

ADC324x 双通道、14 位、25MSPS 至 125MSPS 模数转换器

1 特性

- 双通道
- 14 位分辨率
- 单电源：1.8V
- 串行 LVDS 接口 (SLVDS)
- 支持 1 分频，2 分频和 4 分频的灵活输入时钟缓冲器
- $f_{IN} = 70\text{MHz}$ 时，信噪比 (SNR) = 72.4dBFS，无杂散动态范围 (SFDR) = 87dBc
- 超低功耗：
 - 125MSPS 时为每通道 116mW
- 通道隔离：105dB
- 内部抖动和斩波
- 支持多芯片同步
- 与 12 位版本器件引脚到引脚兼容
- 封装：超薄四方扁平无引线 (VQFN)-48 (7mm x 7mm)

2 应用

- 多载波、多模式蜂窝基站
- 雷达和智能天线阵列
- 炮弹制导
- 电机控制反馈
- 网络和矢量分析器
- 通信测试设备
- 无损检测
- 微波接收器
- 软件定义无线电 (SDR)
- 正交和分集无线电接收器
- 手持式无线电和仪表

3 说明

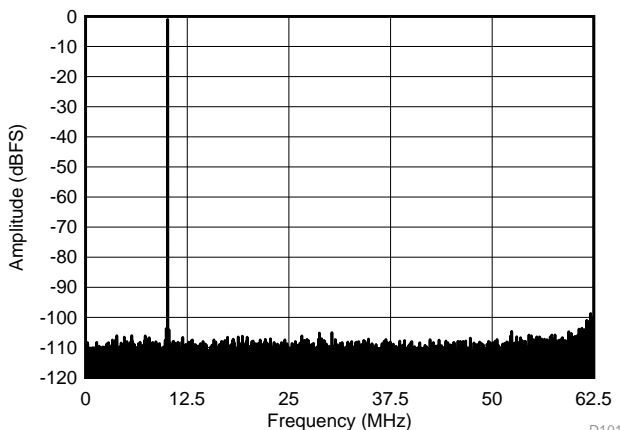
ADC324x 属于高线性度、超低功耗、双通道、14 位、25MSPS 至 125MSPS 模数转换器 (ADC) 系列。此类器件专门设计用于支持具有宽动态范围需求且要求苛刻的高输入频率信号。当 SYSREF 输入实现整个系统同步时，时钟输入分频器将给予系统时钟架构设计更高的灵活性。ADC324x 系列支持串行低压差分信号 (LVDS)，从而减少接口线路的数量，实现高系统集成度。串行 LVDS 接口为双线制，通过两个 LVDS 对串行输出每个 ADC 数据。内部锁相环 (PLL) 会将传入的 ADC 采样时钟加倍，以获得串行输出各通道的 14 位输出数据时所使用的位时钟。除了串行数据流之外，数据帧和位时钟也作为 LVDS 输出进行传送。

器件信息⁽¹⁾

器件型号	封装	封装尺寸 (标称值)
ADC324x	VQFN (48)	7.00mm x 7.00mm

(1) 如需了解所有可用封装，请见数据表末尾的可订购产品附录。

$f_S = 125\text{MSPS}$ 、 $f_{IN} = 10\text{MHz}$ 时的性能



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4 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

Changes from Revision B (March 2015) to Revision C	Page
• Added <i>Digital Inputs</i> section to <i>Digital Characteristics</i> table	17
• Changed <i>Wake-up time</i> parameter maximum specifications in <i>Timing Requirements: General</i> table	17
• Updated Figure 19 , Figure 20 , Figure 23 , Figure 24 , Figure 25 , and Figure 26	22
• Updated Figure 50 , Figure 51 , Figure 54 , Figure 55 , Figure 56 , and Figure 57	28
• Updated Figure 81 , Figure 82 , Figure 85 , Figure 86 , Figure 87 , and Figure 88	34
• Updated Figure 112 , Figure 113 , Figure 116 , Figure 117 , Figure 118 , and Figure 119	40
• Changed Figure 133	45
• Changed <i>SNR and Clock Jitter</i> section: changed typical thermal noise value and changed Figure 141 to reflect updated thermal noise value	49
• Changed Table 3	50
• Changed Figure 142	51
• Added <i>Improving Wake-Up Time From Global Power-Down</i> section	53
• Changed Table 8 : changed <i>FLIP BITS</i> to <i>FLIP WIRE</i> in register 4h, changed bit D7 in row 70A, and added register 13 row	57
• Changed <i>Summary of Special Mode Registers</i> section: changed title, moved section to correct location	58
• Changed register 04h description	59
• Changed register 0Ah and 0Bh descriptions	61
• Added register 13h	63
• Changed register 70Ah to include DIS CLK FILT bit	68

Changes from Revision A (December 2014) to Revision B**Page**

-
- 已将文档状态由“混合状态”更改为“量产数据”：将 ADC3241 和 ADC3242 发布为量产数据；已对产品预览器件进行了更改 1
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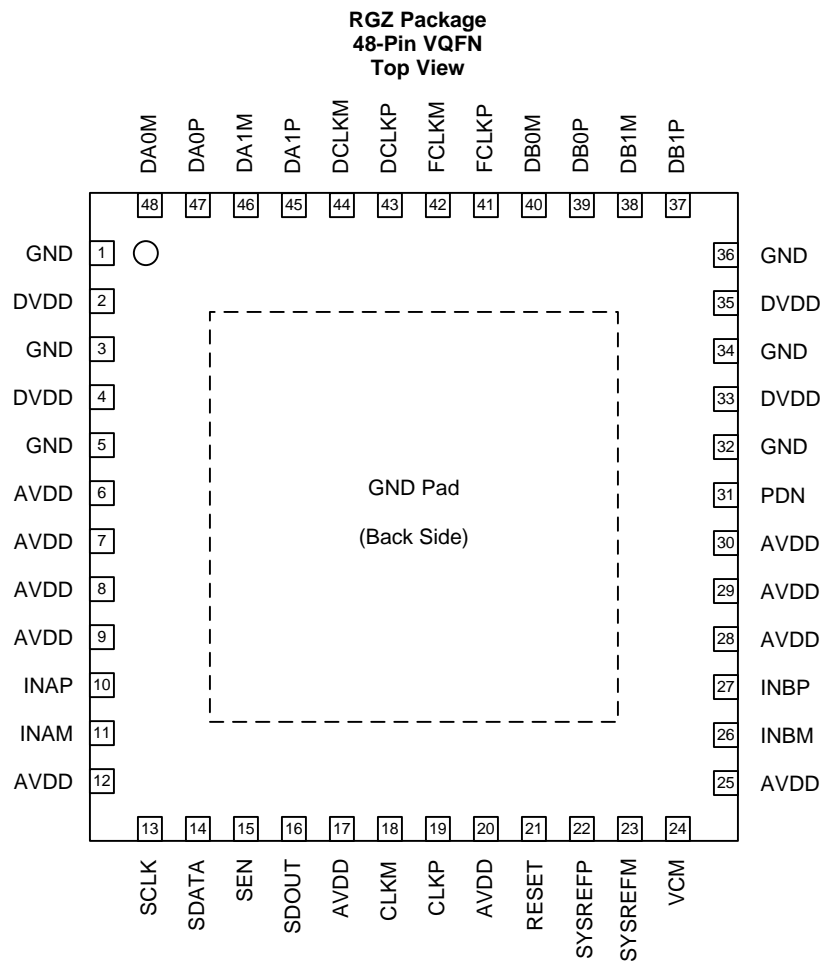
Changes from Original (July 2014) to Revision A**Page**

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- 已将文档状态更改为“混合状态”..... 1
 - 更改了产品预览数据表..... 1
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5 Device Comparison Table

INTERFACE	RESOLUTION (Bits)	25 MSPS	50 MSPS	80 MSPS	125 MSPS	160 MSPS
Serial LVDS	12	ADC3221	ADC3222	ADC3223	ADC3224	—
	14	ADC3241	ADC3242	ADC3243	ADC3244	—
JESD204B	12	—	ADC32J22	ADC32J23	ADC32J24	ADC32J25
	14	—	ADC32J42	ADC32J43	ADC32J44	ADC32J45

6 Pin Configuration and Functions



Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
AVDD	6-9, 12, 17, 20, 25, 28-30	I	Analog 1.8-V power supply
CLKM	18	I	Negative differential clock input for the ADC
CLKP	19	I	Positive differential clock input for the ADC
DA0M	48	O	Negative serial LVDS output for channel A0
DA0P	47	O	Positive serial LVDS output for channel A0
DA1M	46	O	Negative serial LVDS output for channel A1
DA1P	45	O	Positive serial LVDS output for channel A1
DB0M	40	O	Negative serial LVDS output for channel B0
DB0P	39	O	Positive serial LVDS output for channel B0
DB1M	38	O	Negative serial LVDS output for channel B1
DB1P	37	O	Positive serial LVDS output for channel B1
DCLKM	44	O	Negative bit clock output
DCLKP	43	O	Positive bit clock output
DVDD	2, 4, 33, 35	I	Digital 1.8-V power supply
FCLKM	42	O	Negative frame clock output
FCLKP	41	O	Positive frame clock output
GND	1, 3, 5, 32, 34, 36, PowerPAD™	I	Ground, 0 V
INAM	11	I	Negative differential analog input for channel A
INAP	10	I	Positive differential analog input for channel A
INBM	26	I	Negative differential analog input for channel B
INBP	27	I	Positive differential analog input for channel B
PDN	31	I	Power-down control. This pin can be configured via the SPI. This pin has an internal 150-kΩ pull-down resistor.
RESET	21	I	Hardware reset; active high. This pin has an internal 150-kΩ pull-down resistor.
SCLK	13	I	Serial interface clock input. This pin has an internal 150-kΩ pull-down resistor.
SDATA	14	I	Serial interface data input. This pin has an internal 150-kΩ pull-down resistor.
SDOUT	16	O	Serial interface data output
SEN	15	I	Serial interface enable; active low. This pin has an internal 150-kΩ pull-up resistor to AVDD.
SYSREFM	23	I	Negative external SYSREF input
SYSREFP	22	I	Positive external SYSREF input
VCM	24	O	Common-mode voltage for analog inputs

7 Specifications

7.1 Absolute Maximum Ratings

 over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Analog supply voltage range, AVDD		-0.3	2.1	V
Digital supply voltage range, DVDD		-0.3	2.1	V
Voltage applied to input pins	INAP, INBP, INAM, INBM	-0.3	min (1.9, AVDD + 0.3)	V
	CLKP, CLKM	-0.3	AVDD + 0.3	
	SYSREFP, SYSREFM	-0.3	AVDD + 0.3	
	SCLK, SEN, SDATA, RESET, PDN	-0.3	3.9	
Temperature	Operating free-air, T _A	-40	85	°C
	Operating junction, T _J		125	
	Storage, T _{stg}	-65	150	

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
SUPPLIES					
AVDD	Analog supply voltage range	1.7	1.8	1.9	V
DVDD	Digital supply voltage range	1.7	1.8	1.9	V
ANALOG INPUT					
V _{ID}	Differential input voltage	For input frequencies < 450 MHz		2	V _{PP}
		For input frequencies < 600 MHz		1	
V _{IC}	Input common-mode voltage	VCM ± 0.025			V
CLOCK INPUT					
	Input clock frequency	Sampling clock frequency	10	125 ⁽²⁾	MSPS
	Input clock amplitude (differential)	Sine wave, ac-coupled	0.2	1.5	V _{PP}
		LVPECL, ac-coupled		1.6	
		LVDS, ac-coupled		0.7	
	Input clock duty cycle		35%	50%	65%
	Input clock common-mode voltage			0.95	V
DIGITAL OUTPUTS					
C _{LOAD}	Maximum external load capacitance from each output pin to GND			3.3	pF
R _{LOAD}	Differential load resistance placed externally			100	Ω

- (1) After power-up, to reset the device for the first time, only use the RESET pin; see the [Register Initialization](#) section.
 (2) With the clock divider enabled by default for divide-by-1. Maximum sampling clock frequency for the divide-by-4 option is 500 MSPS.

7.4 Thermal Information

THERMAL METRIC ⁽¹⁾		ADC324x	UNIT
		RGZ (VQFN)	
		48 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	25.7	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	18.9	°C/W
R _{θJB}	Junction-to-board thermal resistance	3.0	°C/W
ψ _{JT}	Junction-to-top characterization parameter	0.2	°C/W
ψ _{JB}	Junction-to-board characterization parameter	3	°C/W
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	0.5	°C/W

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).

7.5 Electrical Characteristics: ADC3241, ADC3242

Typical values are over the operating free-air temperature range, at T_A = 25°C, full temperature range is T_{MIN} = –40°C to T_{MAX} = 85°C, maximum sampling rate, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and –1-dBFS differential input, unless otherwise noted.

PARAMETER	ADC3241			ADC3242			UNIT
	MIN	TYP	MAX	MIN	TYP	MAX	
ADC clock frequency			125			125	MSPS
1.8-V analog supply current		31	71		39	81	mA
1.8-V digital supply current		35	65		43	75	mA
Total power dissipation		118	205		147	245	mW
Global power-down dissipation		5	17		5	17	mW
Standby power-down dissipation		78	103		78	103	mW

7.6 Electrical Characteristics: ADC3243, ADC3244

Typical values are over the operating free-air temperature range, at T_A = 25°C, full temperature range is T_{MIN} = –40°C to T_{MAX} = 85°C, maximum sampling rate, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and –1-dBFS differential input, unless otherwise noted.

PARAMETER	ADC3243			ADC3244			UNIT
	MIN	TYP	MAX	MIN	TYP	MAX	
ADC clock frequency			80			125	MSPS
1.8-V analog supply current		50	91		65	106	mA
1.8-V digital supply current		52	85		64	95	mA
Total power dissipation		183	285		233	325	mW
Global power-down dissipation		5	17		5	17	mW
Standby power-down dissipation		72	103		78	103	mW

7.7 Electrical Characteristics: General

Typical values are over the operating free-air temperature range, at $T_A = 25^\circ\text{C}$, full temperature range is $T_{\text{MIN}} = -40^\circ\text{C}$ to $T_{\text{MAX}} = 85^\circ\text{C}$, maximum sampling rate, 50% clock duty cycle, $\text{AVDD} = \text{DVDD} = 1.8\text{ V}$, and -1-dBFS differential input, unless otherwise noted.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
RESOLUTION					
Resolution		14			Bits
ANALOG INPUT					
Differential input full-scale			2.0		V_{PP}
R_{IN} Input resistance	Differential at dc		6.6		$\text{k}\Omega$
C_{IN} Input capacitance	Differential at dc		3.7		pF
$V_{\text{OC(VCM)}}$ VCM common-mode voltage output			0.95		V
VCM output current capability			10		mA
Input common-mode current	Per analog input pin		1.5		$\mu\text{A/MSPS}$
Analog input bandwidth (3 dB)	50- Ω differential source driving 50- Ω termination across INP and INM		540		MHz
DC ACCURACY					
E_{O} Offset error		-25		25	mV
α_{EO} Temperature coefficient of offset error			± 0.024		$^\circ\text{C}$
$E_{\text{G(REF)}}$ Gain error as a result of internal reference inaccuracy alone		-2		2	%FS
$E_{\text{G(CHAN)}}$ Gain error of channel alone			-2		%FS
$\alpha_{\text{(EGCHAN)}}$ Temperature coefficient of $E_{\text{G(CHAN)}}$			± 0.008		$\Delta\%FS/^\circ\text{C}$
CHANNEL-TO-CHANNEL ISOLATION					
Crosstalk ⁽¹⁾	$f_{\text{IN}} = 10\text{ MHz}$		105		dB
	$f_{\text{IN}} = 100\text{ MHz}$		105		
	$f_{\text{IN}} = 200\text{ MHz}$		105		
	$f_{\text{IN}} = 230\text{ MHz}$		105		
	$f_{\text{IN}} = 300\text{ MHz}$		105		

(1) Crosstalk is measured with a -1-dBFS input signal on one channel and no input on the other channel.

7.8 AC Performance: ADC3241

Typical values are over the operating free-air temperature range, at $T_A = 25^\circ\text{C}$, full temperature range is $T_{\text{MIN}} = -40^\circ\text{C}$ to $T_{\text{MAX}} = 85^\circ\text{C}$, ADC sampling rate = 25 MSPS, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and –1-dBFS differential input, unless otherwise noted.

PARAMETER		TEST CONDITIONS	ADC3241 ($f_s = 25$ MSPS)						UNIT
			DITHER ON			DITHER OFF			
			MIN	TYP	MAX	MIN	TYP	MAX	
DYNAMIC AC CHARACTERISTICS									
SNR	Signal-to-noise ratio (from 1-MHz offset)	$f_{\text{IN}} = 10$ MHz	73.3			73.7			dBFS
		$f_{\text{IN}} = 20$ MHz	69.7	73.4		73.7			
		$f_{\text{IN}} = 70$ MHz	72.8			73.2			
		$f_{\text{IN}} = 100$ MHz	72.4			72.8			
		$f_{\text{IN}} = 170$ MHz	71.3			71.6			
		$f_{\text{IN}} = 230$ MHz	70.1			70.4			
	Signal-to-noise ratio (full Nyquist band)	$f_{\text{IN}} = 10$ MHz	72.2			72.6			dBFS
		$f_{\text{IN}} = 20$ MHz	72.3			72.6			
		$f_{\text{IN}} = 70$ MHz	71.8			72.2			
		$f_{\text{IN}} = 100$ MHz	71.5			71.9			
		$f_{\text{IN}} = 170$ MHz	70.5			70.8			
		$f_{\text{IN}} = 230$ MHz	69.3			69.6			
NSD ⁽¹⁾	Noise spectral density (averaged across Nyquist zone)	$f_{\text{IN}} = 10$ MHz	–143.9			–144.3			dBFS/Hz
		$f_{\text{IN}} = 20$ MHz	–144.0	–140.7		–144.3			
		$f_{\text{IN}} = 70$ MHz	–143.4			–143.8			
		$f_{\text{IN}} = 100$ MHz	–143.0			–143.4			
		$f_{\text{IN}} = 170$ MHz	–141.9			–142.2			
		$f_{\text{IN}} = 230$ MHz	–140.7			–141.0			
SINAD ⁽¹⁾	Signal-to-noise and distortion ratio	$f_{\text{IN}} = 10$ MHz	73.3			73.5			dBFS
		$f_{\text{IN}} = 20$ MHz	69.1	73.1		73.5			
		$f_{\text{IN}} = 70$ MHz	72.8			72.9			
		$f_{\text{IN}} = 100$ MHz	72.2			72.4			
		$f_{\text{IN}} = 170$ MHz	71.2			71.2			
		$f_{\text{IN}} = 230$ MHz	69.7			69.7			
ENOB ⁽¹⁾	Effective number of bits	$f_{\text{IN}} = 10$ MHz	11.9			11.9			Bits
		$f_{\text{IN}} = 20$ MHz	11.2	11.8		11.9			
		$f_{\text{IN}} = 70$ MHz	11.8			11.8			
		$f_{\text{IN}} = 100$ MHz	11.7			11.7			
		$f_{\text{IN}} = 170$ MHz	11.5			11.5			
		$f_{\text{IN}} = 230$ MHz	11.3			11.3			
SFDR	Spurious-free dynamic range	$f_{\text{IN}} = 10$ MHz	95			87			dBc
		$f_{\text{IN}} = 20$ MHz	84	94		89			
		$f_{\text{IN}} = 70$ MHz	92			86			
		$f_{\text{IN}} = 100$ MHz	85			81			
		$f_{\text{IN}} = 170$ MHz	86			83			
		$f_{\text{IN}} = 230$ MHz	81			79			

(1) Reported from a 1-MHz offset.

AC Performance: ADC3241 (continued)

Typical values are over the operating free-air temperature range, at $T_A = 25^\circ\text{C}$, full temperature range is $T_{\text{MIN}} = -40^\circ\text{C}$ to $T_{\text{MAX}} = 85^\circ\text{C}$, ADC sampling rate = 25 MSPS, 50% clock duty cycle, $\text{AVDD} = \text{DVDD} = 1.8\text{ V}$, and -1-dBFS differential input, unless otherwise noted.

PARAMETER	TEST CONDITIONS	ADC3241 ($f_S = 25\text{ MSPS}$)						UNIT
		DITHER ON			DITHER OFF			
		MIN	TYP	MAX	MIN	TYP	MAX	
HD2	Second-order harmonic distortion	$f_{\text{IN}} = 10\text{ MHz}$		104			96	dBc
		$f_{\text{IN}} = 20\text{ MHz}$	84	100			95	
		$f_{\text{IN}} = 70\text{ MHz}$		100			95	
		$f_{\text{IN}} = 100\text{ MHz}$		95			93	
		$f_{\text{IN}} = 170\text{ MHz}$		87			87	
		$f_{\text{IN}} = 230\text{ MHz}$		81			81	
HD3	Third-order harmonic distortion	$f_{\text{IN}} = 10\text{ MHz}$		95			88	dBc
		$f_{\text{IN}} = 20\text{ MHz}$	84	94			92	
		$f_{\text{IN}} = 70\text{ MHz}$		92			86	
		$f_{\text{IN}} = 100\text{ MHz}$		85			82	
		$f_{\text{IN}} = 170\text{ MHz}$		87			83	
		$f_{\text{IN}} = 230\text{ MHz}$		82			80	
Non HD2, HD3	Spurious-free dynamic range (excluding HD2, HD3)	$f_{\text{IN}} = 10\text{ MHz}$		100			92	dBc
		$f_{\text{IN}} = 20\text{ MHz}$	87	101			92	
		$f_{\text{IN}} = 70\text{ MHz}$		100			92	
		$f_{\text{IN}} = 100\text{ MHz}$		98			92	
		$f_{\text{IN}} = 170\text{ MHz}$		100			92	
		$f_{\text{IN}} = 230\text{ MHz}$		96			92	
THD	Total harmonic distortion	$f_{\text{IN}} = 10\text{ MHz}$		94			85	dBc
		$f_{\text{IN}} = 20\text{ MHz}$	80.5	92			85	
		$f_{\text{IN}} = 70\text{ MHz}$		91			84	
		$f_{\text{IN}} = 100\text{ MHz}$		86			82	
		$f_{\text{IN}} = 170\text{ MHz}$		84			81	
		$f_{\text{IN}} = 230\text{ MHz}$		78			76	
IMD3	Two-tone, third-order intermodulation distortion	$f_{\text{IN1}} = 45\text{ MHz}$, $f_{\text{IN2}} = 50\text{ MHz}$		-94			-93	dBFS
		$f_{\text{IN1}} = 185\text{ MHz}$, $f_{\text{IN2}} = 190\text{ MHz}$		-92			-90	

7.9 AC Performance: ADC3242

Typical values are over the operating free-air temperature range, at $T_A = 25^\circ\text{C}$, full temperature range is $T_{\text{MIN}} = -40^\circ\text{C}$ to $T_{\text{MAX}} = 85^\circ\text{C}$, ADC sampling rate = 50 MSPS, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and –1-dBFS differential input, unless otherwise noted.

PARAMETER		TEST CONDITIONS	ADC3242 ($f_s = 50$ MSPS)						UNIT
			DITHER ON			DITHER OFF			
			MIN	TYP	MAX	MIN	TYP	MAX	
DYNAMIC AC CHARACTERISTICS									
SNR	Signal-to-noise ratio (from 1-MHz offset)	$f_{\text{IN}} = 10$ MHz	73.3			73.7			dBFS
		$f_{\text{IN}} = 20$ MHz	70.5	73.3		73.8			
		$f_{\text{IN}} = 70$ MHz	73			73.3			
		$f_{\text{IN}} = 100$ MHz	72.6			73.1			
		$f_{\text{IN}} = 170$ MHz	71.7			72.1			
		$f_{\text{IN}} = 230$ MHz	70.9			71.2			
	Signal-to-noise ratio (full Nyquist band)	$f_{\text{IN}} = 10$ MHz	72.5			72.9			
		$f_{\text{IN}} = 20$ MHz	72.6			73.1			
		$f_{\text{IN}} = 70$ MHz	72.3			72.6			
		$f_{\text{IN}} = 100$ MHz	71.9			72.4			
		$f_{\text{IN}} = 170$ MHz	71.1			71.5			
		$f_{\text{IN}} = 230$ MHz	70.3			70.6			
NSD ⁽¹⁾	Noise spectral density (averaged across Nyquist zone)	$f_{\text{IN}} = 10$ MHz	–147.1			–147.5			dBFS/Hz
		$f_{\text{IN}} = 20$ MHz	–147.1	–144.5		–147.6			
		$f_{\text{IN}} = 70$ MHz	–146.8			–147.1			
		$f_{\text{IN}} = 100$ MHz	–146.4			–146.9			
		$f_{\text{IN}} = 170$ MHz	–145.5			–145.9			
		$f_{\text{IN}} = 230$ MHz	–144.7			–145			
SINAD ⁽¹⁾	Signal-to-noise and distortion ratio	$f_{\text{IN}} = 10$ MHz	73.2			73.6			dBFS
		$f_{\text{IN}} = 20$ MHz	69.6	73.4		73.6			
		$f_{\text{IN}} = 70$ MHz	72.9			73.2			
		$f_{\text{IN}} = 100$ MHz	72.5			72.9			
		$f_{\text{IN}} = 170$ MHz	71.5			71.7			
		$f_{\text{IN}} = 230$ MHz	70.5			70.6			
ENOB ⁽¹⁾	Effective number of bits	$f_{\text{IN}} = 10$ MHz	11.9			11.9			Bits
		$f_{\text{IN}} = 20$ MHz	11.3	11.9		11.9			
		$f_{\text{IN}} = 70$ MHz	11.8			11.9			
		$f_{\text{IN}} = 100$ MHz	11.7			11.8			
		$f_{\text{IN}} = 170$ MHz	11.6			11.6			
		$f_{\text{IN}} = 230$ MHz	11.4			11.4			
SFDR	Spurious-free dynamic range	$f_{\text{IN}} = 10$ MHz	89			95			dBc
		$f_{\text{IN}} = 20$ MHz	83	93		91			
		$f_{\text{IN}} = 70$ MHz	94			93			
		$f_{\text{IN}} = 100$ MHz	88			86			
		$f_{\text{IN}} = 170$ MHz	85			82			
		$f_{\text{IN}} = 230$ MHz	82			80			

(1) Reported from a 1-MHz offset.

AC Performance: ADC3242 (continued)

Typical values are over the operating free-air temperature range, at $T_A = 25^\circ\text{C}$, full temperature range is $T_{\text{MIN}} = -40^\circ\text{C}$ to $T_{\text{MAX}} = 85^\circ\text{C}$, ADC sampling rate = 50 MSPS, 50% clock duty cycle, $\text{AVDD} = \text{DVDD} = 1.8\text{ V}$, and -1-dBFS differential input, unless otherwise noted.

PARAMETER	TEST CONDITIONS	ADC3242 ($f_S = 50\text{ MSPS}$)						UNIT
		DITHER ON			DITHER OFF			
		MIN	TYP	MAX	MIN	TYP	MAX	
HD2	Second-order harmonic distortion	$f_{\text{IN}} = 10\text{ MHz}$		103			97	dBc
		$f_{\text{IN}} = 20\text{ MHz}$	83	99			95	
		$f_{\text{IN}} = 70\text{ MHz}$		96			94	
		$f_{\text{IN}} = 100\text{ MHz}$		94			92	
		$f_{\text{IN}} = 170\text{ MHz}$		88			89	
		$f_{\text{IN}} = 230\text{ MHz}$		82			83	
HD3	Third-order harmonic distortion	$f_{\text{IN}} = 10\text{ MHz}$		89			97	dBc
		$f_{\text{IN}} = 20\text{ MHz}$	83	93			95	
		$f_{\text{IN}} = 70\text{ MHz}$		94			93	
		$f_{\text{IN}} = 100\text{ MHz}$		88			86	
		$f_{\text{IN}} = 170\text{ MHz}$		85			82	
		$f_{\text{IN}} = 230\text{ MHz}$		82			80	
Non HD2, HD3	Spurious-free dynamic range (excluding HD2, HD3)	$f_{\text{IN}} = 10\text{ MHz}$		99			96	dBc
		$f_{\text{IN}} = 20\text{ MHz}$	87	101			93	
		$f_{\text{IN}} = 70\text{ MHz}$		100			94	
		$f_{\text{IN}} = 100\text{ MHz}$		99			94	
		$f_{\text{IN}} = 170\text{ MHz}$		99			93	
		$f_{\text{IN}} = 230\text{ MHz}$		97			93	
THD	Total harmonic distortion	$f_{\text{IN}} = 10\text{ MHz}$		88			90	dBc
		$f_{\text{IN}} = 20\text{ MHz}$	79	92			87	
		$f_{\text{IN}} = 70\text{ MHz}$		92			88	
		$f_{\text{IN}} = 100\text{ MHz}$		89			86	
		$f_{\text{IN}} = 170\text{ MHz}$		83			81	
		$f_{\text{IN}} = 230\text{ MHz}$		79			78	
IMD3	Two-tone, third-order intermodulation distortion	$f_{\text{IN1}} = 45\text{ MHz}$, $f_{\text{IN2}} = 50\text{ MHz}$		-95			-95	dBFS
		$f_{\text{IN1}} = 185\text{ MHz}$, $f_{\text{IN2}} = 190\text{ MHz}$		-92			-89	

7.10 AC Performance: ADC3243

Typical values are over the operating free-air temperature range, at $T_A = 25^\circ\text{C}$, full temperature range is $T_{\text{MIN}} = -40^\circ\text{C}$ to $T_{\text{MAX}} = 85^\circ\text{C}$, ADC sampling rate = 80 MSPS, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and –1-dBFS differential input, unless otherwise noted.

PARAMETER		TEST CONDITIONS	ADC3243 ($f_s = 80$ MSPS)						UNIT
			DITHER ON			DITHER OFF			
			MIN	TYP	MAX	MIN	TYP	MAX	
DYNAMIC AC CHARACTERISTICS									
SNR	Signal-to-noise ratio (from 1-MHz offset)	$f_{\text{IN}} = 10$ MHz	73.1			73.5			dBFS
		$f_{\text{IN}} = 70$ MHz	70.7	72.9		73.3			
		$f_{\text{IN}} = 100$ MHz	72.7			73			
		$f_{\text{IN}} = 170$ MHz	72			72.4			
		$f_{\text{IN}} = 230$ MHz	71.4			71.7			
	Signal-to-noise ratio (full Nyquist band)	$f_{\text{IN}} = 10$ MHz	72.4			72.8			
		$f_{\text{IN}} = 70$ MHz	72.3			72.6			
		$f_{\text{IN}} = 100$ MHz	72.1			72.3			
		$f_{\text{IN}} = 170$ MHz	71.4			71.7			
		$f_{\text{IN}} = 230$ MHz	70.9			71.2			
NSD ⁽¹⁾	Noise spectral density (averaged across Nyquist zone)	$f_{\text{IN}} = 10$ MHz	–149.0			–149.4			dBFS/Hz
		$f_{\text{IN}} = 70$ MHz	–148.8	–146.7		–149.2			
		$f_{\text{IN}} = 100$ MHz	–148.6			–148.9			
		$f_{\text{IN}} = 170$ MHz	–147.9			–148.3			
		$f_{\text{IN}} = 230$ MHz	–147.3			–147.6			
SINAD ⁽¹⁾	Signal-to-noise and distortion ratio	$f_{\text{IN}} = 10$ MHz	73.1			73.4			dBFS
		$f_{\text{IN}} = 70$ MHz	69.6	72.9		73.2			
		$f_{\text{IN}} = 100$ MHz	72.7			72.9			
		$f_{\text{IN}} = 170$ MHz	71.9			72.2			
		$f_{\text{IN}} = 230$ MHz	71.2			71.3			
ENOB ⁽¹⁾	Effective number of bits	$f_{\text{IN}} = 10$ MHz	11.8			11.9			Bits
		$f_{\text{IN}} = 70$ MHz	11.3	11.8		11.9			
		$f_{\text{IN}} = 100$ MHz	11.8			11.8			
		$f_{\text{IN}} = 170$ MHz	11.6			11.7			
		$f_{\text{IN}} = 230$ MHz	11.5			11.6			
SFDR	Spurious-free dynamic range	$f_{\text{IN}} = 10$ MHz	89			94			dBc
		$f_{\text{IN}} = 70$ MHz	82	93		93			
		$f_{\text{IN}} = 100$ MHz	93			91			
		$f_{\text{IN}} = 170$ MHz	87			87			
		$f_{\text{IN}} = 230$ MHz	85			83			

(1) Reported from a 1-MHz offset.

AC Performance: ADC3243 (continued)

Typical values are over the operating free-air temperature range, at $T_A = 25^\circ\text{C}$, full temperature range is $T_{\text{MIN}} = -40^\circ\text{C}$ to $T_{\text{MAX}} = 85^\circ\text{C}$, ADC sampling rate = 80 MSPS, 50% clock duty cycle, $\text{AVDD} = \text{DVDD} = 1.8\text{ V}$, and -1-dBFS differential input, unless otherwise noted.

PARAMETER	TEST CONDITIONS	ADC3243 ($f_S = 80\text{ MSPS}$)						UNIT
		DITHER ON			DITHER OFF			
		MIN	TYP	MAX	MIN	TYP	MAX	
HD2	Second-order harmonic distortion	$f_{\text{IN}} = 10\text{ MHz}$		102			98	dBc
		$f_{\text{IN}} = 70\text{ MHz}$	82	95			93	
		$f_{\text{IN}} = 100\text{ MHz}$		95			93	
		$f_{\text{IN}} = 170\text{ MHz}$		87			87	
		$f_{\text{IN}} = 230\text{ MHz}$		85			85	
HD3	Third-order harmonic distortion	$f_{\text{IN}} = 10\text{ MHz}$		89			95	dBc
		$f_{\text{IN}} = 70\text{ MHz}$	83	94			94	
		$f_{\text{IN}} = 100\text{ MHz}$		95			96	
		$f_{\text{IN}} = 170\text{ MHz}$		92			90	
		$f_{\text{IN}} = 230\text{ MHz}$		89			84	
Non HD2, HD3	Spurious-free dynamic range (excluding HD2, HD3)	$f_{\text{IN}} = 10\text{ MHz}$		93			95	dBc
		$f_{\text{IN}} = 70\text{ MHz}$	86	100			95	
		$f_{\text{IN}} = 100\text{ MHz}$		100			95	
		$f_{\text{IN}} = 170\text{ MHz}$		99			95	
		$f_{\text{IN}} = 230\text{ MHz}$		98			94	
THD	Total harmonic distortion	$f_{\text{IN}} = 10\text{ MHz}$		88			91	dBc
		$f_{\text{IN}} = 70\text{ MHz}$	76	91			89	
		$f_{\text{IN}} = 100\text{ MHz}$		91			88	
		$f_{\text{IN}} = 170\text{ MHz}$		85			84	
		$f_{\text{IN}} = 230\text{ MHz}$		83			81	
IMD3	Two-tone, third-order intermodulation distortion	$f_{\text{IN1}} = 45\text{ MHz}$, $f_{\text{IN2}} = 50\text{ MHz}$		-93			-92	dBFS
		$f_{\text{IN1}} = 185\text{ MHz}$, $f_{\text{IN2}} = 190\text{ MHz}$		-91			-89	

7.11 AC Performance: ADC3244

Typical values are over the operating free-air temperature range, at $T_A = 25^\circ\text{C}$, full temperature range is $T_{\text{MIN}} = -40^\circ\text{C}$ to $T_{\text{MAX}} = 85^\circ\text{C}$, ADC sampling rate = 125 MSPS, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and -1-dBFS differential input, unless otherwise noted.

PARAMETER		TEST CONDITIONS	ADC3244 ($f_s = 125 \text{ MSPS}$)						UNIT
			DITHER ON			DITHER OFF			
			MIN	TYP	MAX	MIN	TYP	MAX	
DYNAMIC AC CHARACTERISTICS									
SNR	Signal-to-noise ratio (from 1-MHz offset)	$f_{\text{IN}} = 10 \text{ MHz}$	72.9			73.3			dBFS
		$f_{\text{IN}} = 70 \text{ MHz}$	71	72.6		73			
		$f_{\text{IN}} = 100 \text{ MHz}$	72.4			72.8			
		$f_{\text{IN}} = 170 \text{ MHz}$	71.7			72.2			
		$f_{\text{IN}} = 230 \text{ MHz}$	71			71.6			
	Signal-to-noise ratio (full Nyquist band)	$f_{\text{IN}} = 10 \text{ MHz}$	72.5			72.9			
		$f_{\text{IN}} = 70 \text{ MHz}$	72.2			72.6			
		$f_{\text{IN}} = 100 \text{ MHz}$	72.1			72.5			
		$f_{\text{IN}} = 170 \text{ MHz}$	71.4			71.9			
		$f_{\text{IN}} = 230 \text{ MHz}$	70.7			71.3			
NSD ⁽¹⁾	Noise spectral density (averaged across Nyquist zone)	$f_{\text{IN}} = 10 \text{ MHz}$	-150.8			-151.1			dBFS/Hz
		$f_{\text{IN}} = 70 \text{ MHz}$	-150.5	-148.9		-150.9			
		$f_{\text{IN}} = 100 \text{ MHz}$	-150.3			-150.7			
		$f_{\text{IN}} = 170 \text{ MHz}$	-149.6			-150.1			
		$f_{\text{IN}} = 230 \text{ MHz}$	-148.9			-149.5			
SINAD ⁽¹⁾	Signal-to-noise and distortion ratio	$f_{\text{IN}} = 10 \text{ MHz}$	72.8			73			dBFS
		$f_{\text{IN}} = 70 \text{ MHz}$	69.6	72.6		72.9			
		$f_{\text{IN}} = 100 \text{ MHz}$	72.3			72.5			
		$f_{\text{IN}} = 170 \text{ MHz}$	71.5			71.9			
		$f_{\text{IN}} = 230 \text{ MHz}$	70.7			71.1			
ENOB ⁽¹⁾	Effective number of bits	$f_{\text{IN}} = 10 \text{ MHz}$	11.8			11.8			Bits
		$f_{\text{IN}} = 70 \text{ MHz}$	11.3	11.8		11.8			
		$f_{\text{IN}} = 100 \text{ MHz}$	11.7			11.8			
		$f_{\text{IN}} = 170 \text{ MHz}$	11.6			11.6			
		$f_{\text{IN}} = 230 \text{ MHz}$	11.5			11.5			
SFDR	Spurious-free dynamic range	$f_{\text{IN}} = 10 \text{ MHz}$	93			86			dBc
		$f_{\text{IN}} = 70 \text{ MHz}$	82	94		89			
		$f_{\text{IN}} = 100 \text{ MHz}$	89			85			
		$f_{\text{IN}} = 170 \text{ MHz}$	85			85			
		$f_{\text{IN}} = 230 \text{ MHz}$	83			82			

(1) Reported from a 1-MHz offset.

AC Performance: ADC3244 (continued)

Typical values are over the operating free-air temperature range, at $T_A = 25^\circ\text{C}$, full temperature range is $T_{\text{MIN}} = -40^\circ\text{C}$ to $T_{\text{MAX}} = 85^\circ\text{C}$, ADC sampling rate = 125 MSPS, 50% clock duty cycle, $\text{AVDD} = \text{DVDD} = 1.8\text{ V}$, and -1-dBFS differential input, unless otherwise noted.

PARAMETER	TEST CONDITIONS	ADC3244 ($f_s = 125\text{ MSPS}$)						UNIT
		DITHER ON			DITHER OFF			
		MIN	TYP	MAX	MIN	TYP	MAX	
HD2	Second-order harmonic distortion	$f_{\text{IN}} = 10\text{ MHz}$		95			96	dBc
		$f_{\text{IN}} = 70\text{ MHz}$	82	96			95	
		$f_{\text{IN}} = 100\text{ MHz}$		91			90	
		$f_{\text{IN}} = 170\text{ MHz}$		85			85	
		$f_{\text{IN}} = 230\text{ MHz}$		83			83	
HD3	Third-order harmonic distortion	$f_{\text{IN}} = 10\text{ MHz}$		94			86	dBc
		$f_{\text{IN}} = 70\text{ MHz}$	83	94			89	
		$f_{\text{IN}} = 100\text{ MHz}$		91			85	
		$f_{\text{IN}} = 170\text{ MHz}$		97			89	
		$f_{\text{IN}} = 230\text{ MHz}$		87			85	
Non HD2, HD3	Spurious-free dynamic range (excluding HD2, HD3)	$f_{\text{IN}} = 10\text{ MHz}$		100			95	dBc
		$f_{\text{IN}} = 70\text{ MHz}$	86	99			95	
		$f_{\text{IN}} = 100\text{ MHz}$		99			95	
		$f_{\text{IN}} = 170\text{ MHz}$		100			91	
		$f_{\text{IN}} = 230\text{ MHz}$		96			92	
THD	Total harmonic distortion	$f_{\text{IN}} = 10\text{ MHz}$		91			85	dBc
		$f_{\text{IN}} = 70\text{ MHz}$	76	91			86	
		$f_{\text{IN}} = 100\text{ MHz}$		87			83	
		$f_{\text{IN}} = 170\text{ MHz}$		84			82	
		$f_{\text{IN}} = 230\text{ MHz}$		81			80	
IMD3	Two-tone, third-order intermodulation distortion	$f_{\text{IN1}} = 45\text{ MHz}$, $f_{\text{IN2}} = 50\text{ MHz}$		-97			-95	dBFS
		$f_{\text{IN1}} = 185\text{ MHz}$, $f_{\text{IN2}} = 190\text{ MHz}$		-91			-90	

7.12 Digital Characteristics

The dc specifications refer to the condition where the digital outputs are not switching, but are permanently at a valid logic level 0 or 1. AVDD = DVDD = 1.8 V, and –1-dBFS differential input, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
DIGITAL INPUTS (RESET, SCLK, SDATA, SEN, PDN)						
V _{IH}	High-level input voltage	All digital inputs support 1.8-V and 3.3-V CMOS logic levels	1.3			V
V _{IL}	Low-level input voltage	All digital inputs support 1.8-V and 3.3-V CMOS logic levels			0.4	V
I _{IH}	High-level input current	RESET, SDATA, SCLK, PDN	V _{HIGH} = 1.8 V	10		μA
		SEN ⁽¹⁾	V _{HIGH} = 1.8 V	0		
I _{IL}	Low-level input current	RESET, SDATA, SCLK, PDN	V _{LOW} = 0 V	0		μA
		SEN	V _{LOW} = 0 V	10		
DIGITAL INPUTS (SYSREFF, SYSREFM)						
V _{IH}	High-level input voltage			1.3		V
V _{IL}	Low-level input voltage			0.5		V
	Common-mode voltage for SYSREF			0.9		V
DIGITAL OUTPUTS, CMOS INTERFACE (SDOUT)						
V _{OH}	High-level output voltage		DVDD – 0.1	DVDD		V
V _{OL}	Low-level output voltage			0	0.1	V
DIGITAL OUTPUTS, LVDS INTERFACE						
V _{ODH}	High-level output differential voltage	With an external 100-Ω termination	280	410	460	mV
V _{ODL}	Low-level output differential voltage	With an external 100-Ω termination	–460	–410	–280	mV
V _{OCM}	Output common-mode voltage			1.05		V

- (1) SEN has an internal 150-kΩ pull-up resistor to AVDD. Because the pull-up resistor is weak, SEN can also be driven by 1.8-V or 3.3-V CMOS buffers.

7.13 Timing Requirements: General

Typical values are at T_A = 25°C, AVDD = DVDD = 1.8 V, and –1-dBFS differential input, unless otherwise noted. Minimum and maximum values are across the full temperature range: T_{MIN} = –40°C to T_{MAX} = 85°C.

			MIN	TYP	MAX	UNIT
t _A	Aperture delay		1.24	1.44	1.64	ns
		Aperture delay matching between two channels of the same device		±70		ps
		Variation of aperture delay between two devices at the same temperature and supply voltage		±150		ps
t _J	Aperture jitter		130		f _S rms	
Wake-up time	Time to valid data after exiting standby power-down mode			35	65	μs
	Time to valid data after exiting global power-down mode (in this mode, both channels power down)			85	140	
ADC latency ⁽¹⁾	2-wire mode (default)			9		Clock cycles
	1-wire mode			8		
t _{SU_SYSREF}	SYSREF reference time	Setup time for SYSREF referenced to input clock rising edge	1000			ps
t _{H_SYSREF}		Hold time for SYSREF referenced to input clock rising edge	100			

- (1) Overall latency = ADC latency + t_{PD}.

7.14 Timing Requirements: LVDS Output

Typical values are at 25°C, AVDD = DVDD = 1.8 V, and –1-dBFS differential input, 7x serialization, C_{LOAD} = 3.3 pF⁽¹⁾, and R_{LOAD} = 100 Ω⁽²⁾, unless otherwise noted. Minimum and maximum values are across the full temperature range: T_{MIN} = –40°C to T_{MAX} = 85°C.⁽³⁾⁽⁴⁾

		MIN	TYP	MAX	UNIT	
t _{SU}	Data setup time: data valid to zero-crossing of differential output clock (CLKOUTP – CLKOUTM) ⁽⁵⁾	0.36	0.42		ns	
t _{HO}	Data hold time: zero-crossing of differential output clock (CLKOUTP – CLKOUTM) to data becoming invalid ⁽⁵⁾	0.36	0.47		ns	
	LVDS bit clock duty cycle: duty cycle of differential clock (CLKOUTP – CLKOUTM)	49%				
t _{PDI}	Clock propagation delay: input clock falling edge cross-over to frame clock rising edge cross-over 10 MSPS < sampling frequency < 125 MSPS	1-wire mode	2.7	4.5	6.5	ns
		2-wire mode	0.44 × t _S + t _{DELAY}			
t _{DELAY}	Delay time	3	4.5	5.9	ns	
t _{FALL} , t _{RISE}	Data fall time, data rise time: rise time measured from –100 mV to 100 mV, 10 MSPS ≤ Sampling frequency ≤ 125 MSPS	0.11			ns	
t _{CLKRISE} , t _{CLKFALL}	Output clock rise time, output clock fall time: rise time measured from –100 mV to 100 mV, 10 MSPS ≤ Sampling frequency ≤ 125 MSPS	0.11			ns	

- (1) C_{LOAD} is the effective external single-ended load capacitance between each output pin and ground
- (2) R_{LOAD} is the differential load resistance between the LVDS output pair.
- (3) Measurements are done with a transmission line of a 100-Ω characteristic impedance between the device and load. Setup and hold time specifications take into account the effect of jitter on the output data and clock.
- (4) Timing parameters are ensured by design and characterization and are not tested in production.
- (5) Data valid refers to a logic high of +100 mV and a logic low of –100 mV.

Table 1. LVDS Timings at Lower Sampling Frequencies: 7x Serialization (2-Wire Mode)

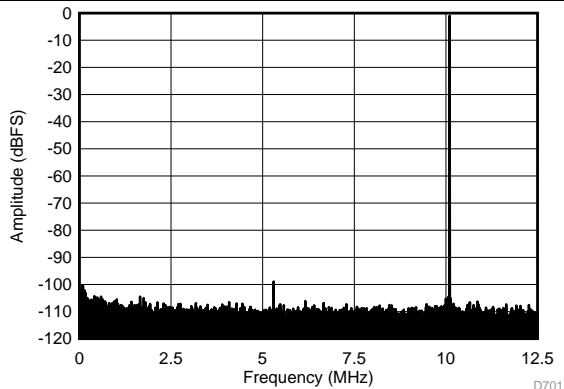
SAMPLING FREQUENCY (MSPS)	SETUP TIME (t _{SU} , ns)			HOLD TIME (t _{HO} , ns)		
	MIN	TYP	MAX	MIN	TYP	MAX
25	2.27	2.6		2.41	2.6	
40	1.44	1.6		1.51	1.7	
50	1.2	1.32		1.24	1.4	
60	0.95	1.04		0.97	1.09	
80	0.68	0.75		0.72	0.81	
100	0.5	0.57		0.53	0.62	

Table 2. LVDS Timings at Lower Sampling Frequencies: 14x Serialization (1-Wire Mode)

SAMPLING FREQUENCY (MSPS)	SETUP TIME (t _{SU} , ns)			HOLD TIME (t _{HO} , ns)		
	MIN	TYP	MAX	MIN	TYP	MAX
25	1.1	1.24		1.19	1.34	
40	0.66	0.72		0.74	0.82	
50	0.48	0.55		0.54	0.64	
60	0.35	0.41		0.42	0.51	
80	0.17	0.24		0.3	0.38	

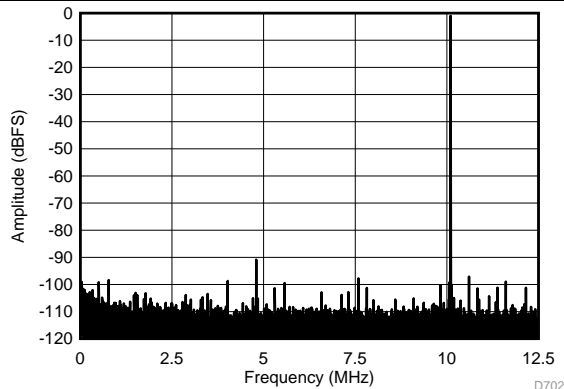
7.15 Typical Characteristics: ADC3241

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 25 MSPS, 50% clock duty cycle, $AVDD = 1.8\text{ V}$, $DVDD = 1.8\text{ V}$, -1-dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.



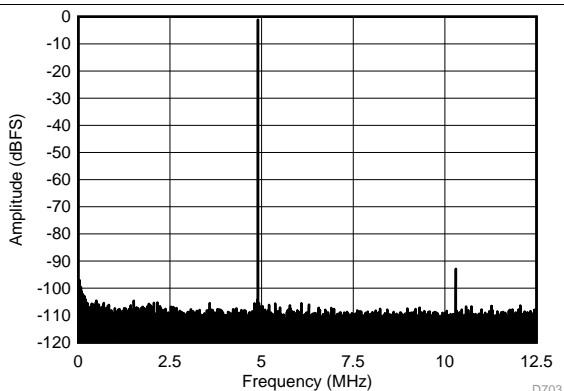
SFDR = 97.9 dBc, SNR = 73.8 dBFS, SINAD = 73.8 dBFS, THD = 96.8 dBc, HD2 = -110.0 dBc, HD3 = -97.9 dBc

Figure 1. FFT for 10-MHz Input Signal (Dither On)



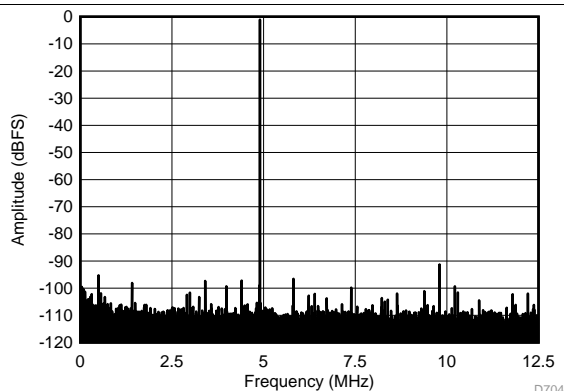
SFDR = 89.8 dBc, SNR = 74.5 dBFS, SINAD = 74.3 dBFS, THD = 88.3 dBc, HD2 = -89.8 dBc, HD3 = -100.3 dBc

Figure 2. FFT for 10-MHz Input Signal (Dither Off)



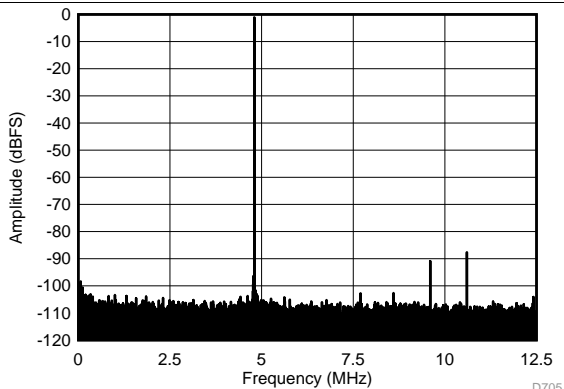
SFDR = 91.8 dBc, SNR = 73.4 dBFS, SINAD = 73.4 dBFS, THD = 91.4 dBc, HD2 = -108.2 dBc, HD3 = -91.8 dBc

Figure 3. FFT for 70-MHz Input Signal (Dither On)



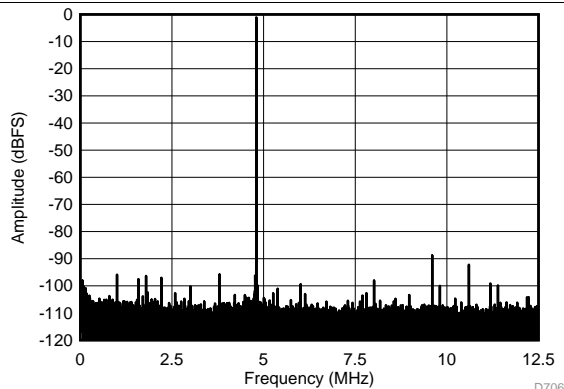
SFDR = 90.2 dBc, SNR = 74.1 dBFS, SINAD = 73.9 dBFS, THD = 88.7 dBc, HD2 = -90.2 dBc, HD3 = -100.5 dBc

Figure 4. FFT for 70-MHz Input Signal (Dither Off)



SFDR = 86.6 dBc, SNR = 72.1 dBFS, SINAD = 71.9 dBFS, THD = 84.7 dBc, HD2 = -89.8 dBc, HD3 = -86.6 dBc

Figure 5. FFT for 170-MHz Input Signal (Dither On)

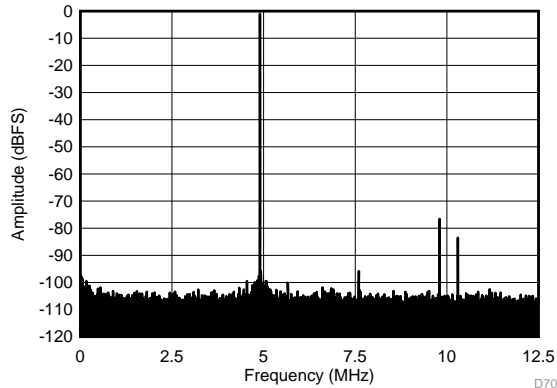


SFDR = 87.7 dBc, SNR = 72.5 dBFS, SINAD = 72.3 dBFS, THD = 85 dBc, HD2 = -87.7 dBc, HD3 = -91.2 dBc

Figure 6. FFT for 170-MHz Input Signal (Dither Off)

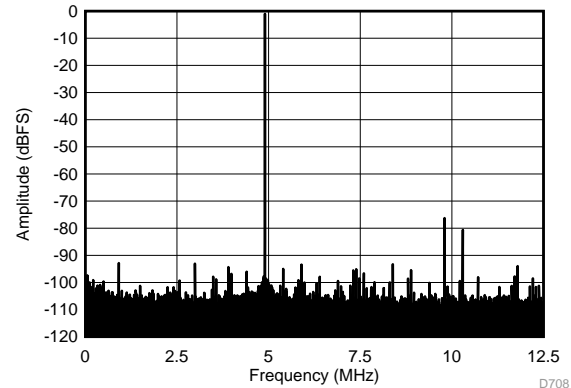
Typical Characteristics: ADC3241 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 25 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, $2-V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.



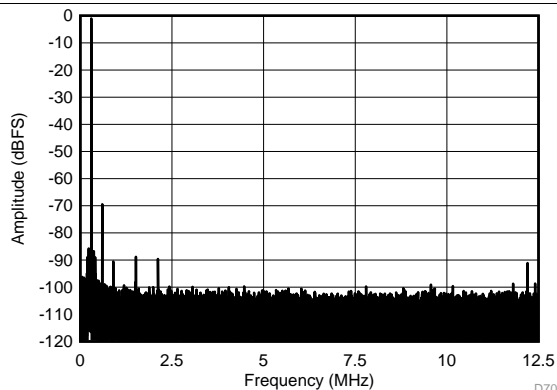
SFDR = 75.6 dBc, SNR = 69.8 dBFS, SINAD = 68.8 dBFS, THD = 74.8 dBc, HD2 = -75.6 dBc, HD3 = -82.5 dBc

Figure 7. FFT for 270-MHz Input Signal (Dither On)



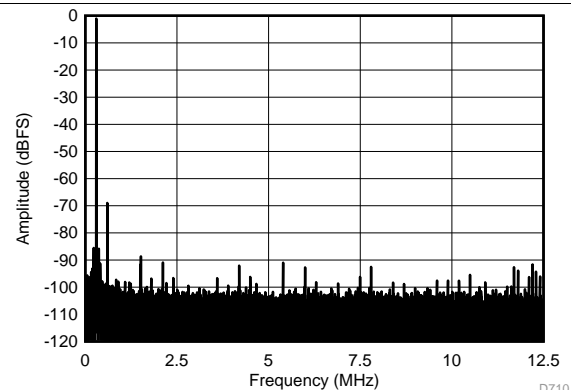
SFDR = 75.3 dBc, SNR = 70.0 dBFS, SINAD = 68.8 dBFS, THD = 73.8 dBc, HD2 = -75.3 dBc, HD3 = -79.6 dBc

Figure 8. FFT for 270-MHz Input Signal (Dither Off)



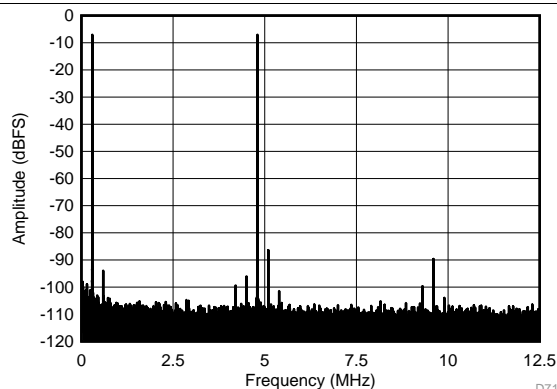
SFDR = 68.4 dBc, SNR = 67.2 dBFS, SINAD = 67.2 dBFS, THD = 92.6 dBc, HD2 = -68.4 dBc, HD3 = -89.5 dBc

Figure 9. FFT for 450-MHz Input Signal (Dither On)



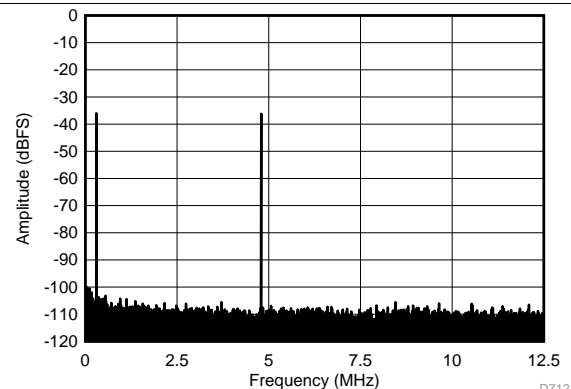
SFDR = 67.9 dBc, SNR = 67.2 dBFS, SINAD = 67.2 dBFS, THD = 87.6 dBc, HD2 = -67.9 dBc, HD3 = -96.9 dBc

Figure 10. FFT for 450-MHz Input Signal (Dither Off)



$f_{IN1} = 46 \text{ MHz}$, $f_{IN2} = 50 \text{ MHz}$, IMD3 = 82.4 dBFS, each tone at -7 dBFS

Figure 11. FFT for Two-Tone Input Signal (-7 dBFS at 46 MHz and 50 MHz)

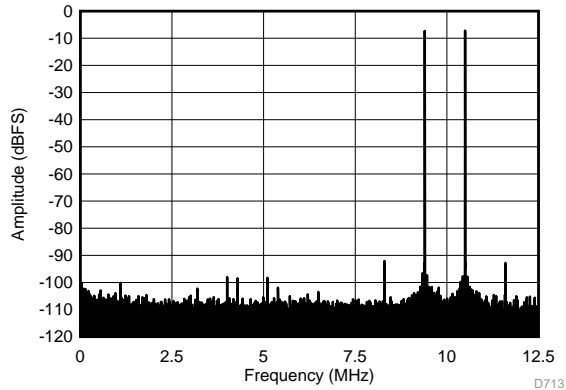


$f_{IN1} = 46 \text{ MHz}$, $f_{IN2} = 50 \text{ MHz}$, IMD3 = 90 dBFS, each tone at -36 dBFS

Figure 12. FFT for Two-Tone Input Signal (-36 dBFS at 46 MHz and 50 MHz)

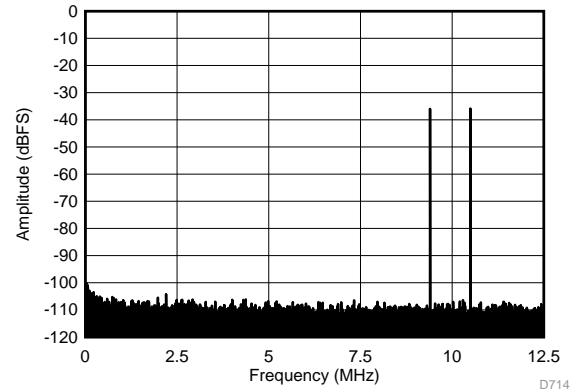
Typical Characteristics: ADC3241 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 25 MSPS, 50% clock duty cycle, $AV_{DD} = 1.8\text{ V}$, $DV_{DD} = 1.8\text{ V}$, -1 dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.



$f_{IN1} = 185\text{ MHz}$, $f_{IN2} = 190\text{ MHz}$, $\text{IMD3} = 78\text{ dBFS}$, each tone at -7 dBFS

Figure 13. FFT for Two-Tone Input Signal (-7 dBFS at 185 MHz and 190 MHz)



$f_{IN1} = 185\text{ MHz}$, $f_{IN2} = 190\text{ MHz}$, $\text{IMD3} = 89\text{ dBFS}$, each tone at -36 dBFS

Figure 14. FFT for Two-Tone Input Signal (-36 dBFS at 185 MHz and 190 MHz)

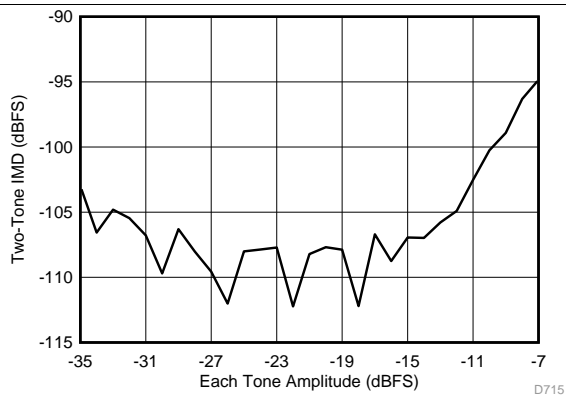


Figure 15. Intermodulation Distortion vs Input Amplitude (46 MHz and 50 MHz)

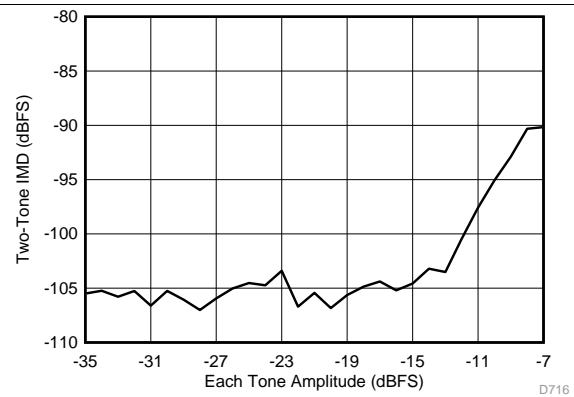


Figure 16. Intermodulation Distortion vs Input Amplitude (185 MHz and 190 MHz)

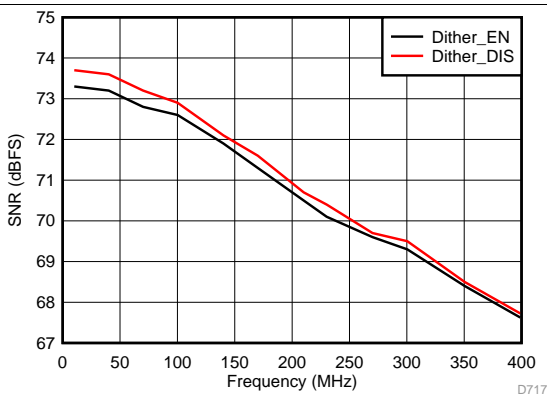


Figure 17. Signal-to-Noise Ratio vs Input Frequency

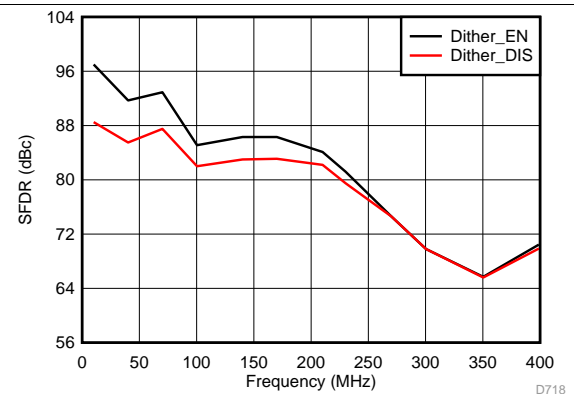


Figure 18. Spurious-Free Dynamic Range vs Input Frequency

Typical Characteristics: ADC3241 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 25 MSPS, 50% clock duty cycle, $AV_{DD} = 1.8\text{ V}$, $DV_{DD} = 1.8\text{ V}$, -1 dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.

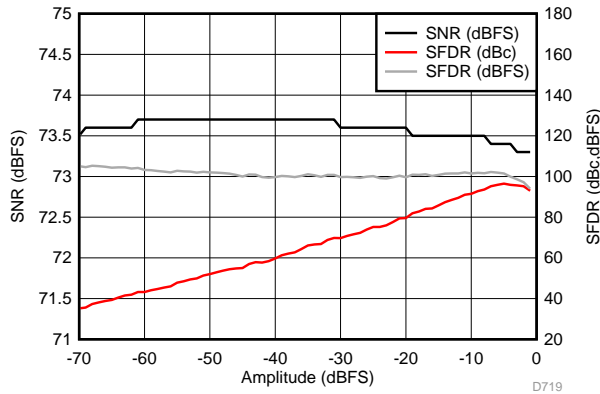


Figure 19. Performance vs Input Amplitude (30 MHz)

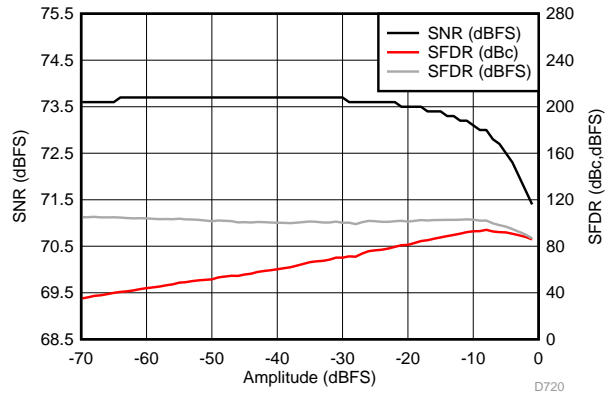


Figure 20. Performance vs Input Amplitude (170 MHz)

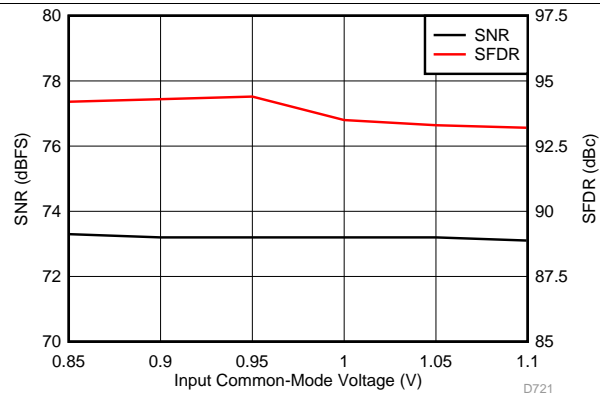


Figure 21. Performance vs Input Common-Mode Voltage (30 MHz)

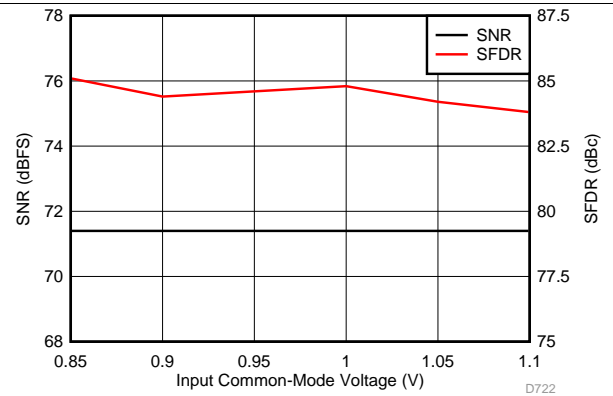


Figure 22. Performance vs Input Common-Mode Voltage (170 MHz)

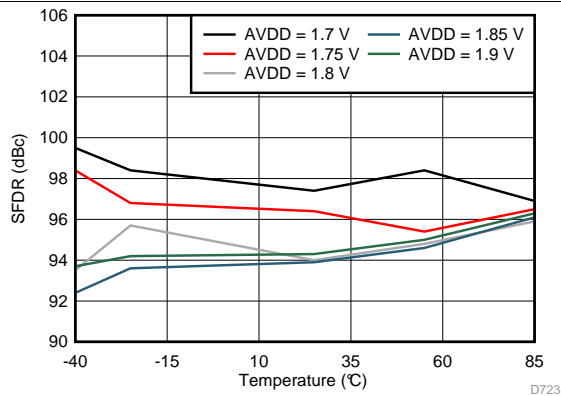


Figure 23. Spurious-Free Dynamic Range vs AVDD Supply and Temperature (30 MHz)

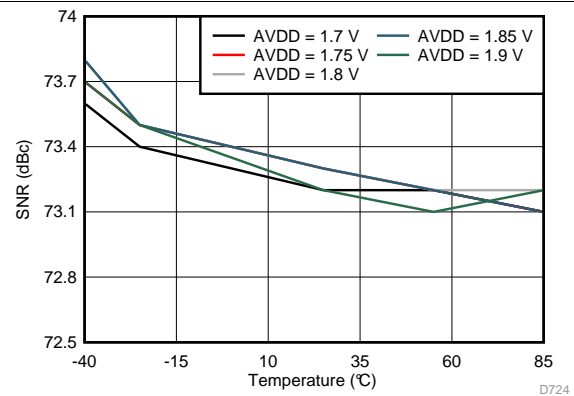


Figure 24. Signal-to-Noise Ratio vs AVDD Supply and Temperature (30 MHz)

Typical Characteristics: ADC3241 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 25 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, $2\cdot V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_S / 2$ when chopper is enabled, unless otherwise noted.

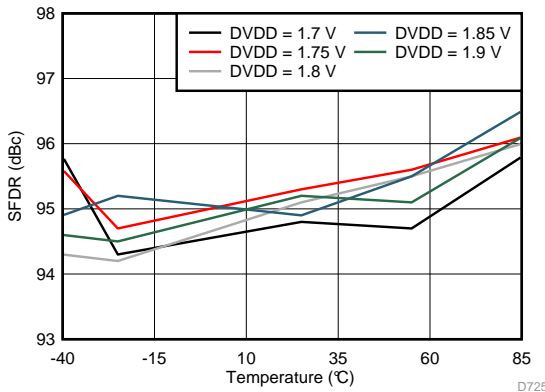


Figure 25. Spurious-Free Dynamic Range vs DVDD Supply and Temperature (30 MHz)

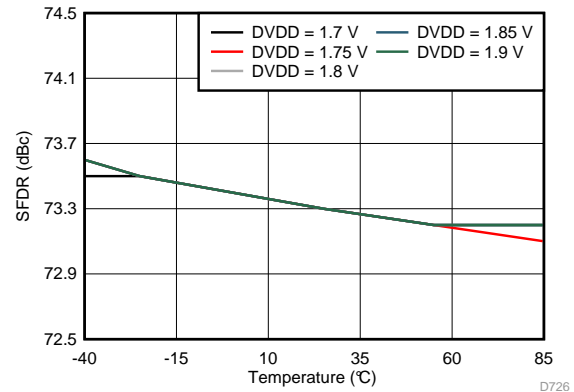


Figure 26. Signal-to-Noise Ratio vs DVDD Supply and Temperature (30 MHz)

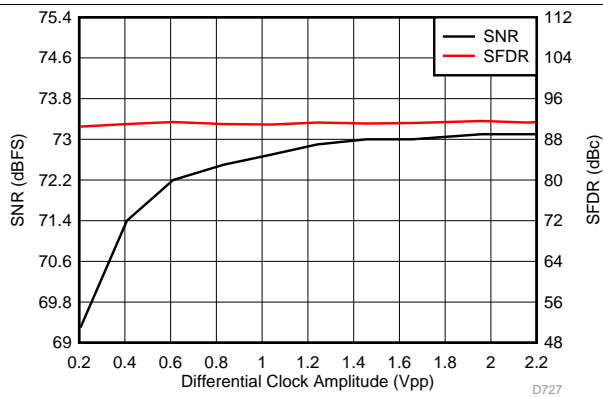


Figure 27. Performance vs Clock Amplitude (40 MHz)

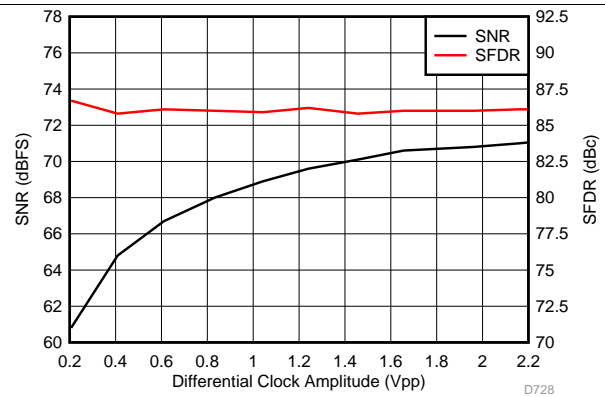


Figure 28. Performance vs Clock Amplitude (150 MHz)

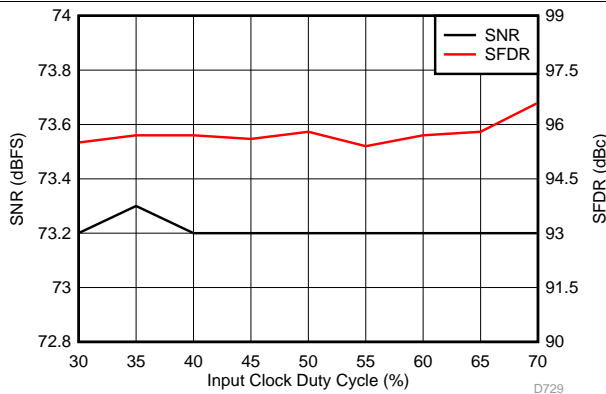


Figure 29. Performance vs Clock Duty Cycle (30 MHz)

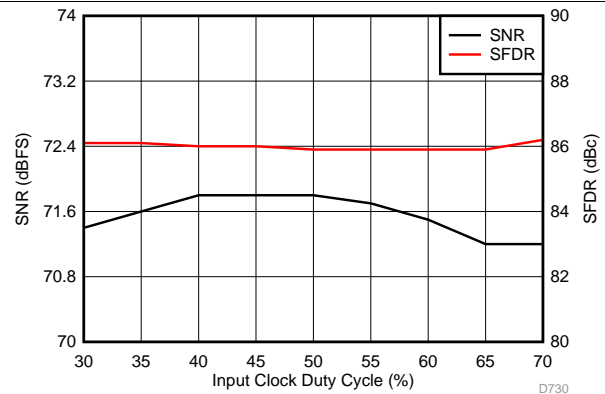


Figure 30. Performance vs Clock Duty Cycle (150 MHz)

Typical Characteristics: ADC3241 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 25 MSPS, 50% clock duty cycle, $AVDD = 1.8\text{ V}$, $DVDD = 1.8\text{ V}$, -1 dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_S / 2$ when chopper is enabled, unless otherwise noted.

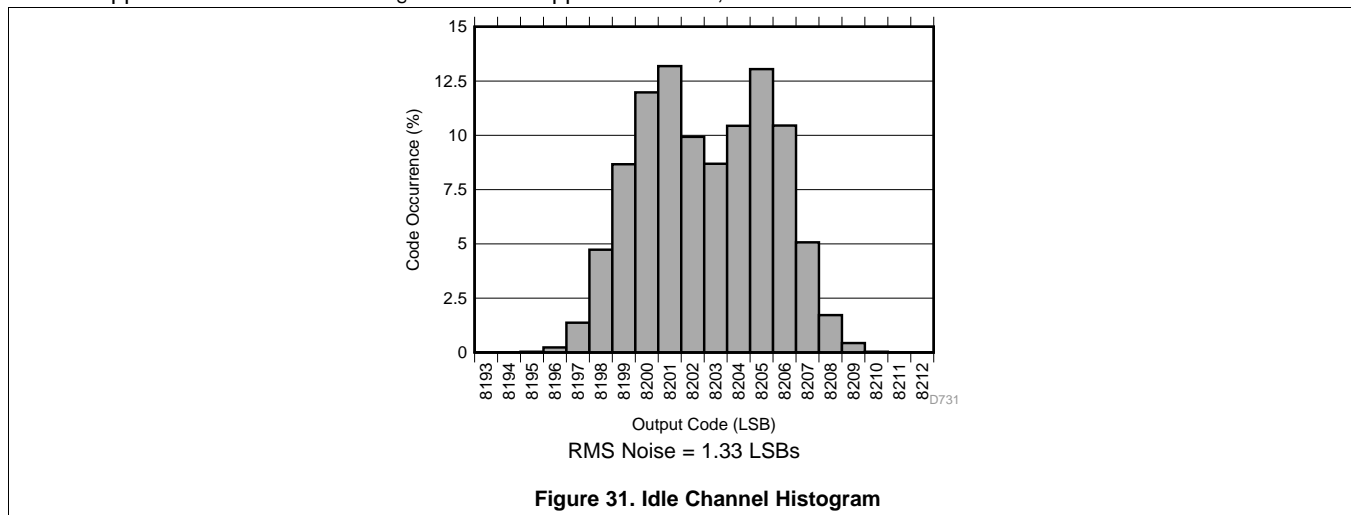
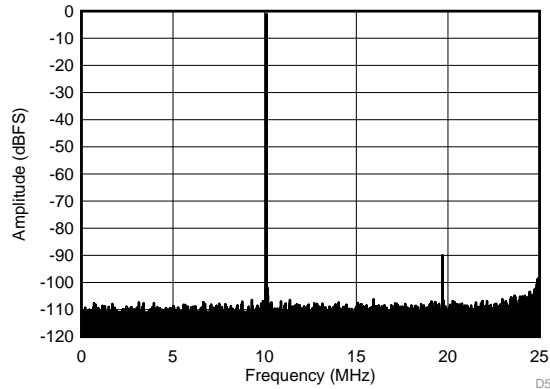


Figure 31. Idle Channel Histogram

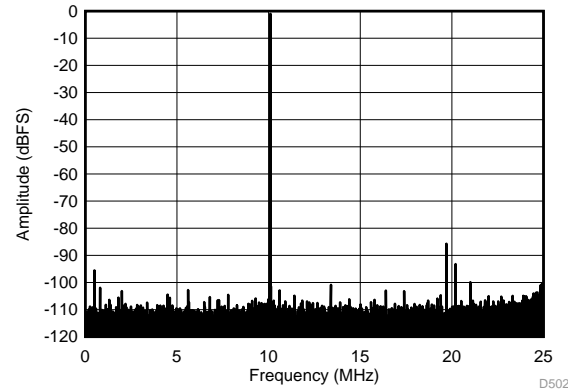
7.16 Typical Characteristics: ADC3242

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 50 MSPS, 50% clock duty cycle, $AVDD = 1.8\text{ V}$, $DVDD = 1.8\text{ V}$, -1-dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.



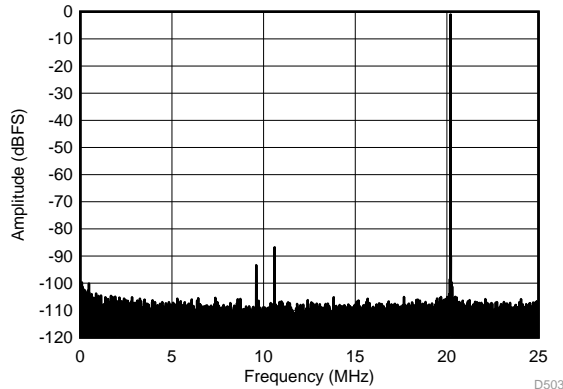
SFDR = 88.9 dBc, SFDR = 99.8 dBc (non 23), SNR = 73.6 dBFS, SINAD = 73.5 dBFS, THD = 88.8 dBc, HD2 = -111.4 dBc, HD3 = -88.9 dBc

Figure 32. FFT for 10-MHz Input Signal (Dither On)



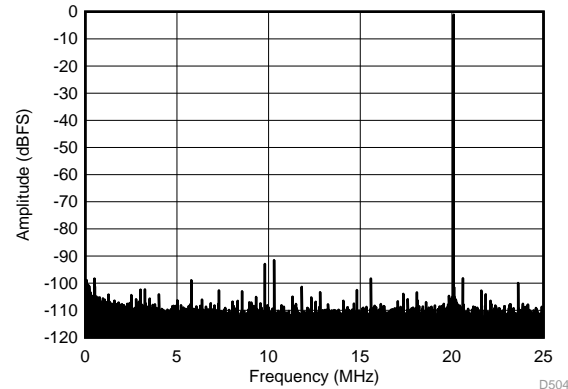
SFDR = 84.7 dBc, SFDR = 96.1 dBc (non 23), SNR = 74.1 dBFS, SINAD = 73.8 dBFS, THD = 83.5 dBc, HD2 = -92.2 dBc, HD3 = -84.7 dBc

Figure 33. FFT for 10-MHz Input Signal (Dither Off)



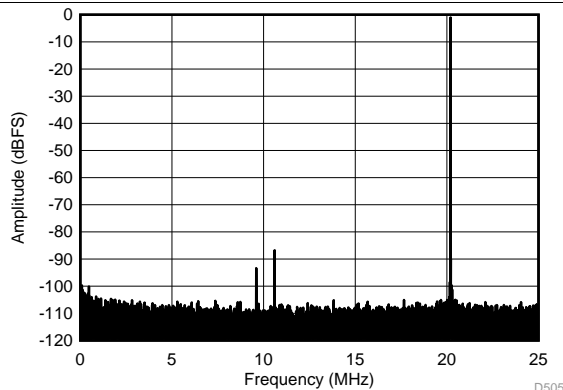
SFDR = 85.8 dBc, SFDR = 100.3 dBc (non 23), SNR = 72.4 dBFS, SINAD = 72.2 dBFS, THD = 84.8 dBc, HD2 = -92.3 dBc, HD3 = -85.8 dBc

Figure 34. FFT for 70-MHz Input Signal (Dither On)



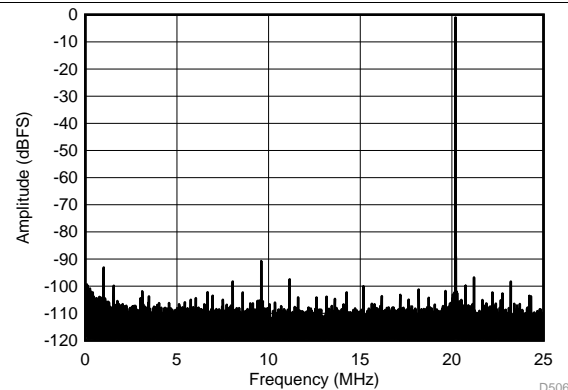
SFDR = 90.4 dBc, SFDR = 94.7 dBc (non 23), SNR = 73.9 dBFS, SINAD = 73.7 dBFS, THD = 87.5 dBc, HD2 = -91.9 dBc, HD3 = -90.4 dBc

Figure 35. FFT for 70-MHz Input Signal (Dither Off)



SFDR = 85.8 dBc, SFDR = 99.1 dBc (non 23), SNR = 72.4 dBFS, SINAD = 72.2 dBFS, THD = 84.8 dBc, HD2 = -92.3 dBc, HD3 = -85.8 dBc

Figure 36. FFT for 170-MHz Input Signal (Dither On)

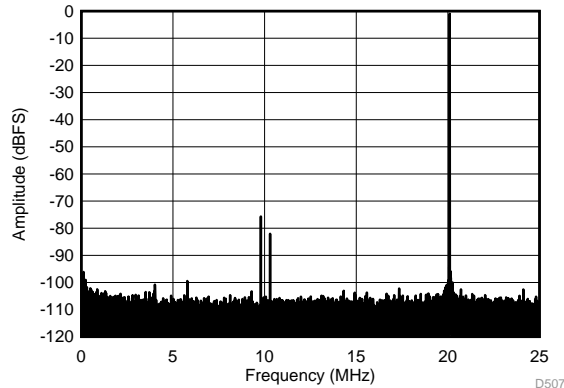


SFDR = 89.7 dBc, SFDR = 93 dBc (non 23), SNR = 72.9 dBFS, SINAD = 72.8 dBFS, THD = 86.6 dBc, HD2 = -89.7 dBc, HD3 = -107.7 dBc

Figure 37. FFT for 170-MHz Input Signal (Dither Off)

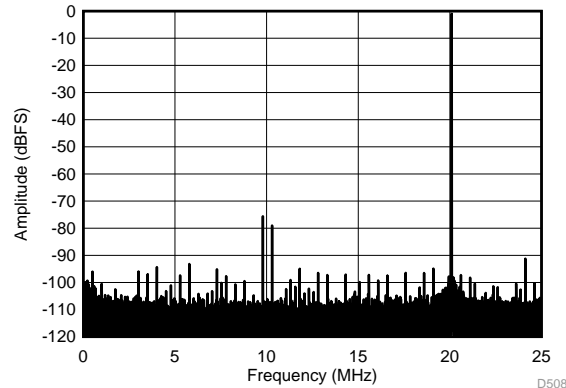
Typical Characteristics: ADC3242 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 50 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, $2\cdot V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.



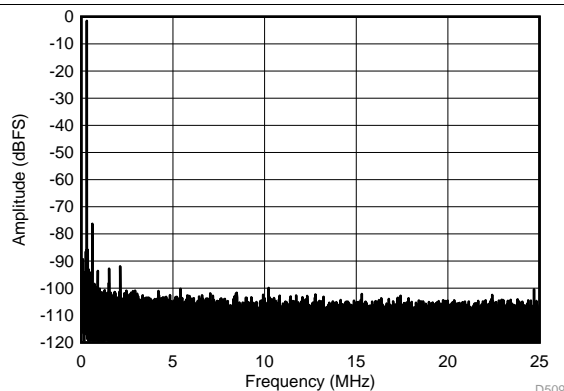
SFDR = 74.7 dBc, SFDR = 95.2 dBc (non 23), SNR = 70.7 dBFS, SINAD = 69.3 dBFS, THD = 73.8 dBc, HD2 = -74.7 dBc, HD3 = -81.1 dBc

Figure 38. FFT for 270-MHz Input Signal (Dither On)



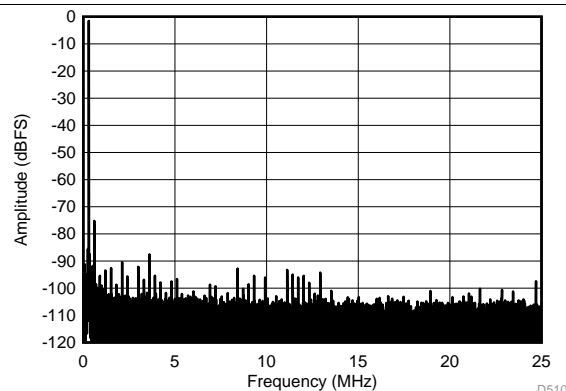
SFDR = 74.6 dBc, SFDR = 91.1 dBc (non 23), SNR = 70.9 dBFS, SINAD = 69.2 dBFS, THD = 72.9 dBc, HD2 = -74.6 dBc, HD3 = -78.0 dBc

Figure 39. FFT for 270-MHz Input Signal (Dither Off)



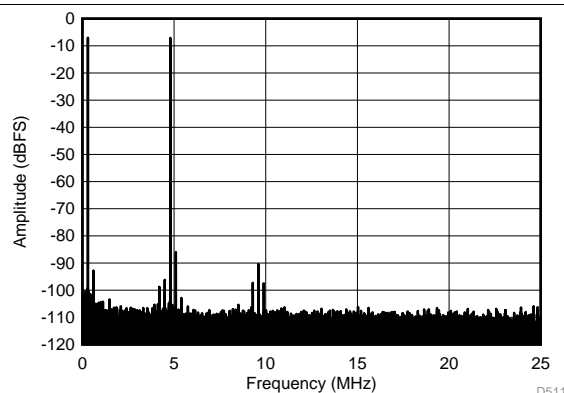
SFDR = 68.2 dBc, SNR = 69.0 dBFS, SINAD = 69.0 dBFS, THD = -85.7 dBc, HD2 = -68.2 dBc, HD3 = -86.5 dBc

Figure 40. FFT for 450-MHz Input Signal (Dither On)



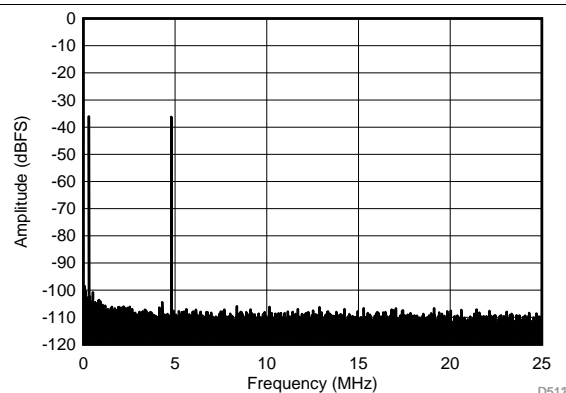
SFDR = 68.2 dBc, SNR = 69.2 dBFS, SINAD = 69.2 dBFS, THD = -86.4 dBc, HD2 = 68.2 dBc, HD3 = -90.3 dBc

Figure 41. FFT for 450-MHz Input Signal (Dither Off)



$f_{IN1} = 46\text{ MHz}$, $f_{IN2} = 50\text{ MHz}$, IMD3 = 87 dBFS, each tone at -7 dBFS

Figure 42. FFT for Two-Tone Input Signal (-7 dBFS at 46 MHz and 50 MHz)



$f_{IN1} = 46\text{ MHz}$, $f_{IN2} = 50\text{ MHz}$, IMD3 = 88 dBFS, each tone at -36 dBFS

Figure 43. FFT for Two-Tone Input Signal (-36 dBFS at 46 MHz and 50 MHz)

Typical Characteristics: ADC3242 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 50 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, $2 \cdot V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.

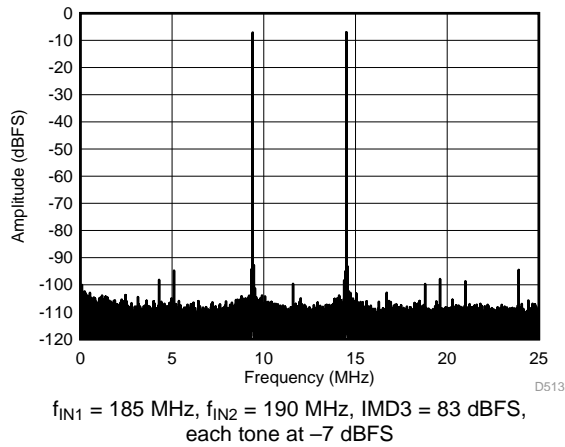


Figure 44. FFT for Two-Tone Input Signal (-7 dBFS at 185 MHz and 190 MHz)

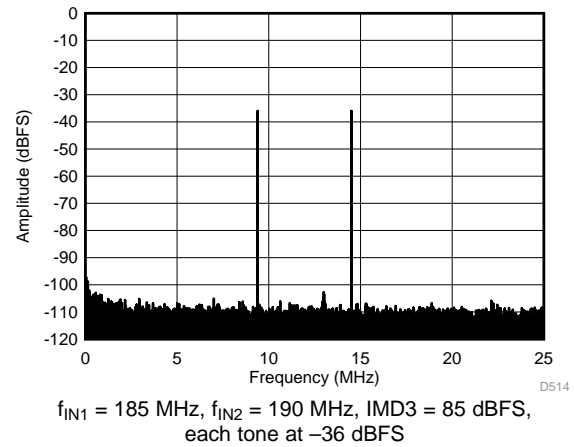


Figure 45. FFT for Two-Tone Input Signal (-36 dBFS at 185 MHz and 190 MHz)

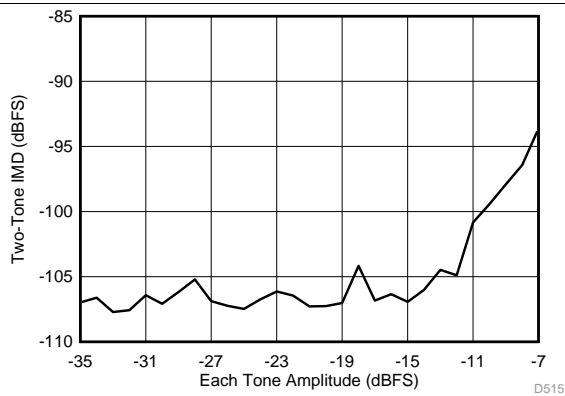


Figure 46. Intermodulation Distortion vs Input Amplitude (46 MHz and 50 MHz)

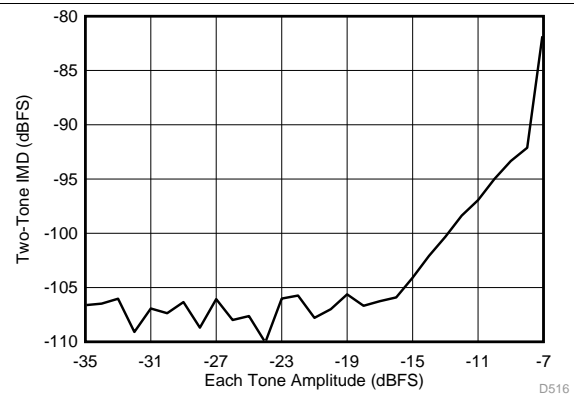


Figure 47. Intermodulation Distortion vs Input Amplitude (185 MHz and 190 MHz)

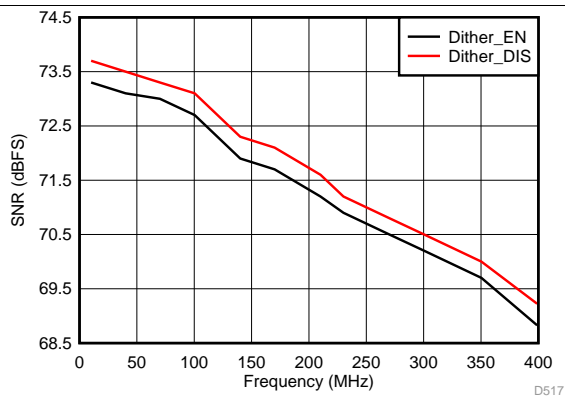


Figure 48. Signal-to-Noise Ratio vs Input Frequency

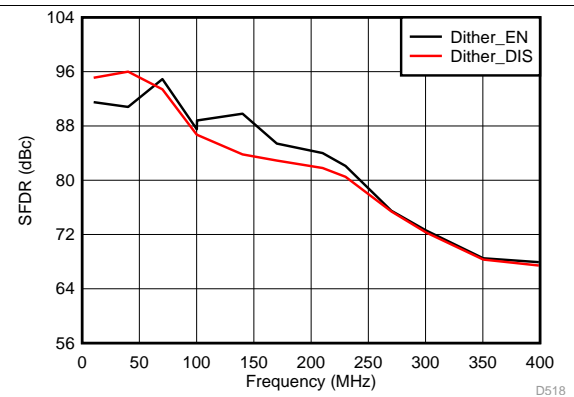


Figure 49. Spurious-Free Dynamic Range vs Input Frequency

Typical Characteristics: ADC3242 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 50 MSPS, 50% clock duty cycle, $AVDD = 1.8\text{ V}$, $DVDD = 1.8\text{ V}$, -1 dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.

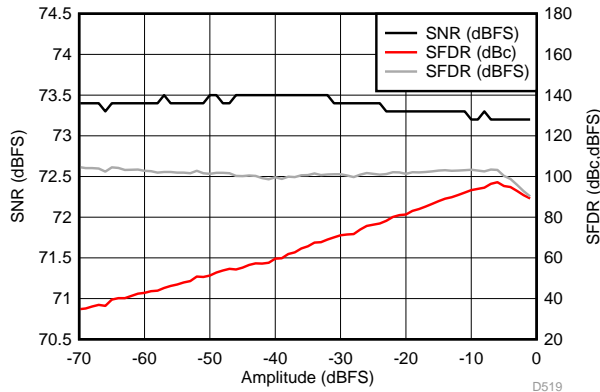


Figure 50. Performance vs Input Amplitude (30 MHz)

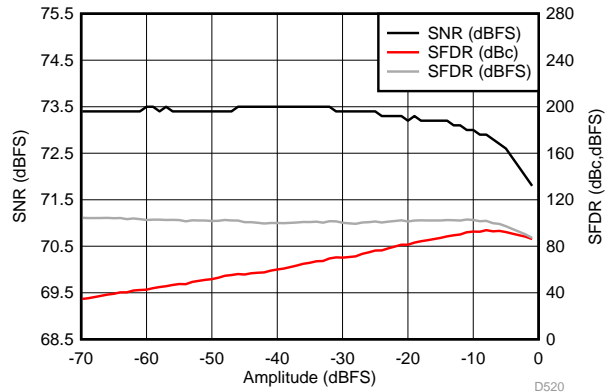


Figure 51. Performance vs Input Amplitude (170 MHz)

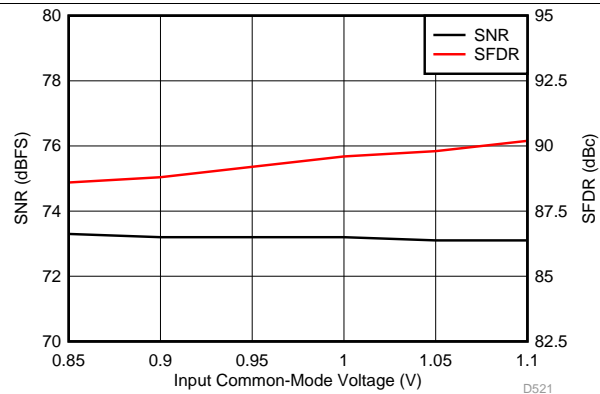


Figure 52. Performance vs Input Common-Mode Voltage (30 MHz)

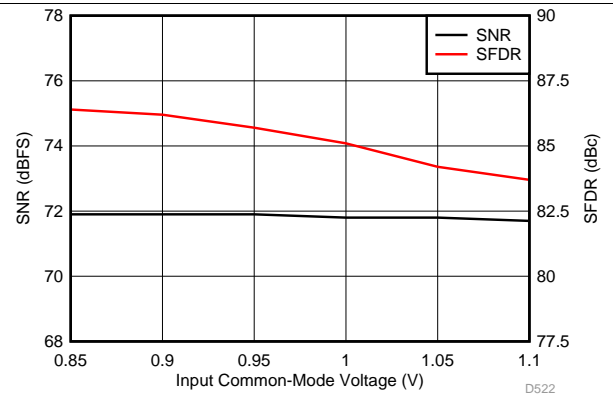


Figure 53. Performance vs Input Common-Mode Voltage (170 MHz)

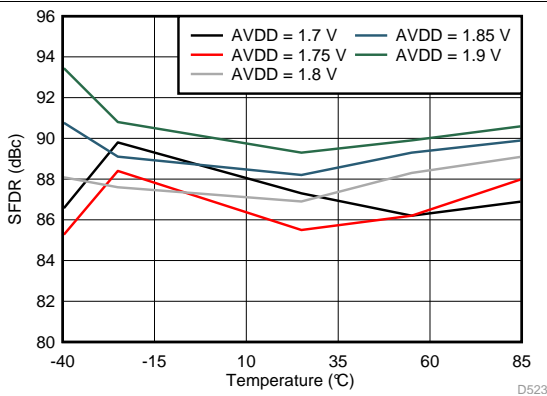


Figure 54. Spurious-Free Dynamic Range vs AVDD Supply and Temperature (30 MHz)

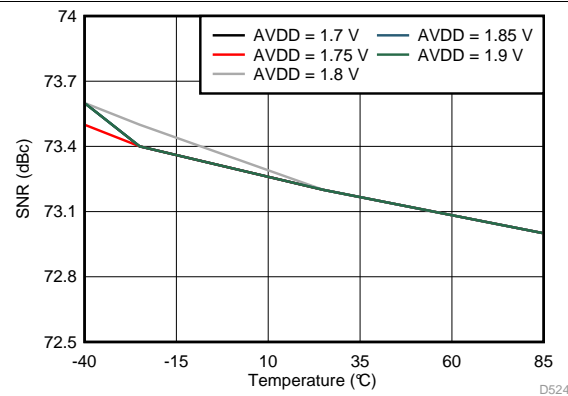


Figure 55. Signal-to-Noise Ratio vs AVDD Supply and Temperature (30 MHz)

Typical Characteristics: ADC3242 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 50 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, $2\cdot V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.

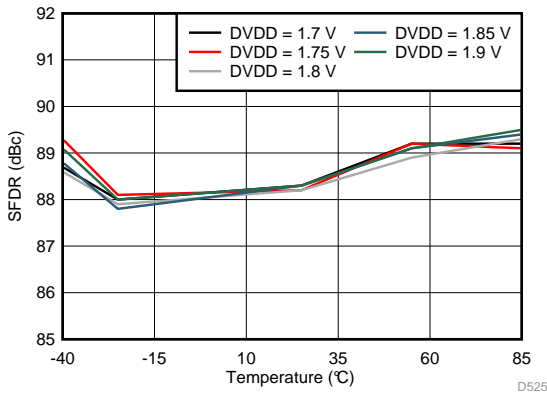


Figure 56. Spurious-Free Dynamic Range vs DVDD Supply and Temperature (30 MHz)

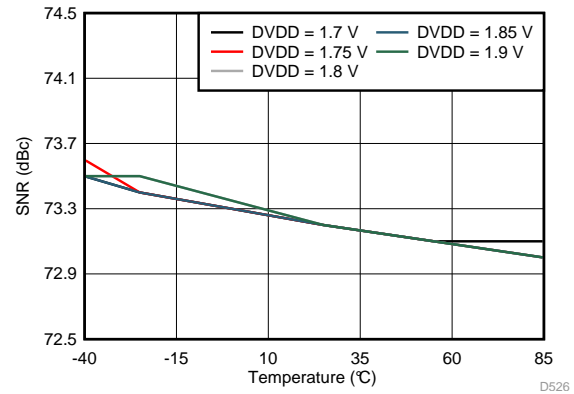


Figure 57. Signal-to-Noise Ratio vs DVDD Supply and Temperature (30 MHz)

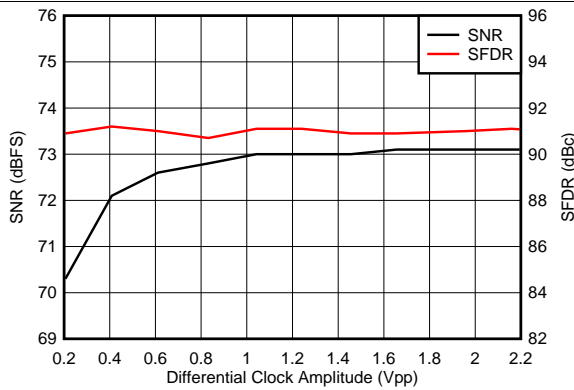


Figure 58. Performance vs Clock Amplitude (40 MHz)

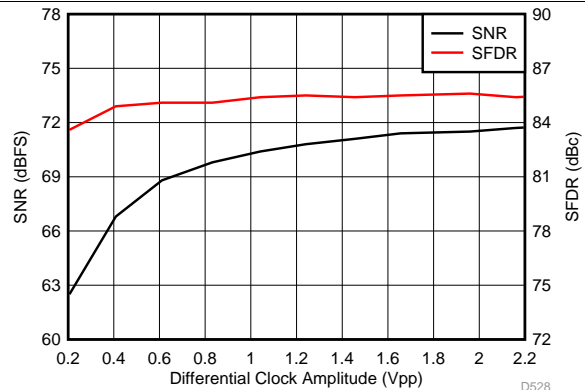


Figure 59. Performance vs Clock Amplitude (150 MHz)

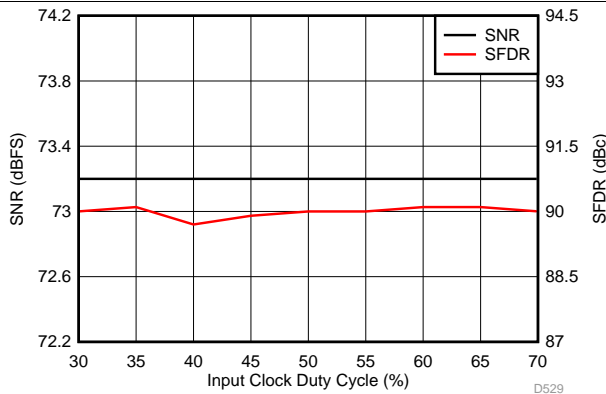


Figure 60. Performance vs Clock Duty Cycle (30 MHz)

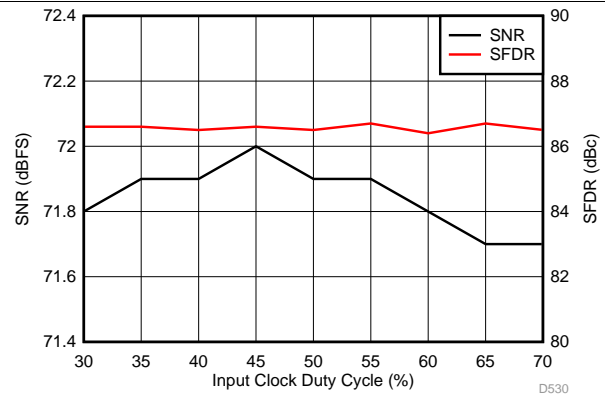
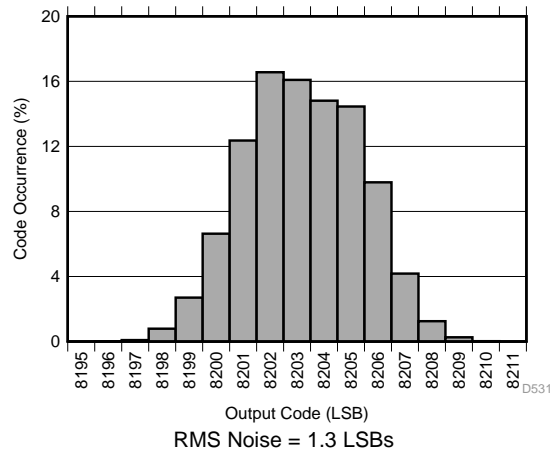


Figure 61. Performance vs Clock Duty Cycle (150 MHz)

Typical Characteristics: ADC3242 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 50 MSPS, 50% clock duty cycle, $AV_{DD} = 1.8\text{ V}$, $DV_{DD} = 1.8\text{ V}$, -1 dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_S / 2$ when chopper is enabled, unless otherwise noted.


Figure 62. Idle Channel Histogram

7.17 Typical Characteristics: ADC3243

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 80 MSPS, 50% clock duty cycle, $AV_{DD} = 1.8\text{ V}$, $DV_{DD} = 1.8\text{ V}$, -1-dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_S / 2$ when chopper is enabled, unless otherwise noted.

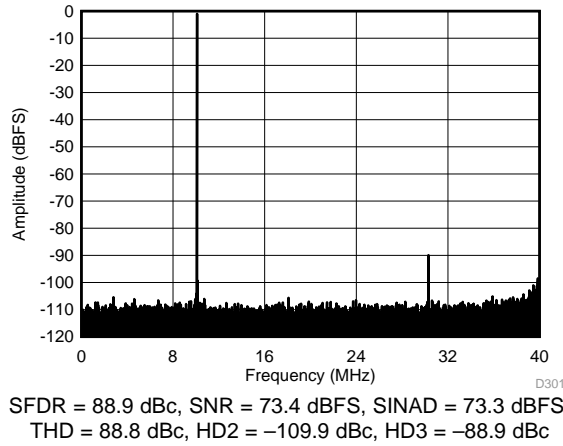


Figure 63. FFT for 10-MHz Input Signal (Dither On)

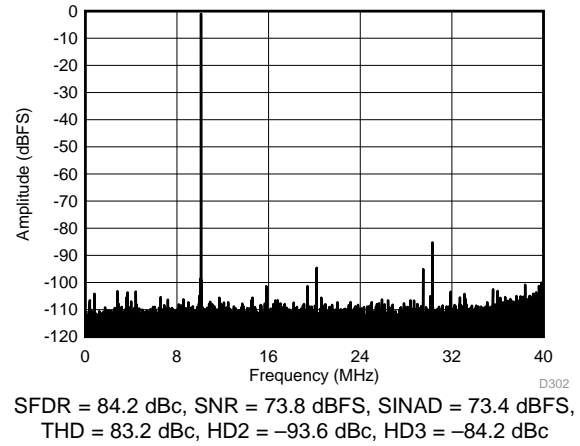


Figure 64. FFT for 10-MHz Input Signal (Dither Off)

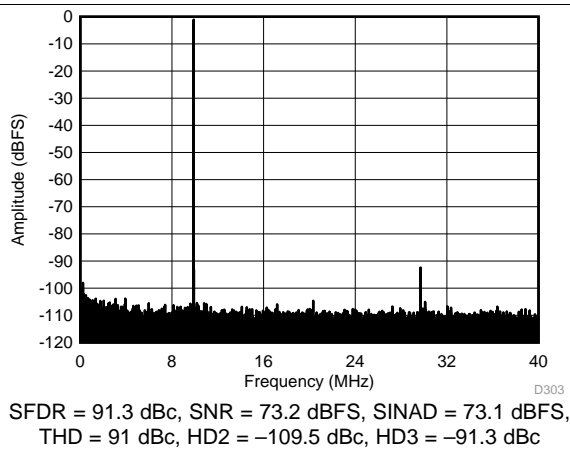


Figure 65. FFT for 70-MHz Input Signal (Dither On)

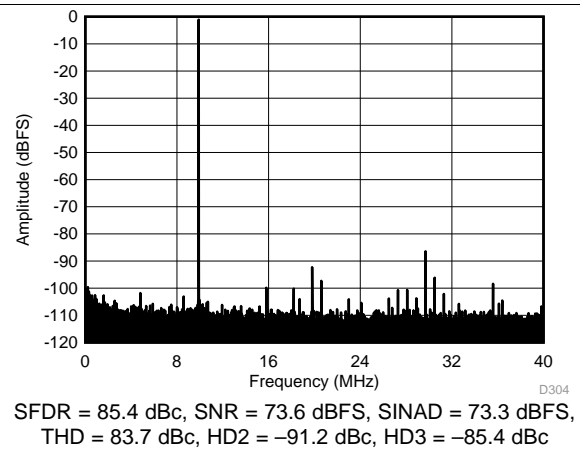


Figure 66. FFT for 70-MHz Input Signal (Dither Off)

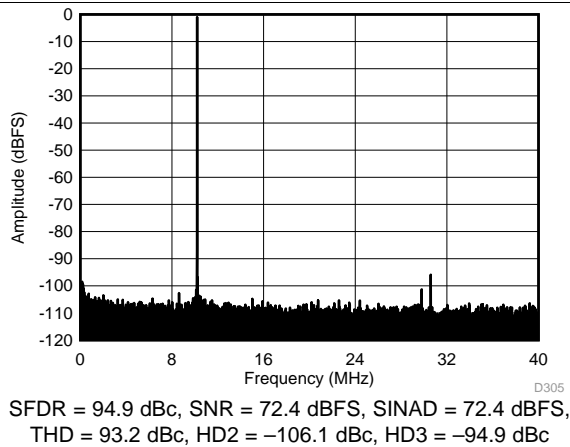


Figure 67. FFT for 170-MHz Input Signal (Dither On)

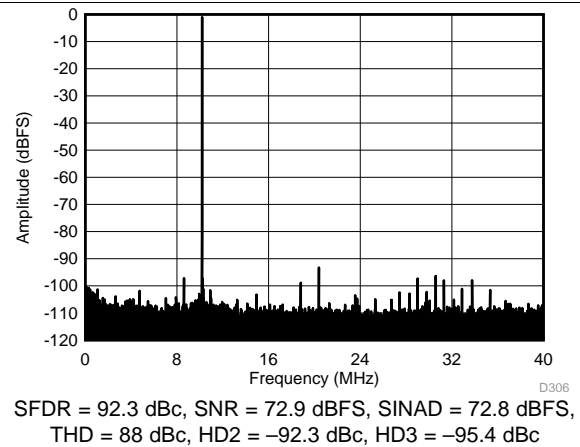
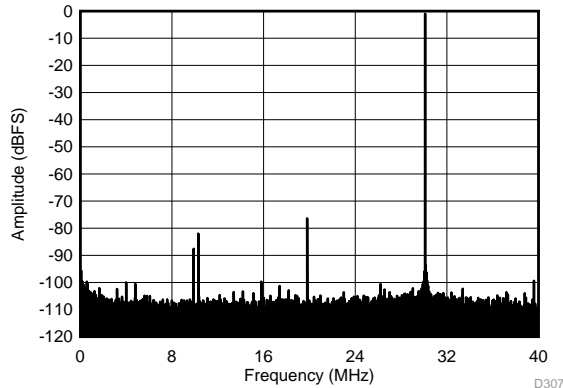


Figure 68. FFT for 170-MHz Input Signal (Dither Off)

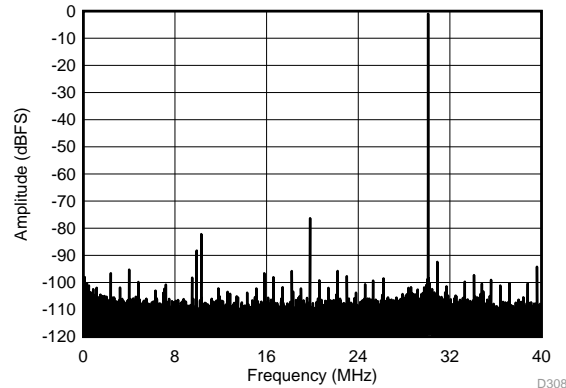
Typical Characteristics: ADC3243 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 80 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, $2\cdot V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.



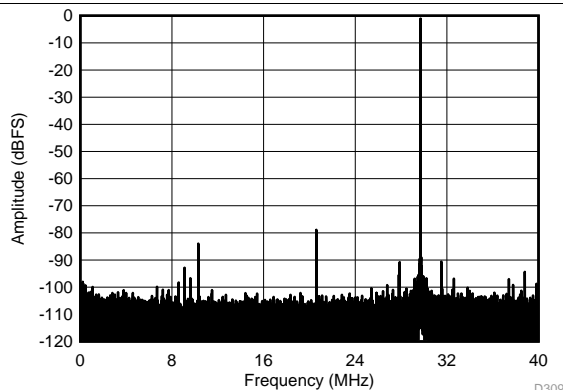
SFDR = 75.4 dBc, SNR = 70.9 dBFS, SINAD = 69.6 dBFS, THD = 74.3 dBc, HD2 = -75.4 dBc, HD3 = -81.0 dBc

Figure 69. FFT for 270-MHz Input Signal (Dither On)



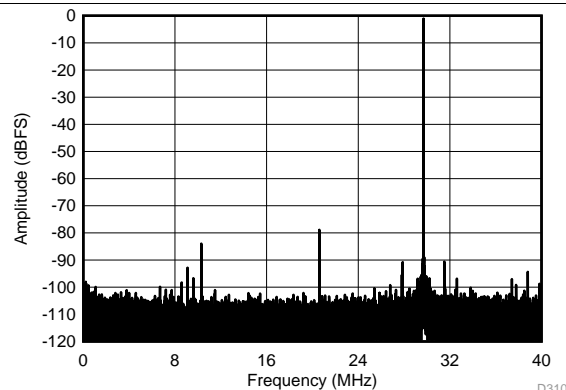
SFDR = 75.4 dBc, SNR = 71.2 dBFS, SINAD = 69.8 dBFS, THD = 74.2 dBc, HD2 = -75.4 dBc, HD3 = -81.2 dBc

Figure 70. FFT for 270-MHz Input Signal (Dither Off)



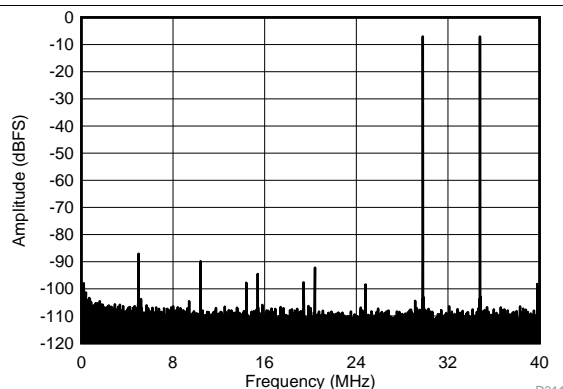
SFDR = 77.8 dBc, SNR = 68.8 dBFS, SINAD = 68.3 dBFS, THD = 77.5 dBc, HD2 = -77.8 dBc, HD3 = -91.8 dBc

Figure 71. FFT for 450-MHz Input Signal (Dither On)



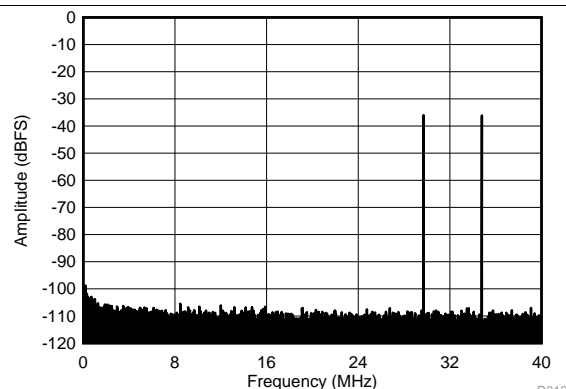
SFDR = 77.8 dBc, SNR = 68.8 dBFS, SINAD = 68.3 dBFS, THD = 77.5 dBc, HD2 = -77.8 dBc, HD3 = -91.8 dBc

Figure 72. FFT for 450-MHz Input Signal (Dither Off)



$f_{IN1} = 46 \text{ MHz}$, $f_{IN2} = 50 \text{ MHz}$, IMD3 = 87 dBFS, each tone at -7 dBFS

Figure 73. FFT for Two-Tone Input Signal (-7 dBFS at 46 MHz and 50 MHz)

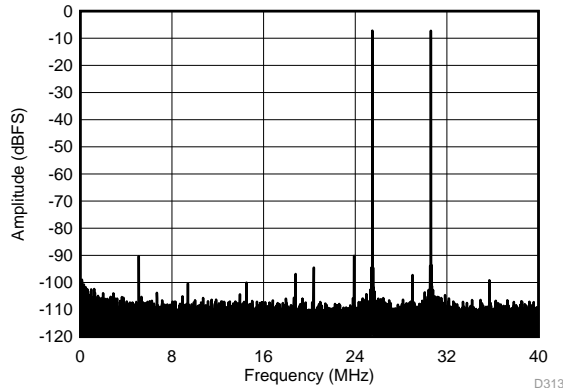


$f_{IN1} = 46 \text{ MHz}$, $f_{IN2} = 50 \text{ MHz}$, IMD3 = 92.8 dBFS, each tone at -36 dBFS

Figure 74. FFT for Two-Tone Input Signal (-36 dBFS at 46 MHz and 50 MHz)

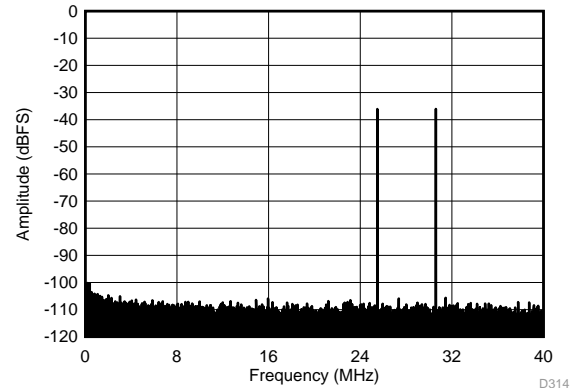
Typical Characteristics: ADC3243 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 80 MSPS, 50% clock duty cycle, $AV_{DD} = 1.8\text{ V}$, $DV_{DD} = 1.8\text{ V}$, -1 dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.



$f_{IN1} = 185\text{ MHz}$, $f_{IN2} = 190\text{ MHz}$, $\text{IMD3} = 78.8\text{ dBFS}$, each tone at -7 dBFS

Figure 75. FFT FOR Two-Tone Input Signal (-7 dBFS at 185 MHz and 190 MHz)



$f_{IN1} = 185\text{ MHz}$, $f_{IN2} = 190\text{ MHz}$, $\text{IMD3} = 91\text{ dBFS}$, each tone at -36 dBFS

Figure 76. FFT FOR Two-Tone Input Signal (-36 dBFS at 185 MHz and 190 MHz)

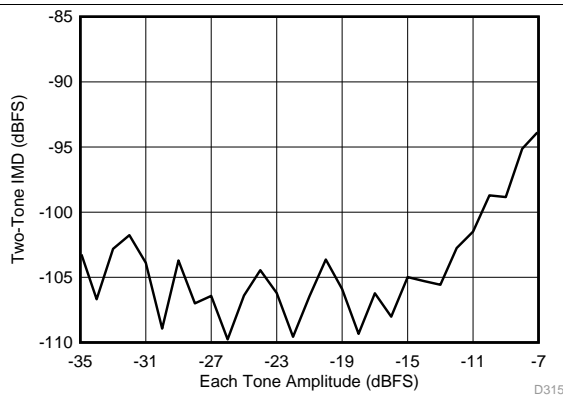


Figure 77. Intermodulation Distortion vs Input Amplitude (46 MHz and 50 MHz)

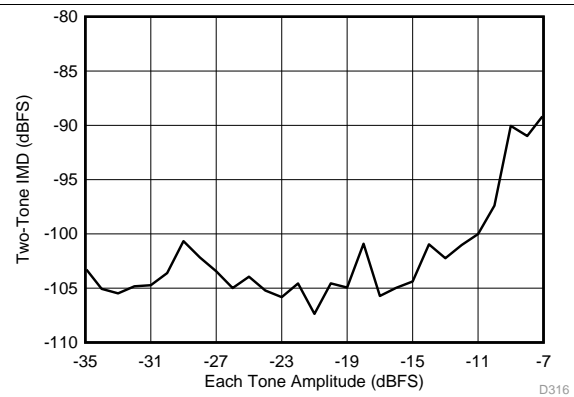


Figure 78. Intermodulation Distortion vs Input Amplitude (185 MHz and 190 MHz)

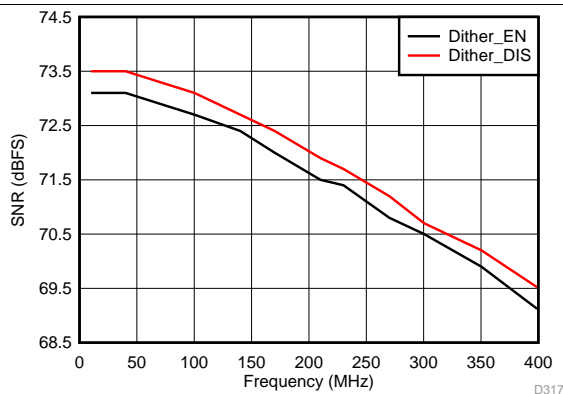


Figure 79. Signal-to-Noise Ratio vs Input Frequency

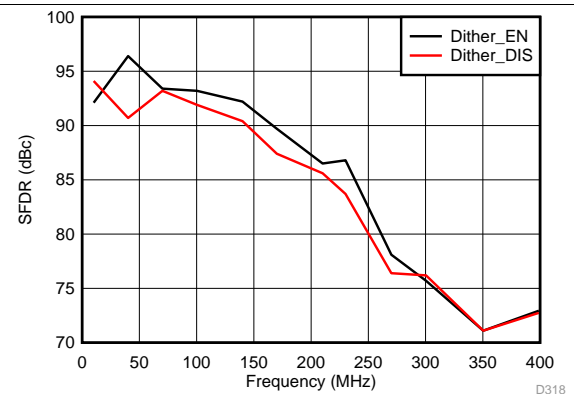


Figure 80. Spurious-Free Dynamic Range vs Input Frequency

Typical Characteristics: ADC3243 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 80 MSPS, 50% clock duty cycle, $AVDD = 1.8\text{ V}$, $DVDD = 1.8\text{ V}$, -1 dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.

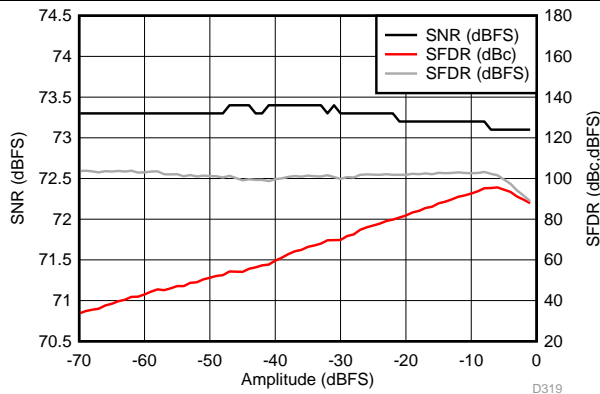


Figure 81. Performance vs Input Amplitude (30 MHz)

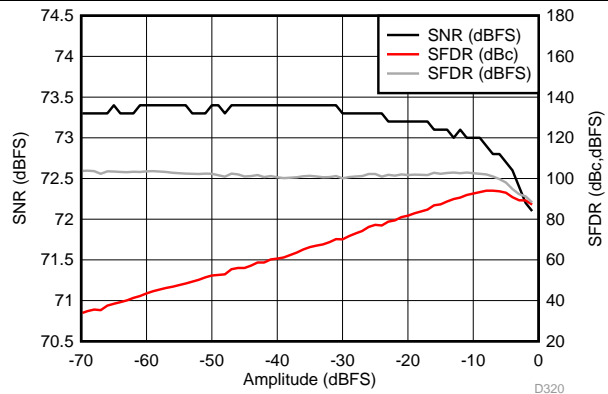


Figure 82. Performance vs Input Amplitude (170 MHz)

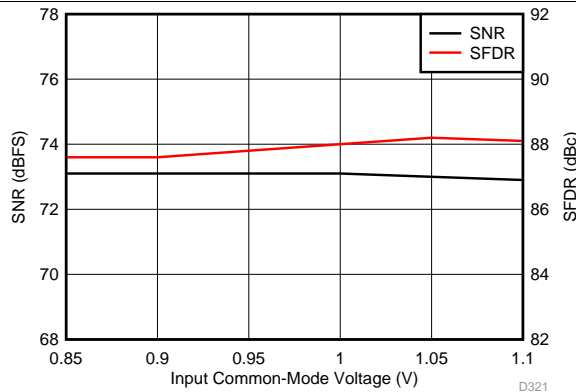


Figure 83. Performance vs Input Common-Mode Voltage (30 MHz)

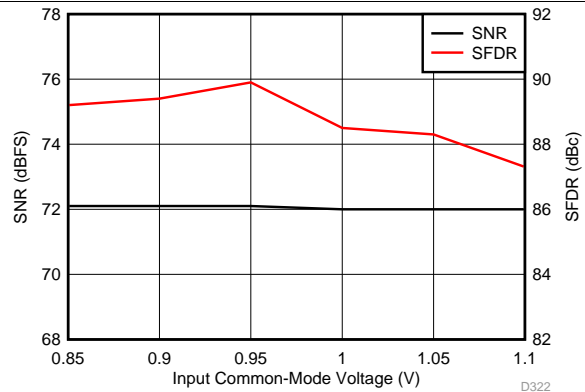


Figure 84. Performance vs Input Common-Mode Voltage (170 MHz)

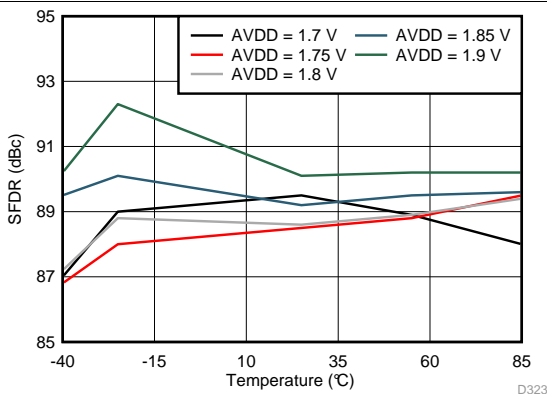


Figure 85. Spurious-Free Dynamic Range vs AVDD Supply and Temperature (170 MHz)

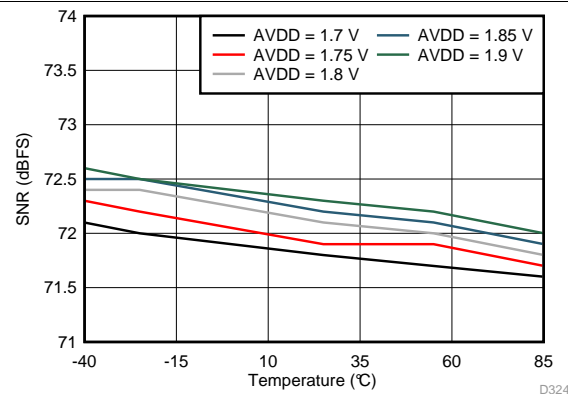


Figure 86. Signal-to-Noise Ratio vs AVDD Supply and Temperature (170 MHz)

Typical Characteristics: ADC3243 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 80 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2- V_{pp} full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.

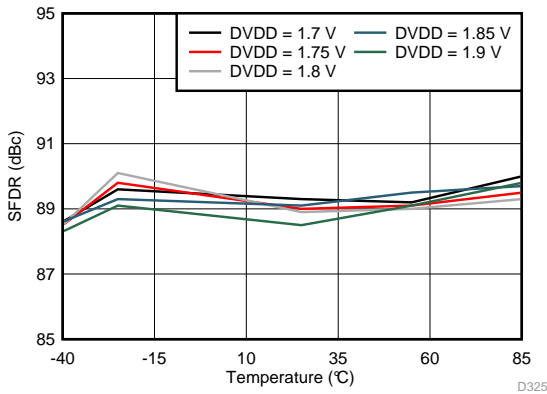


Figure 87. Spurious-Free Dynamic Range vs DVDD Supply and Temperature (170 MHz)

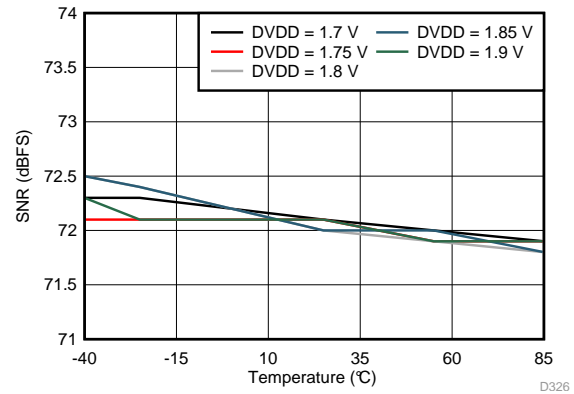


Figure 88. Signal-to-Noise Ratio vs DVDD Supply and Temperature (170 MHz)

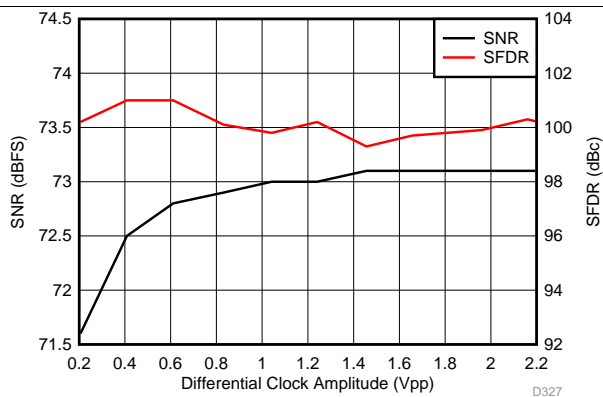


Figure 89. Performance vs Clock Amplitude (40 MHz)

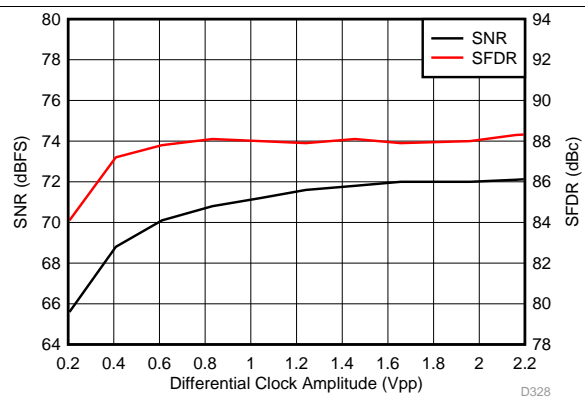


Figure 90. Performance vs Clock Amplitude (150 MHz)

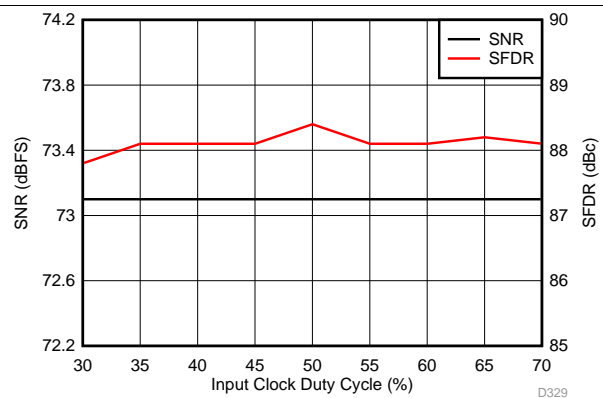


Figure 91. Performance vs Clock Duty Cycle (30 MHz)

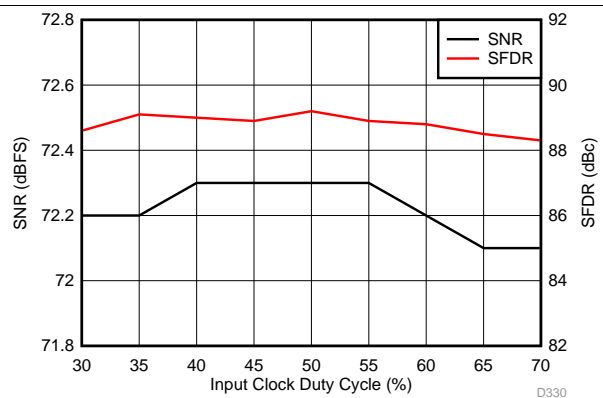
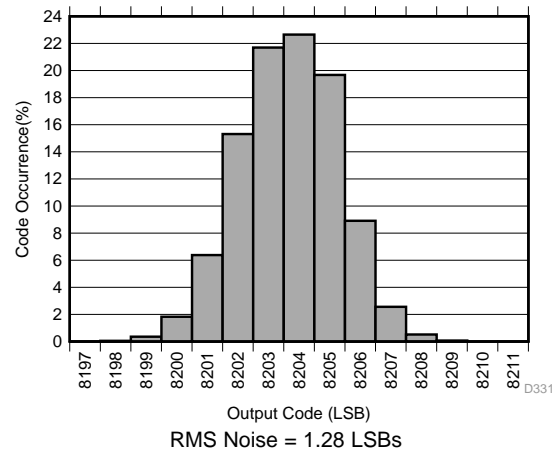


Figure 92. Performance vs Clock Duty Cycle (150 MHz)

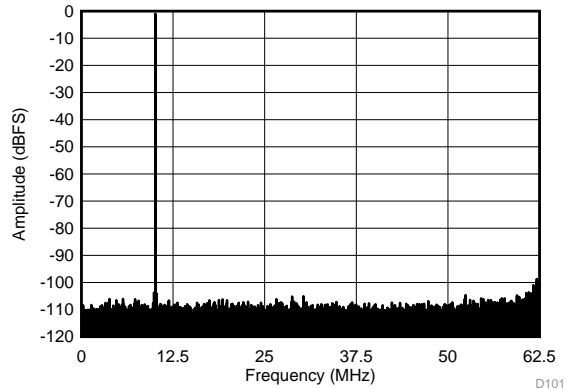
Typical Characteristics: ADC3243 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 80 MSPS, 50% clock duty cycle, $AVDD = 1.8\text{ V}$, $DVDD = 1.8\text{ V}$, -1-dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_S / 2$ when chopper is enabled, unless otherwise noted.


Figure 93. Idle Channel Histogram

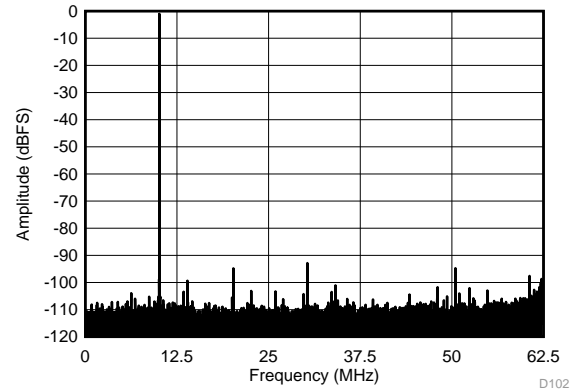
7.18 Typical Characteristics: ADC3244

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 125 MSPS, 50% clock duty cycle, $AV_{DD} = 1.8\text{ V}$, $DV_{DD} = 1.8\text{ V}$, -1-dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.



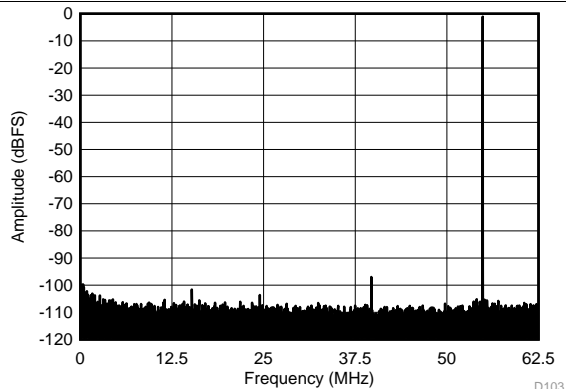
SFDR = 102.6 dBc, SNR = 72.9 dBFS, SINAD = 72.8 dBFS, THD = 99.8 dBc, HD2 = -108.6 dBc , HD3 = -104.0 dBc

Figure 94. FFT for 10-MHz Input Signal (Chopper On, Dither On)



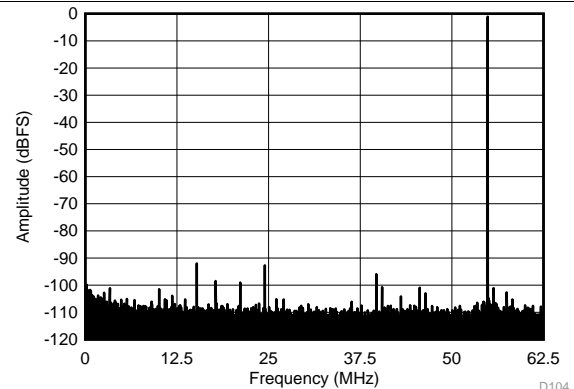
SFDR = 91.8 dBc, SNR = 73.5 dBFS, SINAD = 73.4 dBFS, THD = 87.3 dBc, HD2 = -93.8 dBc , HD3 = -91.8 dBc

Figure 95. FFT for 10-MHz Input Signal (Chopper On, Dither Off)



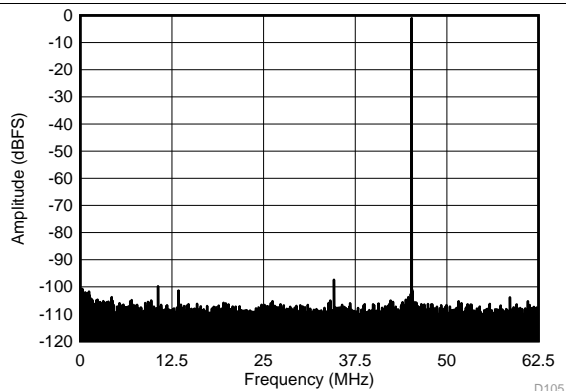
SFDR = 95.9 dBc, SNR = 72.7 dBFS, SINAD = 72.7 dBFS, THD = 93.6 dBc, HD2 = -100.6 dBc , HD3 = -95.9 dBc

Figure 96. FFT for 70-MHz Input Signal (Dither On)



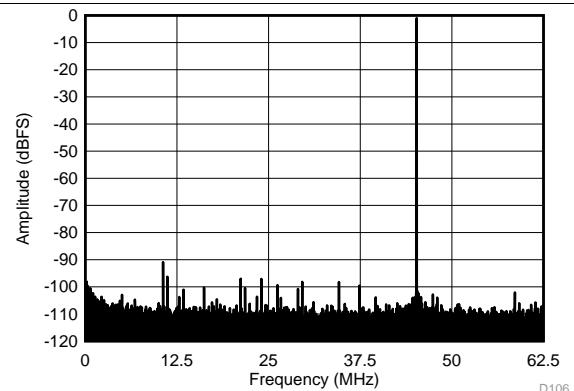
SFDR = 90.9 dBc, SNR = 73.3 dBFS, SINAD = 73.1 dBFS, THD = 87 dBc, HD2 = -90.9 dBc , HD3 = -94.9 dBc

Figure 97. FFT for 70-MHz Input Signal (Dither Off)



SFDR = 96.4 dBc, SNR = 72.1 dBFS, SINAD = 72.0 dBFS, THD = 92.6 dBc, HD2 = -96.4 dBc , HD3 = -98.8 dBc

Figure 98. FFT for 170-MHz Input Signal (Dither On)

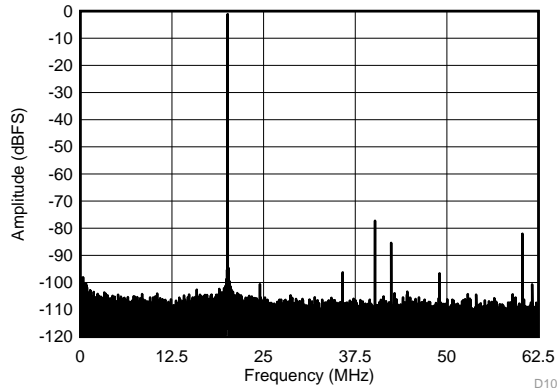


SFDR = 89.9 dBc, SNR = 72.8 dBFS, SINAD = 72.6 dBFS, THD = 87.1 dBc, HD2 = -97.2 dBc , HD3 = -89.9 dBc

Figure 99. FFT for 170-MHz Input Signal (Dither Off)

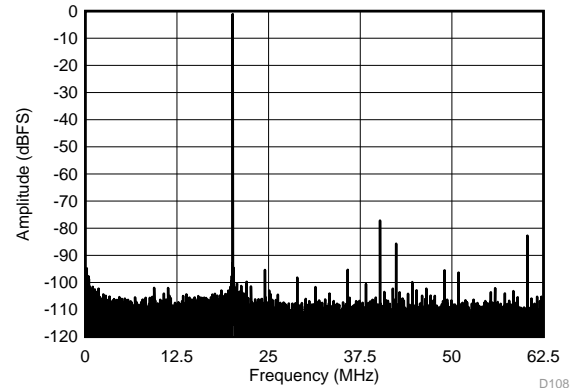
Typical Characteristics: ADC3244 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 125 MSPS, 50% clock duty cycle, $AVDD = 1.8\text{ V}$, $DVDD = 1.8\text{ V}$, -1 dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.



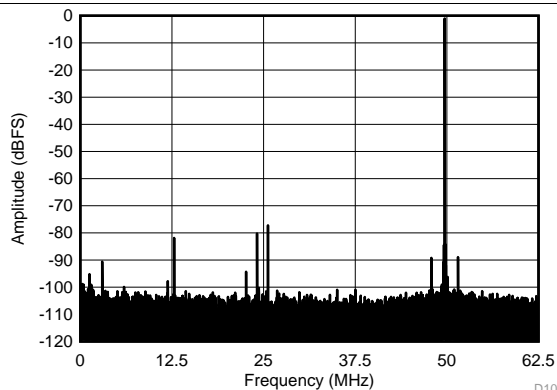
SFDR = 76.1 dBc, SNR = 70.8 dBFS, SINAD = 69.8 dBFS, THD = 74.8 dBc, HD2 = -76.1 dBc , HD3 = -80.9 dBc

Figure 100. FFT for 270-MHz Input Signal (Dither On)



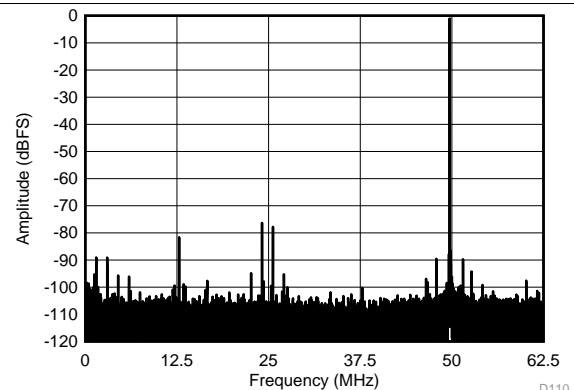
SFDR = 76.1 dBc, SNR = 71.2 dBFS, SINAD = 70.2 dBFS, THD = 74.9 dBc, HD2 = -76.1 dBc , HD3 = -81.6 dBc

Figure 101. FFT for 270-MHz Input Signal (Dither Off)



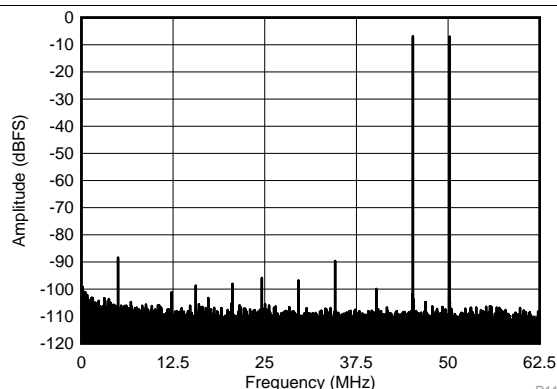
SFDR = 76.2 dBc, SNR = 68.8 dBFS, SINAD = 67.5 dBFS, THD = 74.3 dBc, HD2 = -76.2 dBc , HD3 = -79.2 dBc

Figure 102. FFT for 450-MHz Input Signal (Dither On)



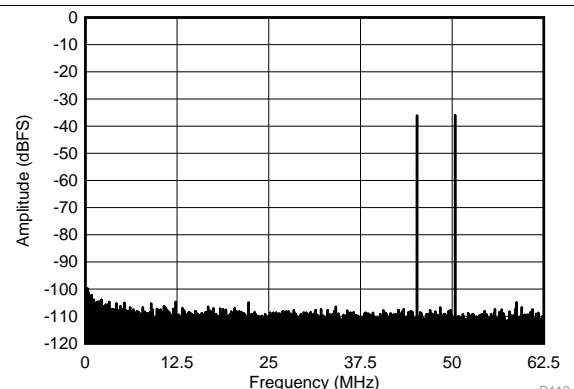
SFDR = 75.3 dBc, SNR = 69.1 dBFS, SINAD = 67.8 dBFS, THD = 72.7 dBc, HD2 = -76.7 dBc , HD3 = -75.3 dBc

Figure 103. FFT for 450-MHz Input Signal (Dither Off)



$f_{IN1} = 46\text{ MHz}$, $f_{IN2} = 50\text{ MHz}$, IMD3 = 88.3 dBFS, each tone at -7 dBFS

Figure 104. FFT for Two-Tone Input Signal (-7 dBFS at 46 MHz and 50 MHz)

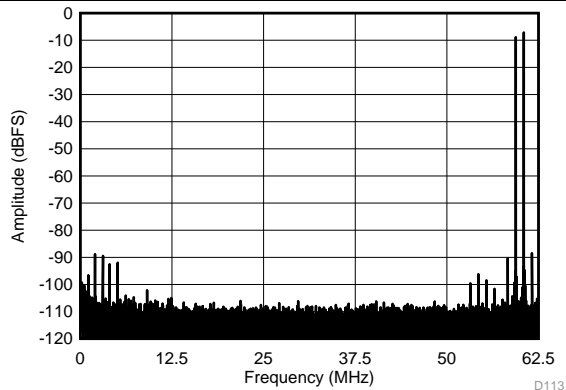


$f_{IN1} = 46\text{ MHz}$, $f_{IN2} = 50\text{ MHz}$, IMD3 = 90.8 dBFS, each tone at -36 dBFS

Figure 105. FFT for Two-Tone Input Signal (-36 dBFS at 46 MHz and 50 MHz)

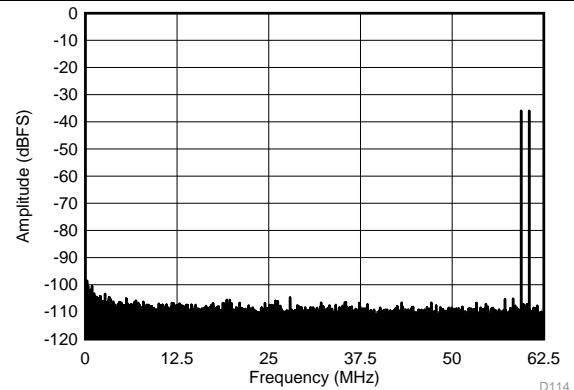
Typical Characteristics: ADC3244 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 125 MSPS, 50% clock duty cycle, $AVDD = 1.8\text{ V}$, $DVDD = 1.8\text{ V}$, -1-dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.



$f_{IN1} = 185\text{ MHz}$, $f_{IN2} = 190\text{ MHz}$, $\text{IMD3} = 86.4\text{ dBFS}$, each tone at -7 dBFS

Figure 106. FFT for Two-Tone Input Signal (-7 dBFS at 185 MHz and 190 MHz)



$f_{IN1} = 185\text{ MHz}$, $f_{IN2} = 190\text{ MHz}$, $\text{IMD3} = 87.28\text{ dBFS}$, each tone at -36 dBFS

Figure 107. FFT for Two-Tone Input Signal (-36 dBFS at 185 MHz and 190 MHz)

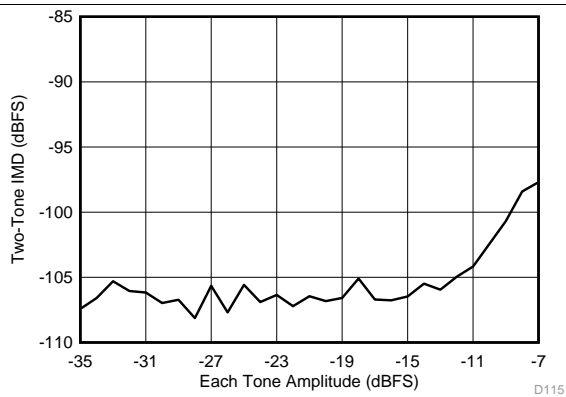


Figure 108. Intermodulation Distortion vs Input Amplitude (46 MHz and 50 MHz)

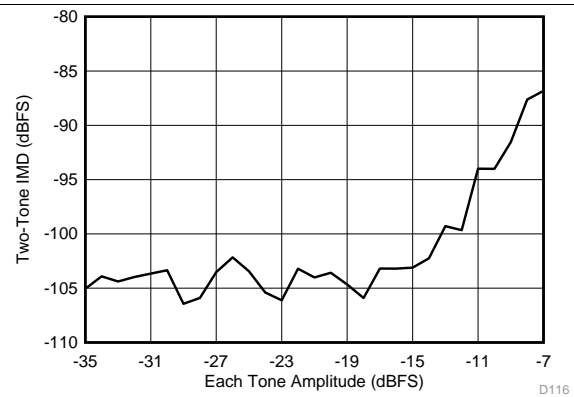


Figure 109. Intermodulation Distortion vs Input Amplitude (185 MHz and 190 MHz)

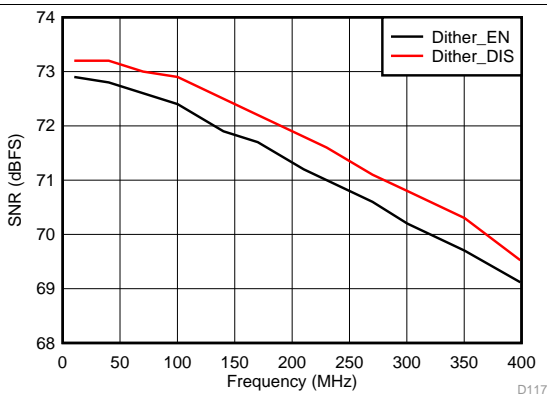


Figure 110. Signal-to-Noise Ratio vs Input Frequency

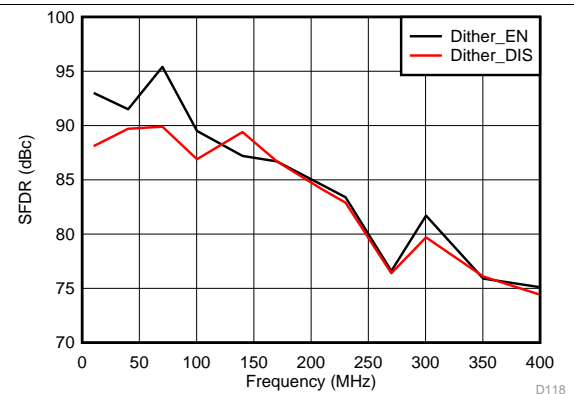


Figure 111. Spurious-Free Dynamic Range vs Input Frequency

Typical Characteristics: ADC3244 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 125 MSPS, 50% clock duty cycle, $AV_{DD} = 1.8\text{ V}$, $DV_{DD} = 1.8\text{ V}$, -1 dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.

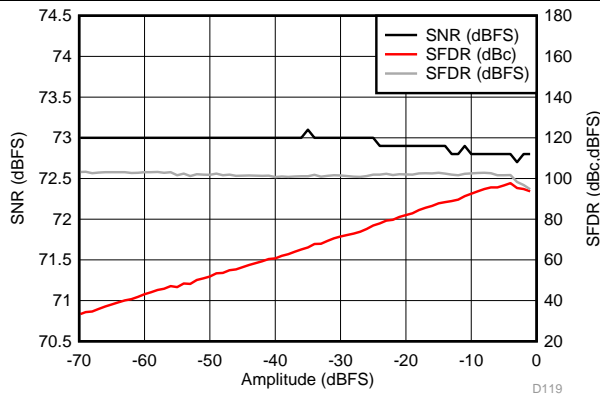


Figure 112. Performance vs Input Amplitude (30 MHz)

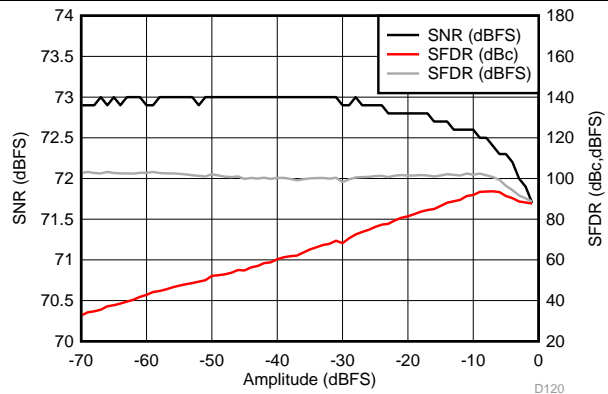


Figure 113. Performance vs Input Amplitude (170 MHz)

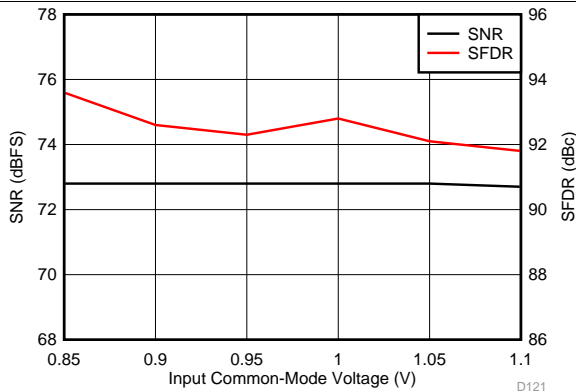


Figure 114. Performance vs Input Common-Mode Voltage (30 MHz)

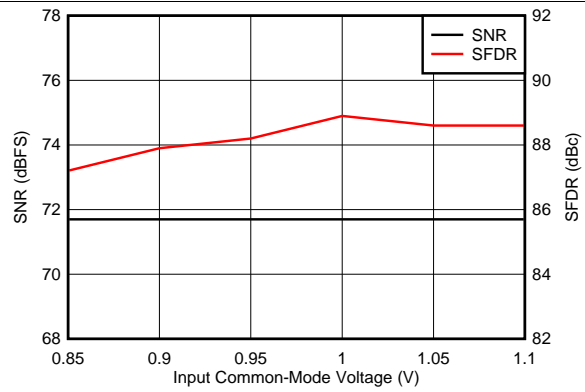


Figure 115. Performance vs Input Common-Mode Voltage (170 MHz)

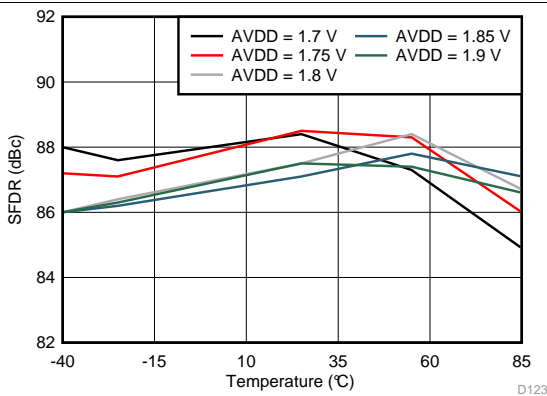


Figure 116. Spurious-Free Dynamic Range vs AVDD Supply and Temperature (170 MHz)

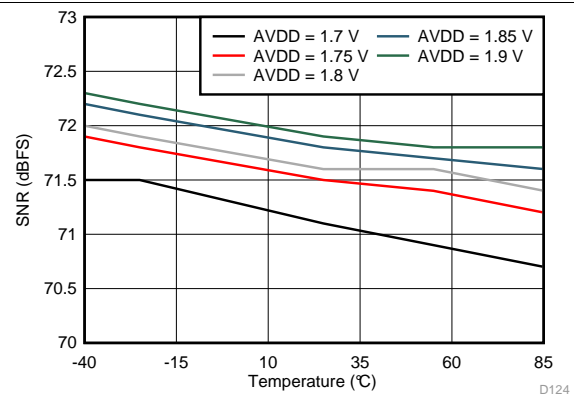


Figure 117. Signal-to-Noise Ratio vs AVDD Supply and Temperature (170 MHz)

Typical Characteristics: ADC3244 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 125 MSPS, 50% clock duty cycle, $AV_{DD} = 1.8\text{ V}$, $DV_{DD} = 1.8\text{ V}$, -1 dBFS differential input, $2\text{-}V_{pp}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.

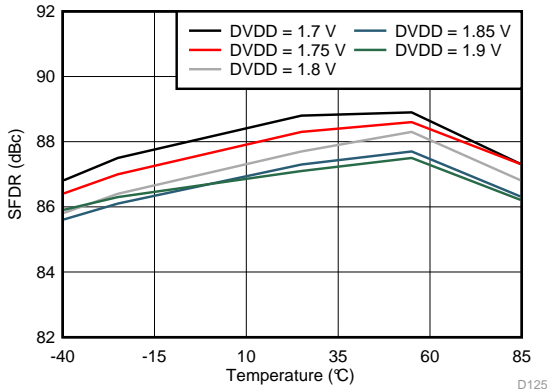


Figure 118. Spurious-Free Dynamic Range vs DVDD Supply and Temperature (170 MHz)

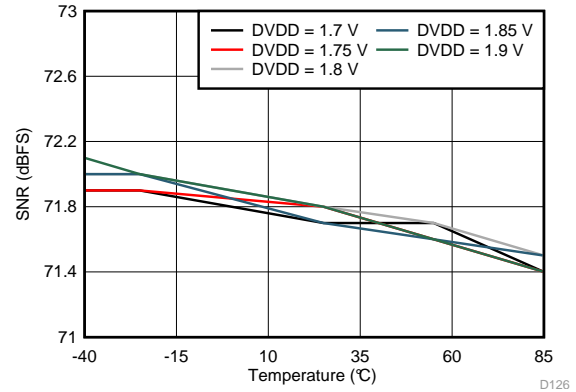


Figure 119. Signal-to-Noise Ratio vs DVDD Supply and Temperature (170 MHz)

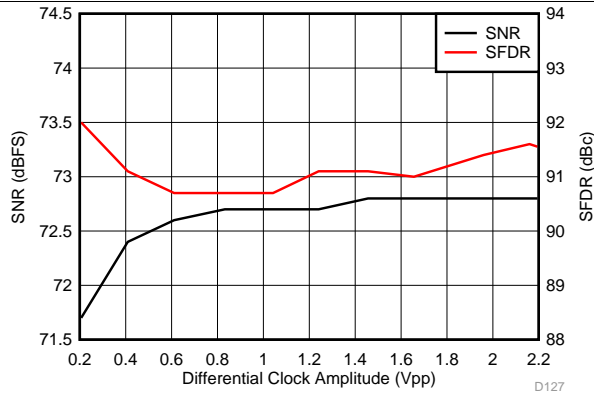


Figure 120. Performance vs Clock Amplitude (40 MHz)

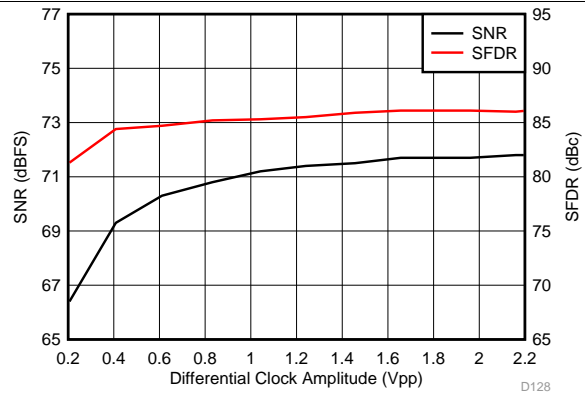


Figure 121. Performance vs Clock Amplitude (150 MHz)

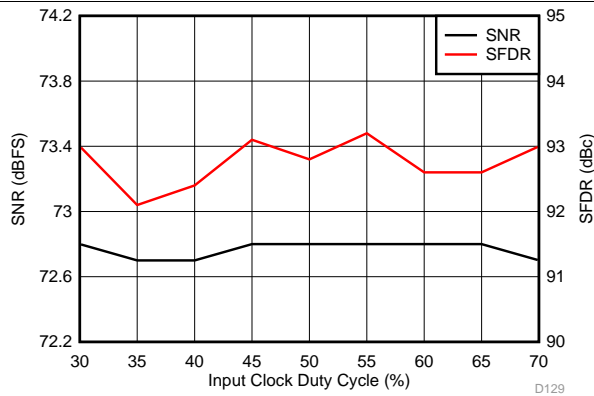


Figure 122. Performance vs Clock Duty Cycle (30 MHz)

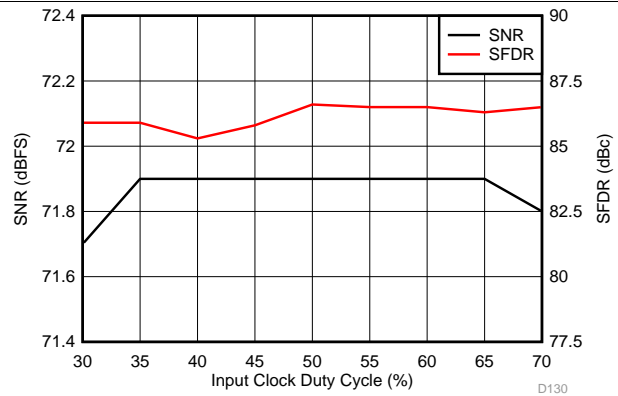
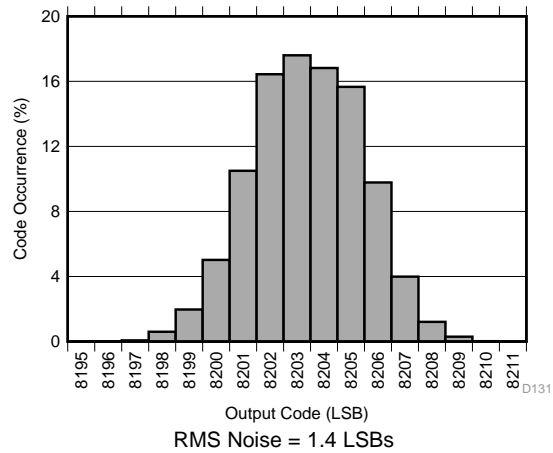


Figure 123. Performance vs Clock Duty Cycle (150 MHz)

Typical Characteristics: ADC3244 (continued)

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 125 MSPS, 50% clock duty cycle, $AVDD = 1.8\text{ V}$, $DVDD = 1.8\text{ V}$, -1-dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_S / 2$ when chopper is enabled, unless otherwise noted.


Figure 124. Idle Channel Histogram

7.19 Typical Characteristics: Common

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 125 MSPS, 50% clock duty cycle, $AV_{DD} = 1.8\text{ V}$, $DV_{DD} = 1.8\text{ V}$, -1-dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when chopper is enabled, unless otherwise noted.

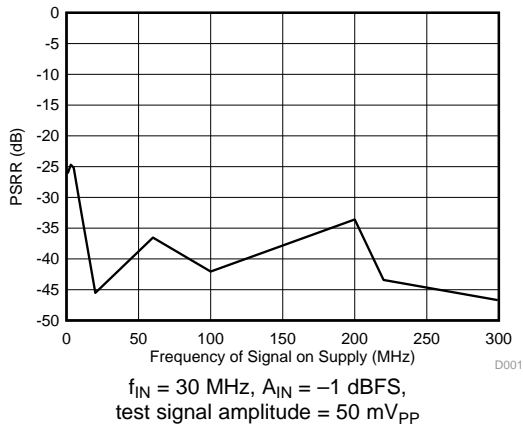


Figure 125. Power-Supply Rejection Ratio vs Test Signal Frequency

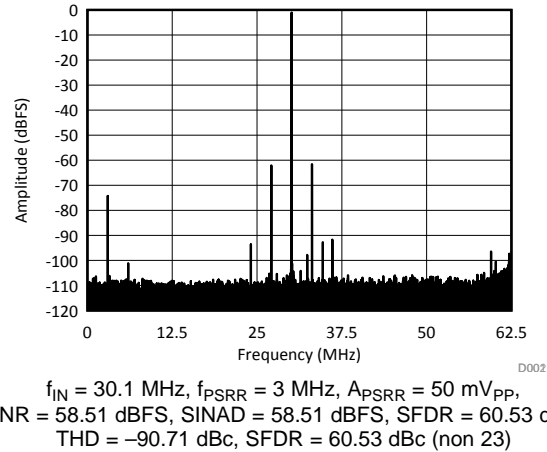


Figure 126. Power-Supply Rejection Ratio Spectrum

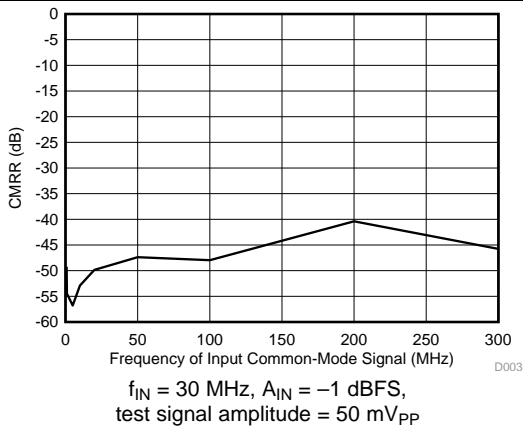


Figure 127. Common-Mode Rejection Ratio vs Test Signal Frequency

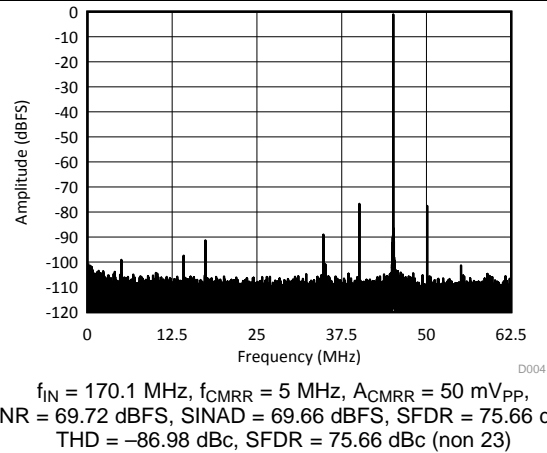


Figure 128. Common-Mode Rejection Ratio Spectrum

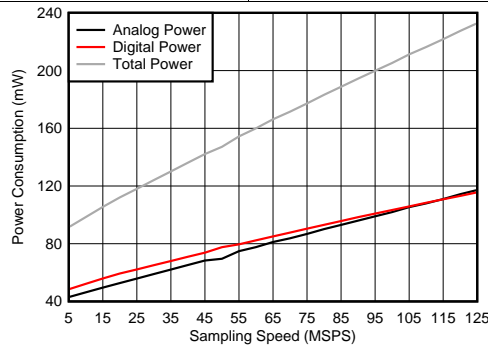


Figure 129. Power vs Sampling Frequency (One-Wire Mode)

7.20 Typical Characteristics: Contour

Typical values are at $T_A = 25^\circ\text{C}$, ADC sampling rate = 125 MSPS, 50% clock duty cycle, $AVDD = 1.8\text{ V}$, $DVDD = 1.8\text{ V}$, -1-dBFS differential input, $2\text{-}V_{PP}$ full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from $f_s / 2$ when is chopper enabled, unless otherwise noted.

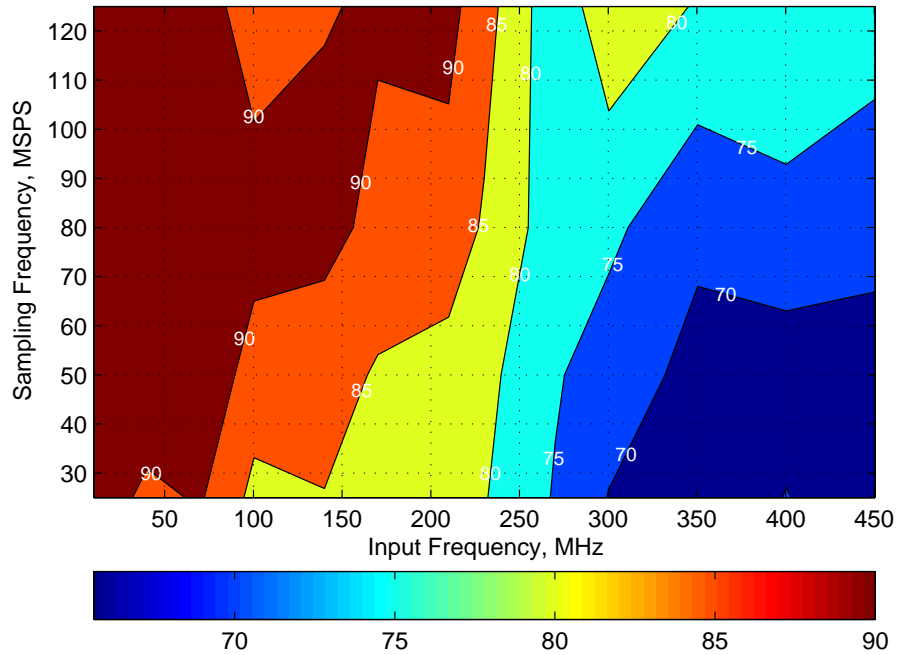


Figure 130. Spurious-Free Dynamic Range (SFDR)

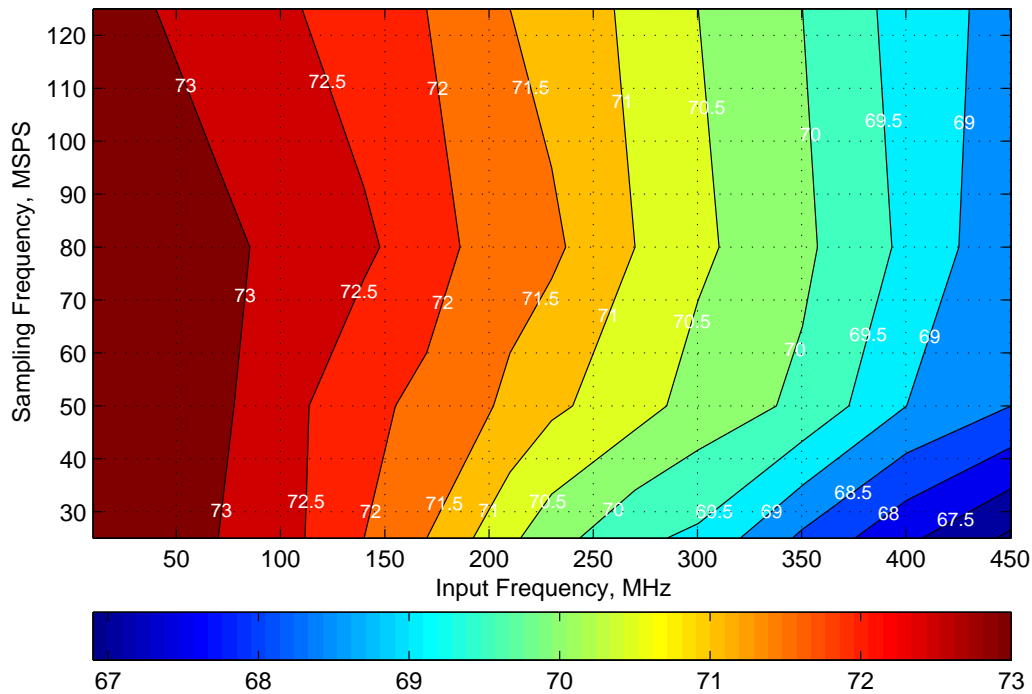
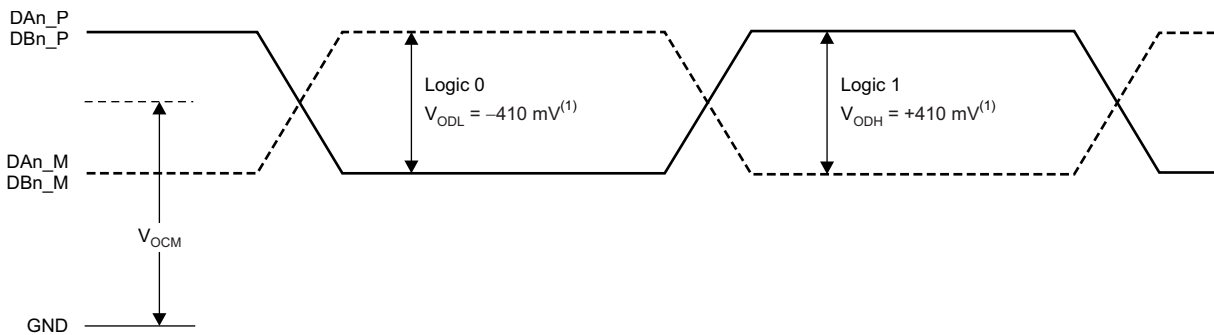


Figure 131. Signal-to-Noise Ratio (SNR)

8 Parameter Measurement Information

8.1 Timing Diagrams



(1) With an external 100-Ω termination.

Figure 132. Serial LVDS Output Voltage Levels

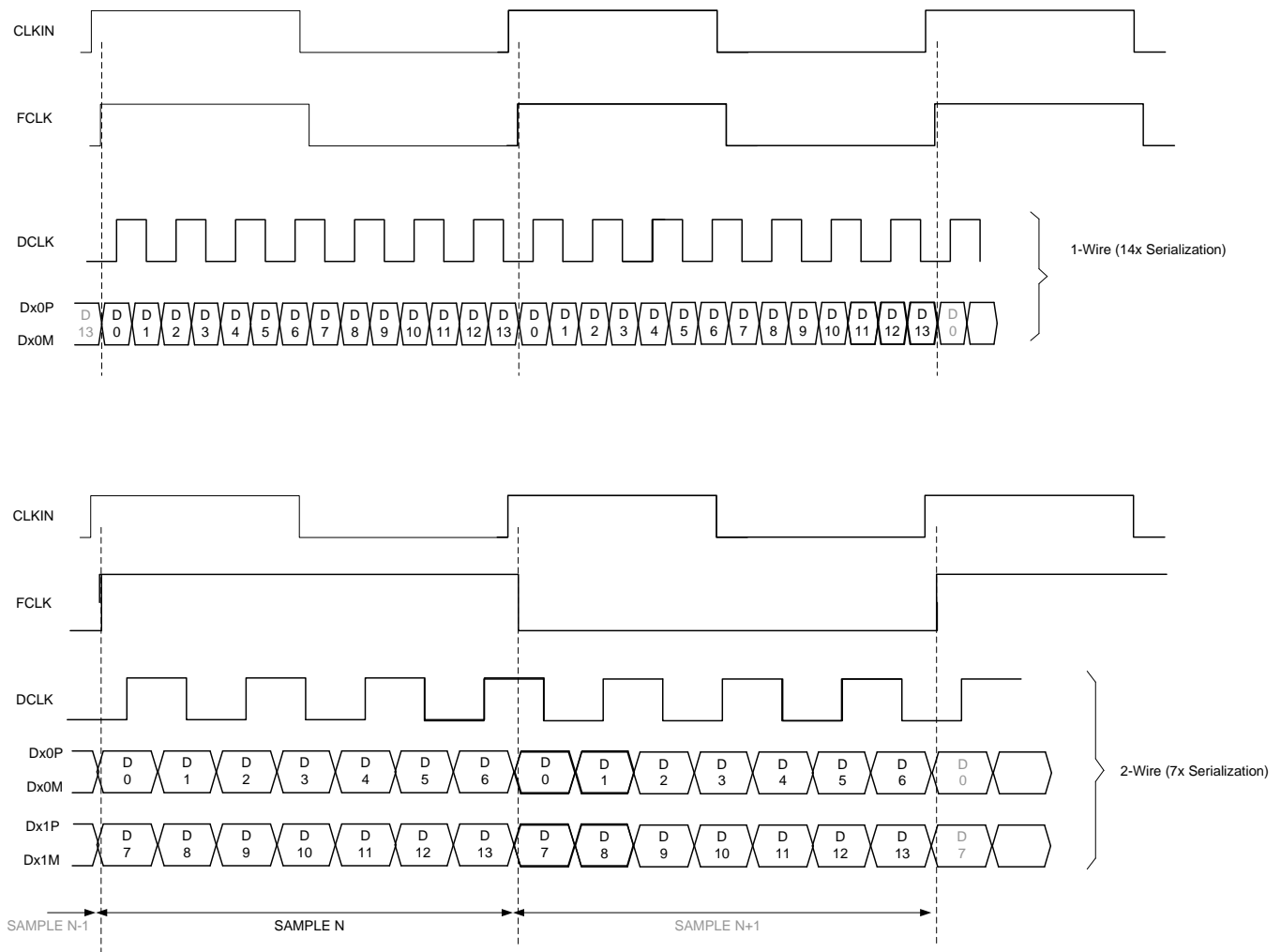


Figure 133. Output Timing Diagram

Timing Diagrams (continued)

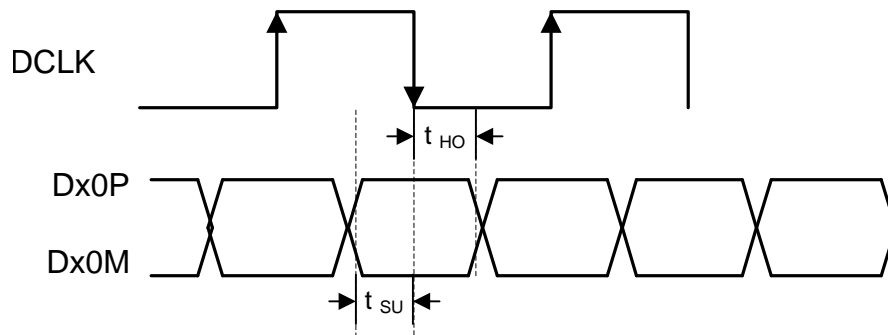
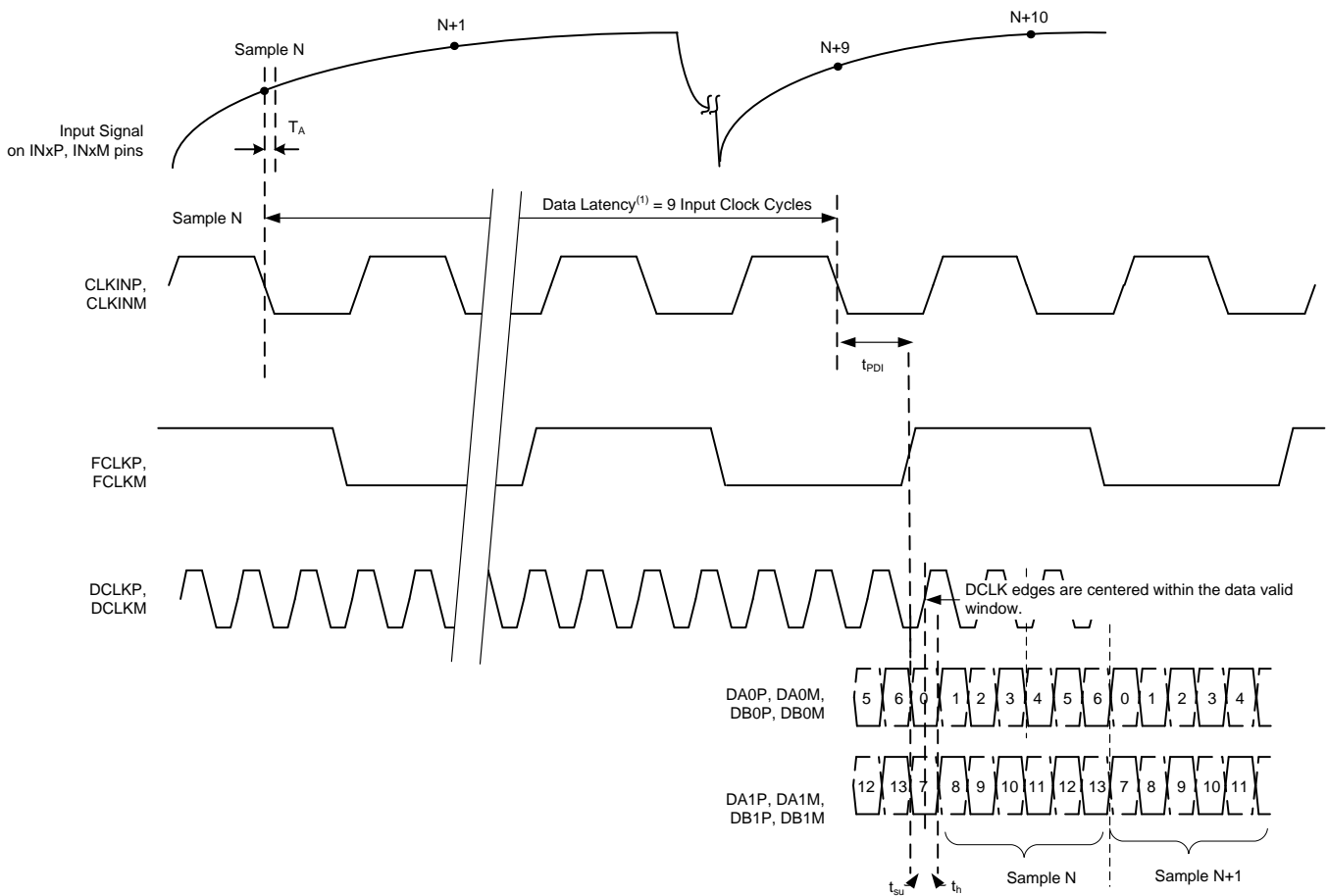


Figure 134. Setup and Hold Time



(1) Overall latency = data latency + t_{PD1} .

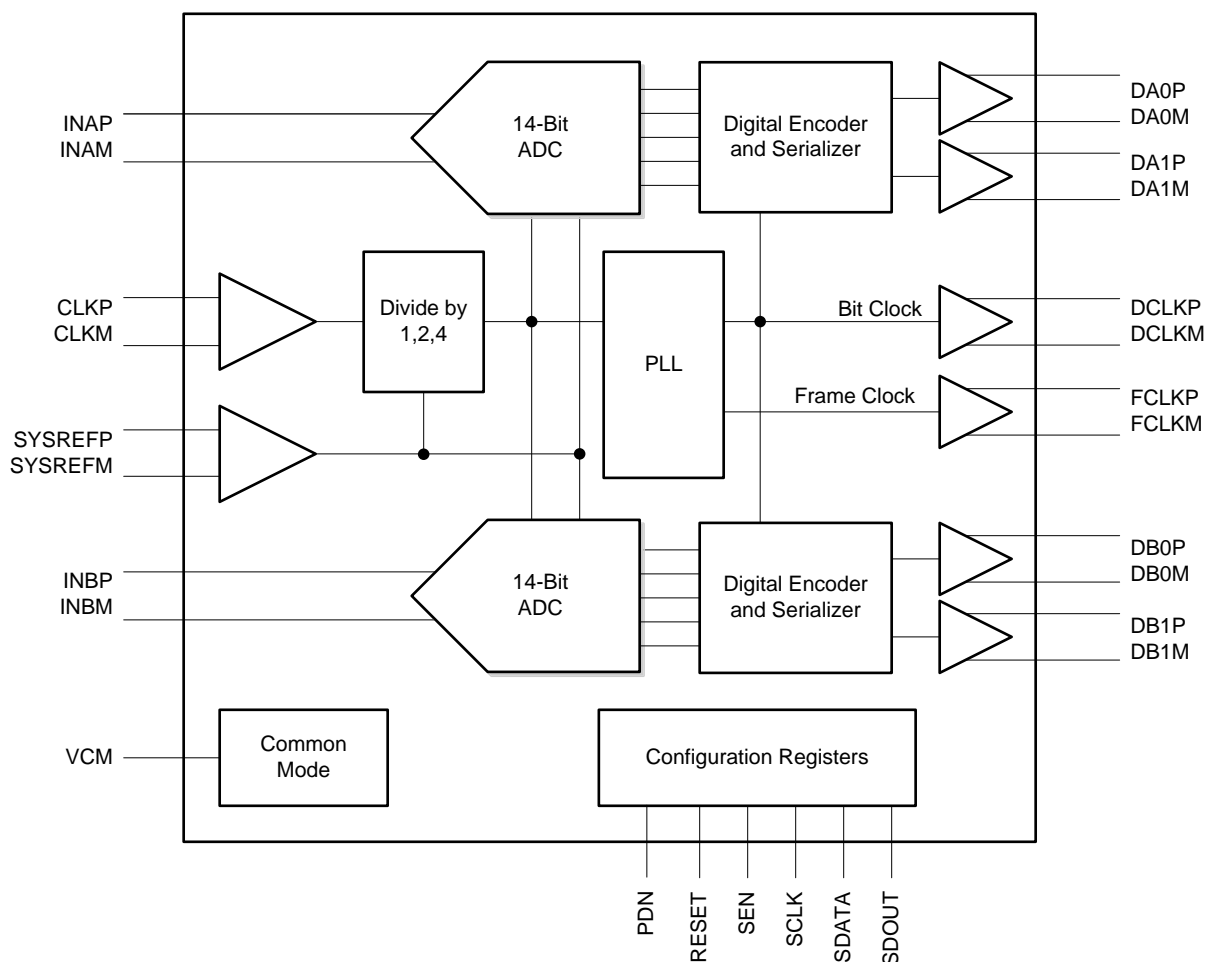
Figure 135. Latency Diagram

9 Detailed Description

9.1 Overview

The ADC324x are a high-linearity, ultra-low power, quad-channel, 14-bit, 25-MSPS to 125-MSPS, analog-to-digital converter (ADC) family. The devices are designed specifically to support demanding, high input frequency signals with large dynamic range requirements. An input clock divider allows more flexibility for system clock architecture design while the SYSREF input enables complete system synchronization. The ADC324x family supports serial LVDS interface in order to reduce the number of interface lines, thus allowing for high system integration density. The serial LVDS interface is two-wire, where each ADC data are serialized and output over two LVDS pairs. An internal phase-locked loop (PLL) multiplies the incoming ADC sampling clock to derive the bit clock that is used to serialize the 14-bit output data from each channel. In addition to the serial data streams, the frame and bit clocks are also transmitted as LVDS outputs.

9.2 Functional Block Diagram



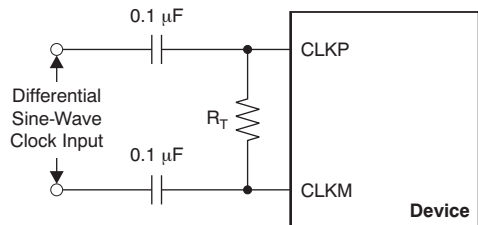
9.3 Feature Description

9.3.1 Analog Inputs

The ADC324x analog signal inputs are designed to be driven differentially. Each input pin (INP, INM) must swing symmetrically between $(V_{CM} + 0.5\text{ V})$ and $(V_{CM} - 0.5\text{ V})$, resulting in a $2\text{-}V_{PP}$ (default) differential input swing. The input sampling circuit has a 3-dB bandwidth that extends up to 540 MHz (50- Ω source driving 50- Ω termination between INP and INM).

9.3.2 Clock Input

The device clock inputs can be driven differentially (sine, LVPECL, or LVDS) or single-ended (LVCMOS), with little or no difference in performance between them. The common-mode voltage of the clock inputs is set to 0.95 V using internal 5-k Ω resistors. The self-bias clock inputs of the ADC324x can be driven by the transformer-coupled, sine-wave clock source or by the ac-coupled, LVPECL and LVDS clock sources, as shown in Figure 136, Figure 137, and Figure 138. See Figure 139 for details regarding the internal clock buffer.



NOTE: R_T = termination resistor, if necessary.

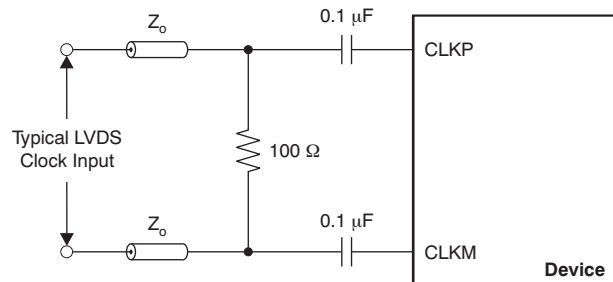


Figure 136. Differential Sine-Wave Clock Driving Circuit

Figure 137. LVDS Clock Driving Circuit

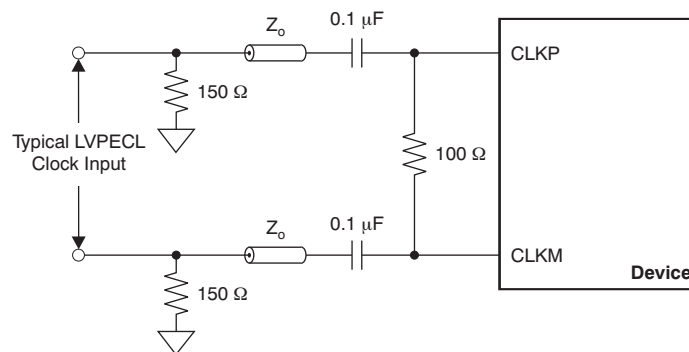
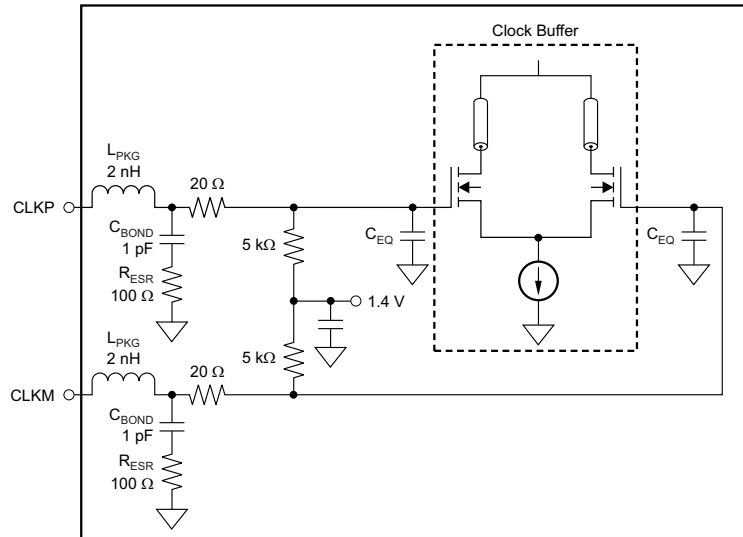


Figure 138. LVPECL Clock Driving Circuit



NOTE: C_{EQ} is 1 pF to 3 pF and is the equivalent input capacitance of the clock buffer.

Figure 139. Internal Clock Buffer

A single-ended CMOS clock can be ac-coupled to the CLKP input, with CLKM connected to ground with a 0.1- μ F capacitor, as shown in Figure 140. However, for best performance the clock inputs must be driven differentially, thereby reducing susceptibility to common-mode noise. For high input frequency sampling, TI recommends using a clock source with very low jitter. Band-pass filtering of the clock source can help reduce the effects of jitter. There is no change in performance with a non-50% duty cycle clock input.

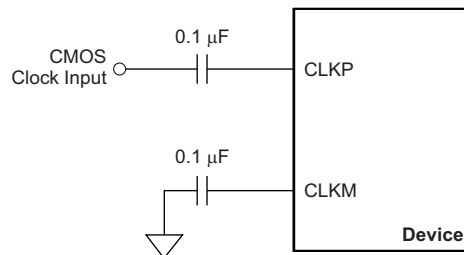


Figure 140. Single-Ended Clock Driving Circuit

9.3.2.1 SNR and Clock Jitter

The signal-to-noise ratio of the ADC is limited by three different factors, as shown in Equation 1. Quantization noise (typically 86 dB for a 14-bit ADC) and thermal noise limit SNR at low input frequencies while the clock jitter sets SNR for higher input frequencies.

$$SNR_{ADC}[dBc] = -20 \cdot \log \sqrt{\left(10^{\frac{SNR_{Quantization\ Noise}}{20}}\right)^2 + \left(10^{\frac{SNR_{Thermal\ Noise}}{20}}\right)^2 + \left(10^{\frac{SNR_{Jitter}}{20}}\right)^2} \quad (1)$$

The SNR limitation resulting from sample clock jitter can be calculated with Equation 2.

$$SNR_{Jitter}[dBc] = -20 \cdot \log(2\pi \cdot f_{in} \cdot T_{Jitter}) \quad (2)$$

The total clock jitter (T_{Jitter}) has two components: the internal aperture jitter (130 fs for the device) which is set by the noise of the clock input buffer and the external clock. T_{Jitter} can be calculated with Equation 3.

$$T_{Jitter} = \sqrt{(T_{Jitter,Ext.Clock_Input})^2 + (T_{Aperture_ADC})^2} \quad (3)$$

External clock jitter can be minimized by using high-quality clock sources and jitter cleaners as well as band pass filters at the clock input while a faster clock slew rate improves the ADC aperture jitter. The ADC324x has a typical thermal noise of 73.5 dBFS and internal aperture jitter of 130 fs. Figure 141 shows SNR (from 1 MHz offset leaving the 1/f flicker noise) for different jitter of clock driver.

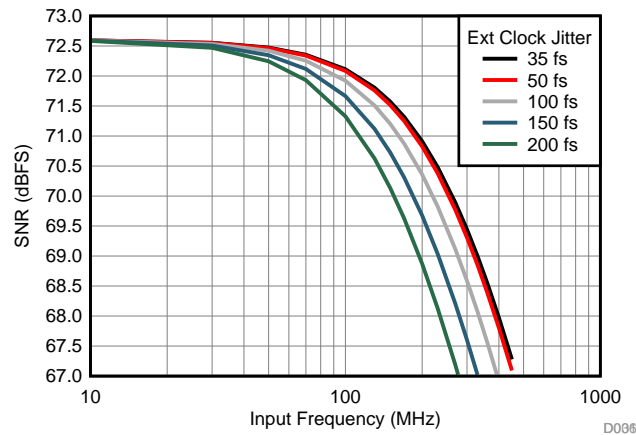


Figure 141. SNR vs Frequency for Different Clock Jitter

9.3.3 Digital Output Interface

The devices offer two different output format options, thus making interfacing to a field-programmable gate array (FPGA) or an application-specific integrated circuit (ASIC) easy. Each option can be easily programmed using the serial interface, as shown in Table 3. The output interface options are:

- One-wire, 1x frame clock, 14x serialization with the DDR bit clock and
- Two-wire, 0.5x frame clock, 7x serialization with the DDR bit clock.

Table 3. Interface Rates

INTERFACE OPTIONS	SERIALIZATION	RECOMMENDED SAMPLING FREQUENCY (MSPS)		BIT CLOCK FREQUENCY (MHz)	FRAME CLOCK FREQUENCY (MHz)	SERIAL DATA RATE (Mbps)
		MINIMUM	MAXIMUM			
1-wire	14x	15 ⁽¹⁾	—	105	15	210
		—	80	560	80	1120
2-wire (default after reset)	7x	20 ⁽¹⁾	—	70	10	140
		—	125	437.5	62.5	875

(1) Use the LOW SPEED ENABLE register bits for low speed operation; see Table 22.

9.3.3.1 One-Wire Interface: 14x Serialization

In this interface option, the device outputs the data of each ADC serially on a single LVDS pair (one-wire). The data are available at the rising and falling edges of the bit clock (DDR bit clock). The ADC outputs a new word at the rising edge of every frame clock, starting with the MSB. The data rate is 14x sample frequency (14x serialization).

9.3.3.2 Two-Wire Interface: 7x Serialization

The two-wire interface is recommended for sampling frequencies above 65 MSPS. The output data rate is 7x sample frequency because seven data bits are output every clock cycle on each differential pair. Each ADC sample is sent over the two wires with the seven MSBs on Dx1P, Dx1M and the seven LSBs on Dx0P, Dx0M, as shown in Figure 142. Note that in two-wire mode, the frame clock (FCLK) frequency is half of sampling clock (CLKIN) frequency.

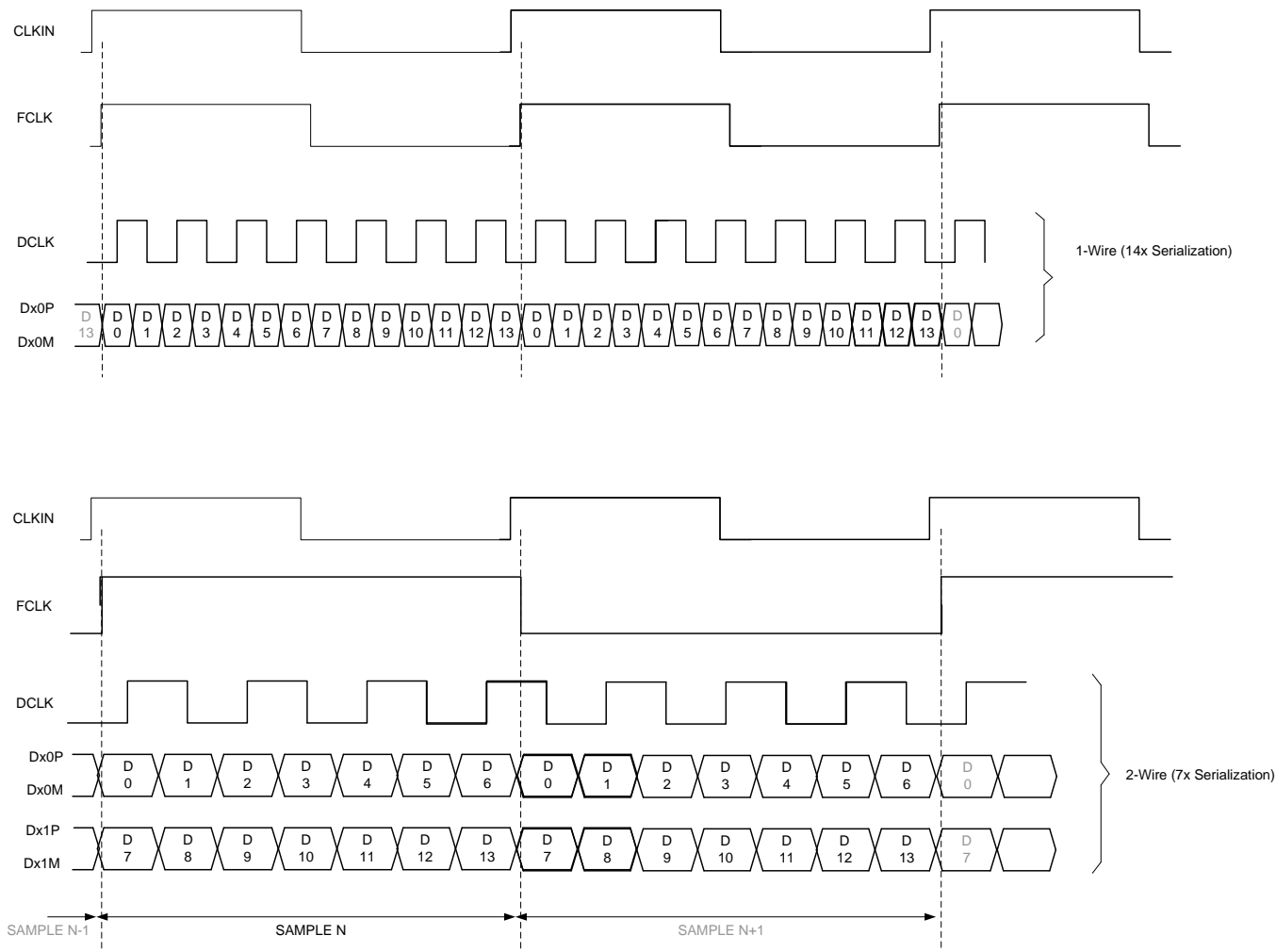


Figure 142. Output Timing Diagram

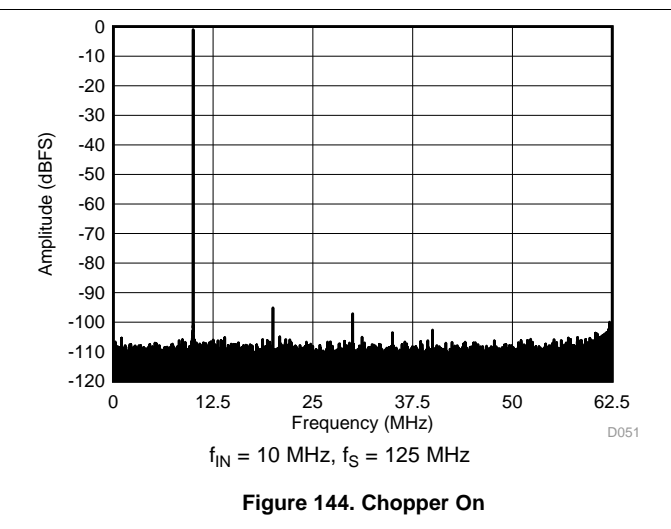
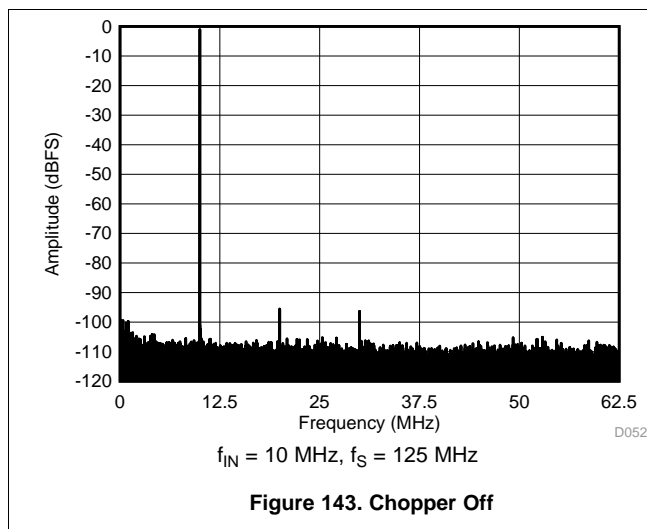
9.4 Device Functional Modes

9.4.1 Input Clock Divider

The devices are equipped with an internal divider on the clock input. The clock divider allows operation with a faster input clock, thus simplifying the system clock distribution design. The clock divider can be bypassed for operation with a 125-MHz clock while the divide-by-2 option supports a maximum input clock of 250 MHz and the divide-by-4 option provides a maximum input clock frequency of 500 MHz.

9.4.2 Chopper Functionality

The devices are equipped with an internal chopper front-end. Enabling the chopper function swaps the ADC noise spectrum by shifting the $1/f$ noise from dc to $f_S / 2$. [Figure 143](#) shows the noise spectrum with the chopper off and [Figure 144](#) shows the noise spectrum with the chopper on. This function is especially useful in applications requiring good ac performance at low input frequencies or in dc-coupled applications. The chopper can be enabled via SPI register writes and is recommended for input frequencies below 30 MHz. The chopper function creates a spur at $f_S / 2$ that must be filtered out digitally.



9.4.3 Power-Down Control

The power-down functions of the ADC324x can be controlled either through the parallel control pin (PDN) or through an SPI register setting (see [register 15h](#)). The PDN pin can also be configured via SPI to a global power-down or standby functionality, as shown in [Table 4](#).

Table 4. Power-Down Modes

FUNCTION	POWER CONSUMPTION (mW)	WAKE-UP TIME (μ s)
Global power-down	5	85
Standby	81	35

9.4.3.1 Improving Wake-Up Time From Global Power-Down

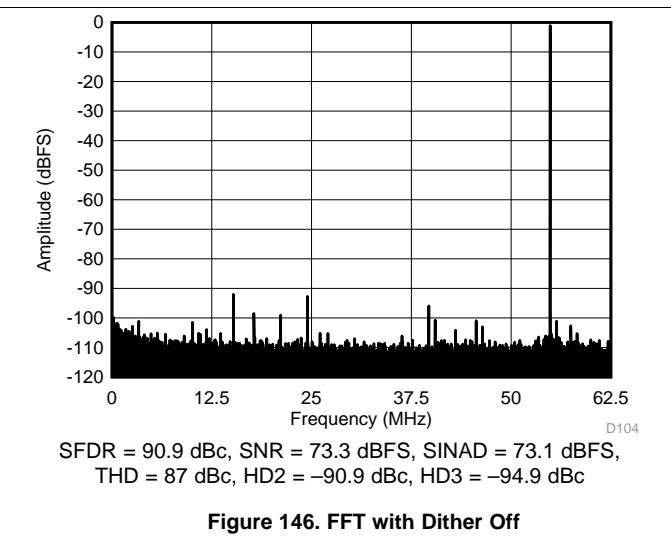
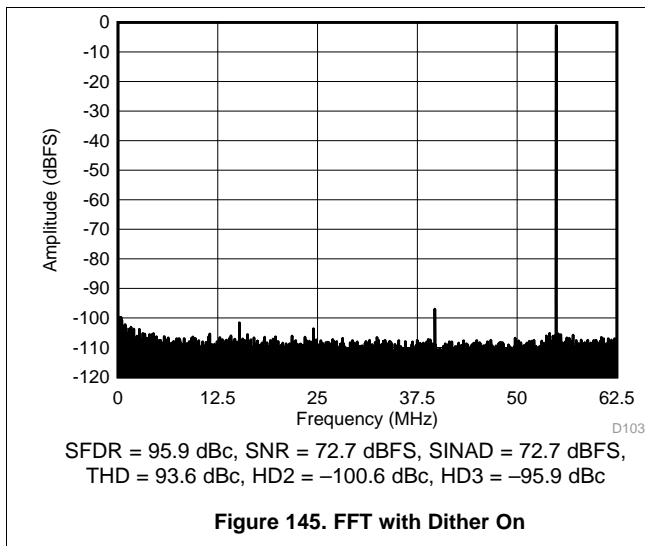
The device has an internal low-pass filter in the sampling clock path. This low-pass filter helps improve the aperture jitter of the device. However, in applications where input frequencies are < 200 MHz, noise from the aperture jitter does not dominate the overall SNR of the device. In such applications, the wake-up time from a global power-down can be reduced by bypassing the low-pass filter using the DIS CLK FILT register bit (write 80h to register address 70Ah). As shown in Table 5, setting the DIS CLK FILT bit improves the wake-up time from a global power-down from 85 μ s to 55 μ s.

Table 5. Wake-Up Time From Global Power-Down

DIS CLK FILT REGISTER BIT	GLOBAL PDN REGISTER BIT	WAKE-UP TIME		
		TYP	MAX	UNIT
0	0→1→0	85	140	μ s
1	0→1→0	55	81	μ s

9.4.4 Internal Dither Algorithm

The ADC324x use an internal dither algorithm to achieve high SFDR and a clean spectrum. However, the dither algorithm marginally degrades SNR, creating a trade-off between SNR and SFDR. If desired, the dither algorithm can be turned off by using the DIS DITH CHx registers bits. Figure 145 and Figure 146 show the effect of using dither algorithms.



9.5 Programming

The ADC324x can be configured using a serial programming interface, as described in this section.

9.5.1 Serial Interface

The device has a set of internal registers that can be accessed by the serial interface formed by the SEN (serial interface enable), SCLK (serial interface clock), SDATA (serial interface data), and SDOUT (serial interface data output) pins. Serially shifting bits into the device is enabled when SEN is low. Serial data SDATA are latched at every SCLK rising edge when SEN is active (low). The serial data are loaded into the register at every 24th SCLK rising edge when SEN is low. When the word length exceeds a multiple of 24 bits, the excess bits are ignored. Data can be loaded in multiples of 24-bit words within a single active SEN pulse. The interface can function with SCLK frequencies from 20 MHz down to very low speeds (of a few hertz) and also with a non-50% SCLK duty cycle.

Programming (continued)

9.5.1.1 Register Initialization

After power-up, the internal registers **must be** initialized to their default values through a hardware reset by applying a high pulse on the RESET pin (of durations greater than 10 ns), as shown in Figure 147. If required, the serial interface registers can be cleared during operation either:

1. Through a hardware reset, or
2. By applying a software reset. When using the serial interface, set the RESET bit (D0 in register address 06h) high. This setting initializes the internal registers to the default values and then self-resets the RESET bit low. In this case, the RESET pin is kept low.

9.5.1.1.1 Serial Register Write

The device internal register can be programmed with these steps:

1. Drive the SEN pin low,
2. Set the R/W bit to 0 (bit A15 of the 16-bit address),
3. Set bit A14 in the address field to 1,
4. Initiate a serial interface cycle by specifying the address of the register (A13 to A0) whose content must be written, and
5. Write the 8-bit data that are latched in on the SCLK rising edge.

Figure 147 and Table 6 show the timing requirements for the serial register write operation.

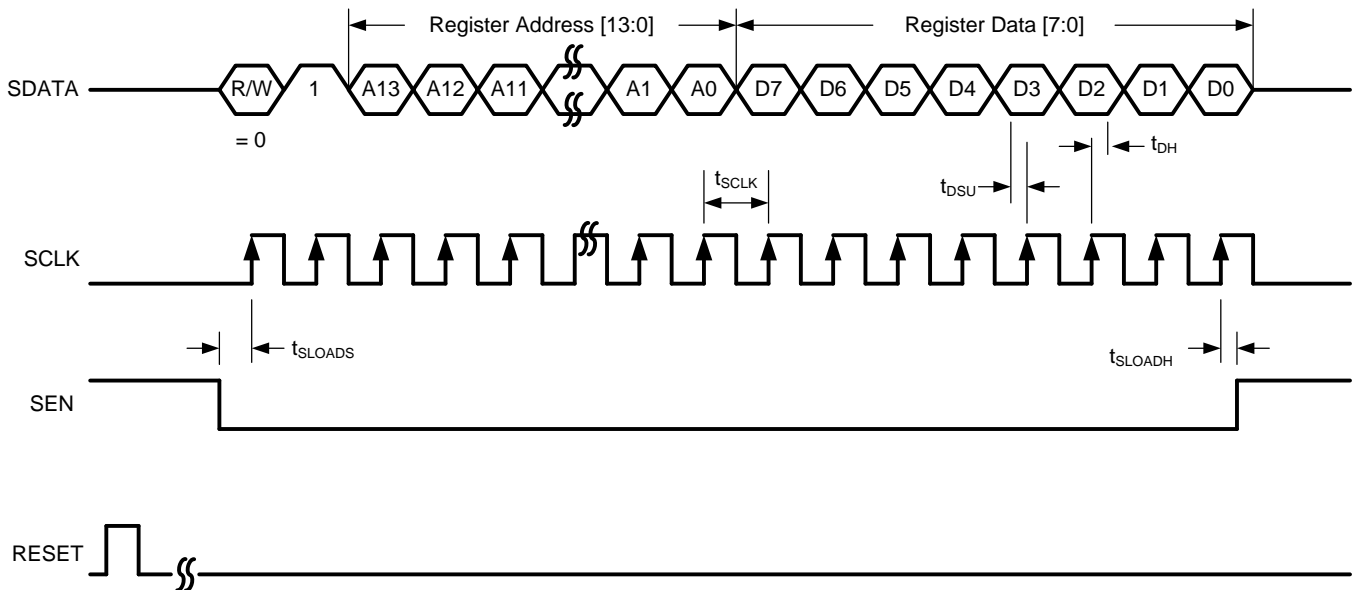


Figure 147. Serial Register Write Timing Diagram

Table 6. Serial Interface Timing⁽¹⁾

		MIN	TYP	MAX	UNIT
f_{SCLK}	SCLK frequency (equal to $1 / t_{SCLK}$)	> dc		20	MHz
t_{SLOADS}	SEN to SCLK setup time	25			ns
t_{SLOADH}	SCLK to SEN hold time	25			ns
t_{DSU}	SDIO setup time	25			ns
t_{DH}	SDIO hold time	25			ns

(1) Typical values are at 25°C, full temperature range is from $T_{MIN} = -40^{\circ}\text{C}$ to $T_{MAX} = 85^{\circ}\text{C}$, and $AVDD = DVDD = 1.8\text{ V}$, unless otherwise noted.

9.5.1.1.2 Serial Register Readout

The device includes a mode where the contents of the internal registers can be read back using the SDOUT pin. This readback mode can be useful as a diagnostic check to verify the serial interface communication between the external controller and the ADC. Given below is the procedure to read contents of serial registers:

1. Drive the SEN pin low.
2. Set the R/W bit (A15) to 1. This setting disables any further writes to the registers.
3. Set bit A14 in the address field to 1.
4. Initiate a serial interface cycle specifying the address of the register (A13 to A0) whose content must be read.
5. The device outputs the contents (D7 to D0) of the selected register on the SDOUT pin.
6. The external controller can latch the contents at the SCLK rising edge.
7. To enable register writes, reset the R/W register bit to 0.

When READOUT is disabled, the SDOUT pin is in a high-impedance mode. If serial readout is not used, the SDOUT pin must float. Figure 148 shows a timing diagram of the serial register read operation. Data appear on the SDOUT pin at the SCLK falling edge with an approximate delay (t_{SD_DELAY}) of 20 ns, as shown in Figure 149.

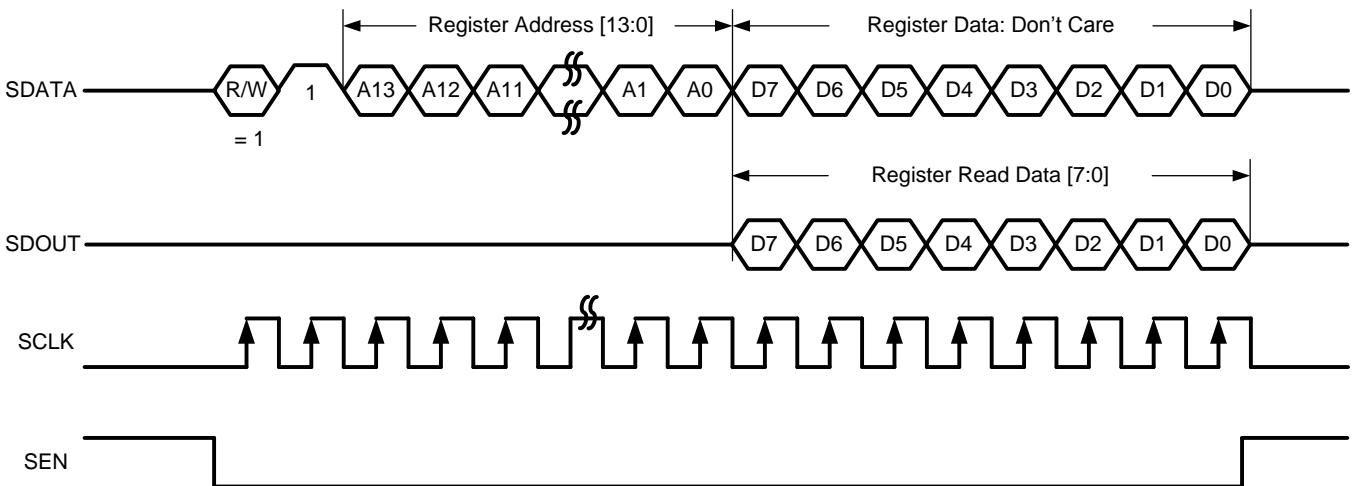


Figure 148. Serial Register Read Timing Diagram

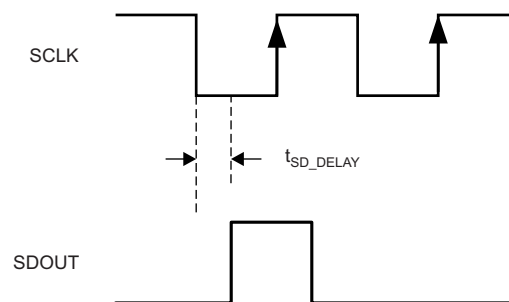


Figure 149. SDOUT Timing Diagram

9.5.2 Register Initialization

After power-up, the internal registers must be initialized to their default values through a hardware reset by applying a high pulse on the RESET pin, as shown in [Figure 150](#) and [Table 7](#).

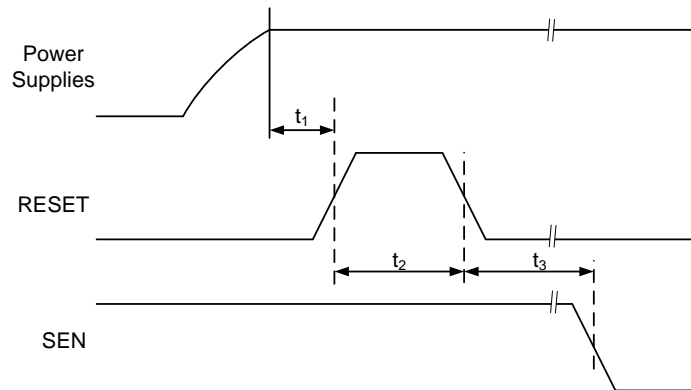


Figure 150. Initialization of Serial Registers after Power-Up

Table 7. Power-Up Timing

		MIN	TYP	MAX	UNIT
t_1	Power-on delay: delay from power up to active high RESET pulse	1			ms
t_2	Reset pulse duration: active high RESET pulse duration	10		1000	ns
t_3	Register write delay: delay from RESET disable to SEN active	100			ns

If required, the serial interface registers can be cleared during operation either:

1. Through hardware reset, or
2. By applying a software reset. When using the serial interface, set the RESET bit (D0 in register address 06h) high. This setting initializes the internal registers to the default values and then self-resets the RESET bit low. In this case, the RESET pin is kept low.

9.6 Register Maps

Table 8. Register Map Summary

REGISTER ADDRESS	REGISTER DATA							
	D7	D6	D5	D4	D3	D2	D1	D0
01	0	0	DIS DITH CHA		DIS DITH CHB		0	0
03	0	0	0	0	0	0	0	ODD EVEN
04	0	0	0	0	0	0	0	FLIP WIRE
05	0	0	0	0	0	0	0	1W-2W
06	0	0	0	0	0	0	TEST PATTERN EN	RESET
07	0	0	0	0	0	0	0	OVR ON LSB
09	0	0	0	0	0	0	ALIGN TEST PATTERN	DATA FORMAT
0A	0	0	0	0	CHA TEST PATTERN			
0B	CHB TEST PATTERN			0	0	0	0	0
0E	CUSTOM PATTERN[13:6]							
0F	CUSTOM PATTERN[5:0]						0	0
13	0	0	0	0	0	0	LOW SPEED ENABLE	
15	0	CHA PDN	CHB PDN	0	STANDBY	GLOBAL PDN	0	CONFIG PDN PIN
25	LVDS SWING							
27	CLK DIV		0	0	0	0	0	0
41D	0	0	0	0	0	0	HIGH IF MODE0	0
422	0	0	0	0	0	0	DIS CHOP CHA	0
434	0	0	DIS DITH CHA	0	DIS DITH CHA	0	0	0
439	0	0	0	0	SP1 CHA	0	0	0
51D	0	0	0	0	0	0	HIGH IF MODE1	0
522	0	0	0	0	0	0	DIS CHOP CHB	0
534	0	0	DIS DITH CHB	0	DIS DITH CHB	0	0	0
539	0	0	0	0	SP1 CHB	0	0	0
608	HIGH IF MODE[3:2]		0	0	0	0	0	0
70A	DIS CLK FILT	0	0	0	0	0	0	PDN SYSREF

9.6.1 Summary of Special Mode Registers

Table 9 lists the location, value, and functions of special mode registers in the device.

Table 9. Special Modes Summary

MODE	REGISTER SETTINGS	DESCRIPTION
Special modes	Registers 439h (bit 3) and 539h (bit 3)	Always set these bits high for best performance
Disable dither	Registers 1h (bits 5-2), 434h (bits 5 and 3), and 534h (bits 5 and 3)	Disable dither to improve SNR
Disable chopper	Registers 422h (bit 1) and 522h (bit 1)	Disable chopper to shift 1/f noise floor at dc
High IF modes	Registers 41Dh (bit 1), 51Dh (bit 1), and 608h (bits 7-6)	Improves HD3 for IF > 100 MHz

9.6.2 Serial Register Description

9.6.2.1 Register 01h

Figure 151. Register 01h

7	6	5	4	3	2	1	0
0	0	DIS DITH CHA		DIS DITH CHB		0	0
W-0h	W-0h	R/W-0h		R/W-0h		W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 10. Register 01h Description

Bit	Field	Type	Reset	Description
7-6	0	W	0h	Must write 0
5-4	DIS DITH CHA	R/W	0h	These bits enable or disable the on-chip dither. Control this bit with bits 5 and 3 of register 434h. 00 = Default 11 = Dither is disabled for channel A. In this mode, SNR typically improves by 0.5 dB at 70 MHz.
3-2	DIS DITH CHB	R/W	0h	These bits enable or disable the on-chip dither. Control this bit with bits 5 and 3 of register 434h. 00 = Default 11 = Dither is disabled for channel B. In this mode, SNR typically improves by 0.5 dB at 70 MHz.
1-0	0	W	0h	Must write 0

9.6.2.2 Register 03h

Figure 152. Register 03h

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	ODD EVEN
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 11. Register 03h Description

Bit	Field	Type	Reset	Description
7-1	0	W	0h	Must write 0
0	ODD EVEN	R/W	0h	This bit selects the bit sequence on the output lanes (in 2-wire mode only). 0 = Bits 0, 1, and 2 appear on lane 0; bits 7, 8, and 9 appear on lane 1 1 = Bits 0, 2, and 4 appear on lane 0; bits 1, 3, and 5 appear on lane 1

9.6.2.3 Register 04h

Figure 153. Register 04h

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	FLIP WIRE
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 12. Register 04h Description

Bit	Field	Type	Reset	Description
7-1	0	W	0h	Must write 0
0	FLIP WIRE	R/W	0h	This bit flips the data on the output wires. Valid only in two wire configuration. 0 = Default 1 = Data on output wires is flipped. Pin D0x becomes D1x, and vice versa.

9.6.2.4 Register 05h

Figure 154. Register 05h

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	1W-2W
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 13. Register 05h Description

Bit	Field	Type	Reset	Description
7-1	0	W	0h	Must write 0
0	1W-2W	R/W	0h	This bit transmits output data on either one or two wires. 0 = Output data are transmitted on two wires (Dx0P, Dx0M and Dx1P, Dx1M) 1 = Output data are transmitted on one wire (Dx0P, Dx0M). In this mode, the recommended f_s is less than 62.5 MSPS.

9.6.2.5 Register 06h

Figure 155. Register 06h

7	6	5	4	3	2	1	0
0	0	0	0	0	0	TEST PATTERN EN	RESET
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 14. Register 06h Description

Bit	Field	Type	Reset	Description
7-2	0	W	0h	Must write 0
1	TEST PATTERN EN	R/W	0h	This bit enables test pattern selection for the digital outputs. 0 = Normal output 1 = Test pattern output enabled
0	RESET	W	0h	This bit applies a software reset. This bit resets all internal registers to the default values and self-clears to 0.

9.6.2.6 Register 07h
Figure 156. Register 07h

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	OVR ON LSB
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 15. Register 07h Description

Bit	Field	Type	Reset	Description
7-1	0	W	0h	Must write 0
0	OVR ON LSB	R/W	0h	This bit provides the overrange (OVR) information on the LSB bits. 0 = Output data bit 0 functions as the LSB of the 14-bit data 1 = Output data bit 0 carries the OVR information.

9.6.2.7 Register 09h
Figure 157. Register 09h

7	6	5	4	3	2	1	0
0	0	0	0	0	0	ALIGN TEST PATTERN	DATA FORMAT
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	R/W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 16. Register 09h Description

Bit	Field	Type	Reset	Description
7-2	0	W	0h	Must write 0
1	ALIGN TEST PATTERN	R/W	0h	This bit aligns the test patterns across the outputs of both channels. 0 = Test patterns of both channels are free running 1 = Test patterns of both channels are aligned
0	DATA FORMAT	R/W	0h	This bit programs the digital output data format. 0 = Twos complement 1 = Offset binary

9.6.2.8 Register 0Ah
Figure 158. Register 0Ah

7	6	5	4	3	2	1	0
0	0	0	0	CHA TEST PATTERN			
W-0h	W-0h	W-0h	W-0h	R/W-0h			

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 17. Register 0Ah Description

Bit	Field	Type	Reset	Description
7-4	0	W	0h	Must write 0
3-0	CHA TEST PATTERN	R/W	0h	These bits control the test pattern for channel A after the TEST PATTERN EN bit is set. 0000 = Normal operation 0001 = All 0's 0010 = All 1's 0011 = Toggle pattern: data alternate between 101010101010 and 010101010101 0100 = Digital ramp: data increment by 1 LSB every clock cycle from code 0 to 16383 0101 = Custom pattern: output data are the same as programmed by the CUSTOM PATTERN register bits 0110 = Deskew pattern: data are 2AAAh 1000 = PRBS pattern: data are a sequence of pseudo random numbers 1001 = 8-point sine-wave: data are a repetitive sequence of the following eight numbers that form a sine-wave: 0, 2399, 8192, 13984, 16383, 13984, 8192, 2399. Others = Do not use

9.6.2.9 Register 0Bh
Figure 159. Register 0Bh

7	6	5	4	3	2	1	0
CHB TEST PATTERN				0	0	0	0
R/W-0h				W-0h	W-0h	W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 18. Register 0Bh Description

Bit	Field	Type	Reset	Description
7-4	CHB TEST PATTERN	R/W	0h	These bits control the test pattern for channel B after the TEST PATTERN EN bit is set. 0000 = Normal operation 0001 = All 0's 0010 = All 1's 0011 = Toggle pattern: data alternate between 101010101010 and 010101010101 0100 = Digital ramp: data increment by 1 LSB every clock cycle from code 0 to 16383 0101 = Custom pattern: output data are the same as programmed by the CUSTOM PATTERN register bits 0110 = Deskew pattern: data are 2AAAh 1000 = PRBS pattern: data are a sequence of pseudo random numbers 1001 = 8-point sine-wave: data are a repetitive sequence of the following eight numbers that form a sine-wave: 0, 2399, 8192, 13984, 16383, 13984, 8192, 2399. Others = Do not use
3-0	0	W	0h	Must write 0

9.6.2.10 Register 0Eh
Figure 160. Register 0Eh

7	6	5	4	3	2	1	0
CUSTOM PATTERN[13:6]							
R/W-0h							

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 19. Register 0Eh Description

Bit	Field	Type	Reset	Description
7-0	CUSTOM PATTERN[13:6]	R/W	0h	These bits set the 14-bit custom pattern (bits 13-6) for all channels.

9.6.2.11 Register 0Fh
Figure 161. Register 0Fh

7	6	5	4	3	2	1	0
CUSTOM PATTERN[5:0]						0	0
R/W-0h						W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 20. Register 0Fh Description

Bit	Field	Type	Reset	Description
7-2	CUSTOM PATTERN[5:0]	R/W	0h	These bits set the 14-bit custom pattern (bits 5-0) for all channels.
1-0	0	W	0h	Must write 0

9.6.2.12 Register 13h (address = 13h)
Figure 162. Register 13h

7	6	5	4	3	2	1	0
0	0	0	0	0	0	LOW SPEED ENABLE	
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	

LEGEND: R/W = Read/Write; W = Write only; -n = value after reset

Table 21. Register 13h Field Descriptions

Bit	Field	Type	Reset	Description
7-2	0	W	0h	Must write 0.
1-0	LOW SPEED ENABLE	R/W	0h	Enables low speed operation in 1-wire and 2-wire mode. Depending upon sampling frequency, write this bit as per Table 22 .

Table 22. LOW SPEED ENABLE Register Bit Settings Across f_s

f_s (MSPS)		REGISTER BIT LOW SPEED ENABLE	
MIN	MAX	1-WIRE MODE	2-WIRE MODE
25	125	00	00
20	25	00	10
15	20	10	Not supported

9.6.2.13 Register 15h
Figure 163. Register 15h

7	6	5	4	3	2	1	0
0	CHA PDN	CHB PDN	0	STANDBY	GLOBAL PDN	0	CONFIG PDN PIN
W-0h	R/W-0h	R/W-0h	W-0h	R/W-0h	R/W-0h	W-0h	R/W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 23. Register 15h Description

Bit	Field	Type	Reset	Description
7	0	W	0h	Must write 0
6	CHA PDN	R/W	0h	0 = Normal operation 1 = Power-down channel A
5	CHB PDN	R/W	0h	0 = Normal operation 1 = Power-down channel B
4	0	W	0h	Must write 0
3	STANDBY	R/W	0h	The ADCs of both channels enter standby. 0 = Normal operation 1 = Standby
2	GLOBAL PDN	R/W	0h	0 = Normal operation 1 = Global power-down
1	0	W	0h	Must write 0
0	CONFIG PDN PIN	R/W	0h	This bit configures the PDN pin as either a global power-down or standby pin. 0 = Logic high voltage on the PDN pin sends the device into global power-down 1 = Logic high voltage on the PDN pin sends the device into standby

9.6.2.14 Register 25h
Figure 164. Register 25h

7	6	5	4	3	2	1	0
LVDS SWING							
R/W-0h							

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 24. Register 25h Description

Bit	Field	Type	Reset	Description
7-0	LVDS SWING	R/W	0h	These bits control the swing of the LVDS outputs (including the data output, bit clock, and frame clock). For details see Table 25 .

Table 25. LVDS Output Swing

BITS 7-4	BITS 3-0	LVDS OUTPUT SWING
0h	0h	Default (± 425 mV)
Dh	9h	Swing reduces by 50 mV
Eh	Ah	Swing reduces by 100 mV
Fh	Dh	Swing reduces by 300 mV
Ch	Eh	Swing increases by 100 mV
Others	Others	Do not use

9.6.2.15 Register 27h
Figure 165. Register 27h

7	6	5	4	3	2	1	0
CLK DIV		0	0	0	0	0	0
R/W-0h		W-0h	W-0h	W-0h	W-0h	W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 26. Register 27h Description

Bit	Field	Type	Reset	Description
7-6	CLK DIV	R/W	0h	These bits set the internal clock divider for the input sampling clock. 00 = Divide-by-1 01 = Divide-by-1 10 = Divide-by-2 11 = Divide-by-4
5-0	0	W	0h	Must write 0

9.6.2.16 Register 41Dh
Figure 166. Register 41Dh

7	6	5	4	3	2	1	0
0	0	0	0	0	0	HIGH IF MODE0	0
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 27. Register 41Dh Description

Bit	Field	Type	Reset	Description
7-2	0	W	0h	Must write 0
1	HIGH IF MODE0	R/W	0h	This bit improves HD3 for IF > 100 MHz. 0 = Normal operation For best HD3 at IF > 100 MHz, set HIGH IF MODE[3:0] to 1111.
0	0	W	0h	Must write 0

9.6.2.17 Register 422h
Figure 167. Register 422h

7	6	5	4	3	2	1	0
0	0	0	0	0	0	DIS CHOP CHA	0
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 28. Register 422h Description

Bit	Field	Type	Reset	Description
7-2	0	W	0h	Must write 0
1	DIS CHOP CHA	R/W	0h	Disable chopper. Set this bit to shift a 1/f noise floor at dc. 0 = 1/f noise floor is centered at $f_S / 2$ (default) 1 = Chopper mechanism is disabled; 1/f noise floor is centered at dc
0	0	W	0h	Must write 0

9.6.2.18 Register 434h
Figure 168. Register 434h

7	6	5	4	3	2	1	0
0	0	DIS DITH CHA	0	DIS DITH CHA	0	0	0
W-0h	W-0h	R/W-0h	W-0h	R/W-0h	W-0h	W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 29. Register 434h Description

Bit	Field	Type	Reset	Description
7-6	0	W	0h	Must write 0
5	DIS DITH CHA	R/W	0h	Set this bit with bits 5 and 4 of register 01h. 00 = Default 11 = Dither is disabled for channel A. In this mode, SNR typically improves by 0.5 dB at 70 MHz.
4	0	W	0h	Must write 0
3	DIS DITH CHA	R/W	0h	Set this bit with bits 5 and 4 of register 01h. 00 = Default 11 = Dither is disabled for channel A. In this mode, SNR typically improves by 0.5 dB at 70 MHz.
2-0	0	W	0h	Must write 0

9.6.2.19 Register 439h
Figure 169. Register 439h

7	6	5	4	3	2	1	0
0	0	0	0	SP1 CHA	0	0	0
W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h	W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 30. Register 439h Description

Bit	Field	Type	Reset	Description
7-4	0	W	0h	Must write 0
3	SP1 CHA	R/W	0h	Special mode for best performance on channel A. Always write 1 after reset.
2-0	0	W	0h	Must write 0

9.6.2.20 Register 51Dh
Figure 170. Register 51Dh

7	6	5	4	3	2	1	0
0	0	0	0	0	0	HIGH IF MODE1	0
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 31. Register 51Dh Description

Bit	Field	Type	Reset	Description
7-2	0	W	0h	Must write 0
1	HIGH IF MODE1	R/W	0h	This bit improves HD3 for IF > 100 MHz. 0 = Normal operation For best HD3 at IF > 100 MHz, set HIGH IF MODE[3:0] to 1111.
0	0	W	0h	Must write 0

9.6.2.21 Register 522h
Figure 171. Register 522h

7	6	5	4	3	2	1	0
0	0	0	0	0	0	DIS CHOP CHB	0
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 32. Register 522h Description

Bit	Field	Type	Reset	Description
7-2	0	W	0h	Must write 0
1	DIS CHOP CHB	R/W	0h	Disable chopper. Set this bit to shift a 1/f noise floor at dc. 0 = 1/f noise floor is centered at $f_s / 2$ (default) 1 = Chopper mechanism is disabled; 1/f noise floor is centered at dc
0	0	W	0h	Must write 0

9.6.2.22 Register 534h
Figure 172. Register 534h

7	6	5	4	3	2	1	0
0	0	DIS DITH CHA	0	DIS DITH CHA	0	0	0
W-0h	W-0h	R/W-0h	W-0h	R/W-0h	W-0h	W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 33. Register 534h Description

Bit	Field	Type	Reset	Description
7-6	0	W	0h	Must write 0
5	DIS DITH CHA	R/W	0h	Set this bit with bits 3 and 2 of register 01h. 00 = Default 11 = Dither is disabled for channel B. In this mode, SNR typically improves by 0.5 dB at 70 MHz.
4	0	W	0h	Must write 0
3	DIS DITH CHA	R/W	0h	Set this bit with bits 3 and 2 of register 01h. 00 = Default 11 = Dither is disabled for channel B. In this mode, SNR typically improves by 0.5 dB at 70 MHz.
2-0	0	W	0h	Must write 0

9.6.2.23 Register 539h
Figure 173. Register 539h

7	6	5	4	3	2	1	0
0	0	0	0	SP1 CHB	0	0	0
W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h	W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 34. Register 539h Description

Bit	Field	Type	Reset	Description
7-4	0	W	0h	Must write 0
3	SP1 CHB	R/W	0h	Special mode for best performance on channel B. Always write 1 after reset.
0	0	W	0h	Must write 0

9.6.2.24 Register 608h
Figure 174. Register 608h

7	6	5	4	3	2	1	0
HIGH IF MODE[3:2]		0	0	0	0	0	0
R/W-0h		W-0h	W-0h	W-0h	W-0h	W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 35. Register 608h Description

Bit	Field	Type	Reset	Description
7-6	HIGH IF MODE[3:2]	R/W	0h	This bit improves HD3 for IF > 100 MHz. 0 = Normal operation For best HD3 at IF > 100 MHz, set HIGH IF MODE[3:0] to 1111.
5-0	0	W	0h	Must write 0

9.6.2.25 Register 70Ah
Figure 175. Register 70Ah

7	6	5	4	3	2	1	0
DIS CLK FILT	0	0	0	0	0	0	PDN SYSREF
R/W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

Table 36. Register 70Ah Description

Bit	Field	Type	Reset	Description
7	DIS CLK FILT	R/W	0h	Set this bit to improve wake-up time from global power-down mode; see the Improving Wake-Up Time From Global Power-Down section for details.
6-1	0	W	0h	Must write 0
0	PDN SYSREF	R/W	0h	If the SYSREF pins are not used in the system, the SYSREF buffer must be powered down by setting this bit. 0 = Normal operation 1 = Powers down the SYSREF buffer

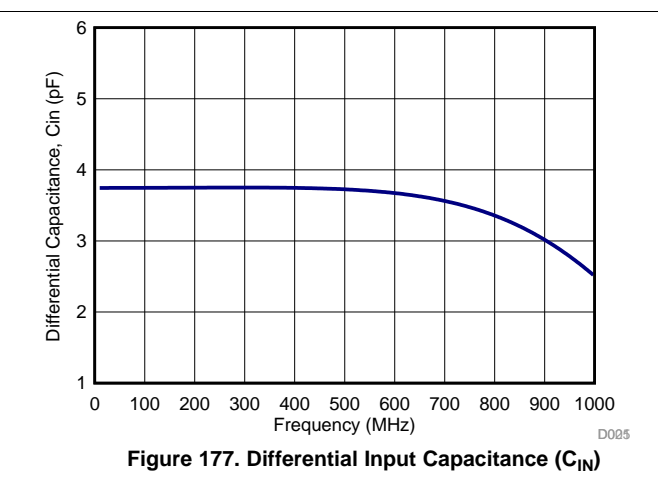
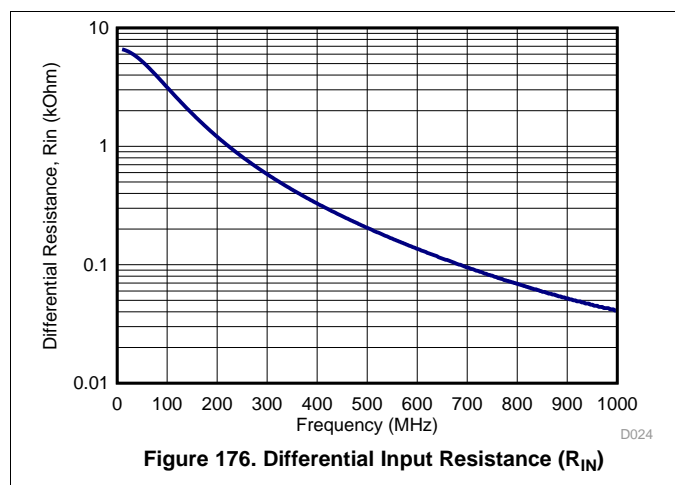
10 Applications and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

Typical applications involving transformer coupled circuits are discussed in this section. Transformers (such as ADT1-1WT or WBC1-1) can be used up to 250 MHz to achieve good phase and amplitude balances at ADC inputs. While designing the dc driving circuits, the ADC input impedance must be considered. [Figure 176](#) and [Figure 177](#) show the impedance ($Z_{in} = R_{in} \parallel C_{in}$) across the ADC input pins.



10.2 Typical Applications

10.2.1 Driving Circuit Design: Low Input Frequencies

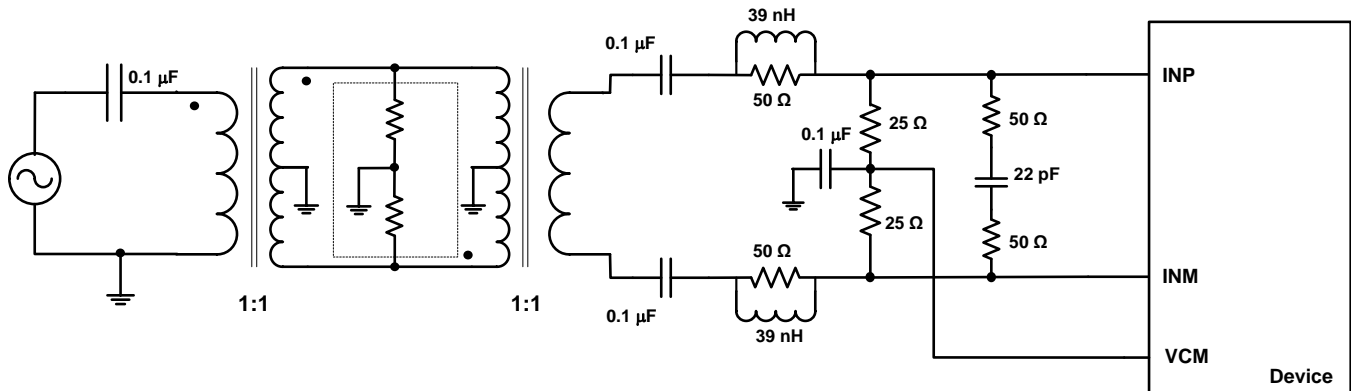


Figure 178. Driving Circuit for Low Input Frequencies

10.2.1.1 Design Requirements

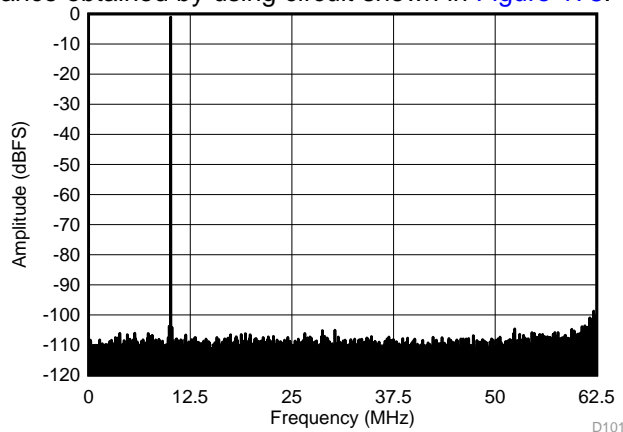
For optimum performance, the analog inputs must be driven differentially. An optional 5-Ω to 15-Ω resistor in series with each input pin can be kept to damp out ringing caused by package parasitic. The drive circuit may have to be designed to minimize the impact of kick-back noise generated by sampling switches opening and closing inside the ADC, as well as ensuring low insertion loss over the desired frequency range and matched impedance to the source.

10.2.1.2 Detailed Design Procedure

A typical application involving using two back-to-back coupled transformers is shown in [Figure 178](#). The circuit is optimized for low input frequencies. An external R-C-R filter using 50-Ω resistors and a 22-pF capacitor is used with the series inductor (39 nH), this combination helps absorb the sampling glitches.

10.2.1.3 Application Curve

[Figure 179](#) shows the performance obtained by using circuit shown in [Figure 178](#).



SFDR = 102.6 dBc, SNR = 72.9 dBFS, SINAD = 72.8 dBFS,
THD = 99.8 dBc, HD2 = -108.6 dBc, HD3 = -104.0 dBc

Figure 179. Performance FFT at 10 MHz (Low Input Frequency)

Typical Applications (continued)

10.2.2 Driving Circuit Design: Input Frequencies Between 100 MHz to 230 MHz

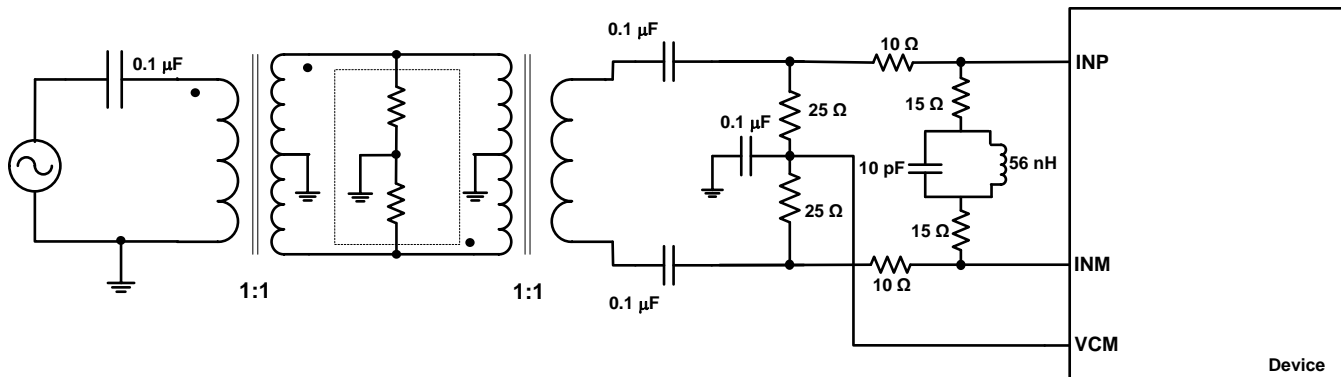


Figure 180. Driving Circuit for Mid-Range Input Frequencies ($100 \text{ MHz} < f_{IN} < 230 \text{ MHz}$)

10.2.2.1 Design Requirements

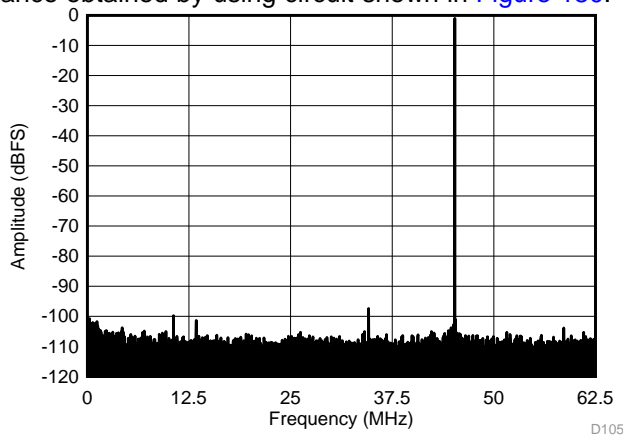
See the [Design Requirements](#) section for further details.

10.2.2.2 Detailed Design Procedure

When input frequencies are between 100 MHz to 230 MHz, an R-LC-R circuit can be used to optimize performance, as shown in [Figure 180](#).

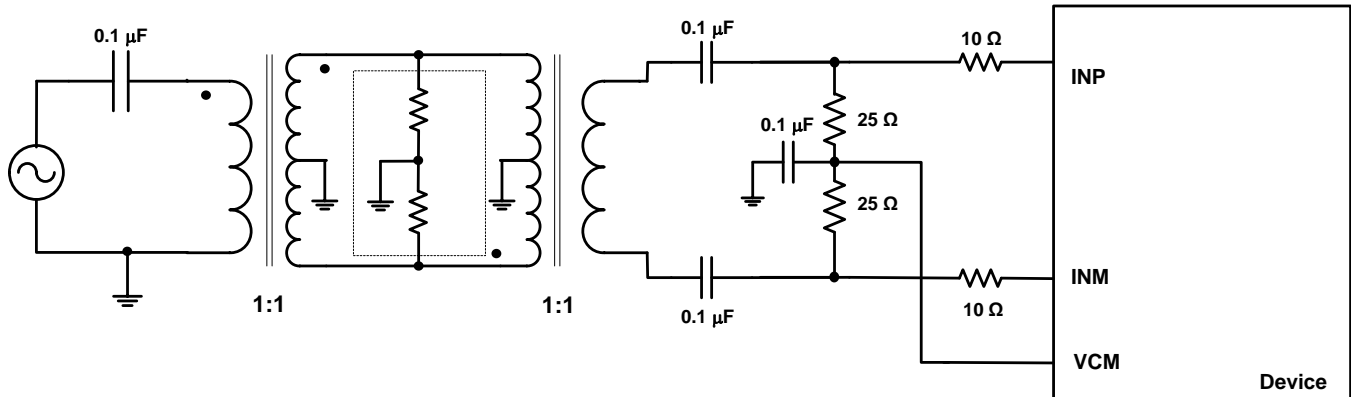
10.2.2.3 Application Curve

[Figure 181](#) shows the performance obtained by using circuit shown in [Figure 180](#).



SFDR = 96.4 dBc, SNR = 72.1 dBFS, SINAD = 72.0 dBFS,
THD = 92.6 dBc, HD2 = -96.4 dBc, HD3 = -98.8 dBc

Figure 181. Performance FFT at 170 MHz (Mid Input Frequency)

Typical Applications (continued)
10.2.3 Driving Circuit Design: Input Frequencies Greater than 230 MHz

Figure 182. Driving Circuit for High input Frequencies ($f_{IN} > 230$ MHz)
10.2.3.1 Design Requirements

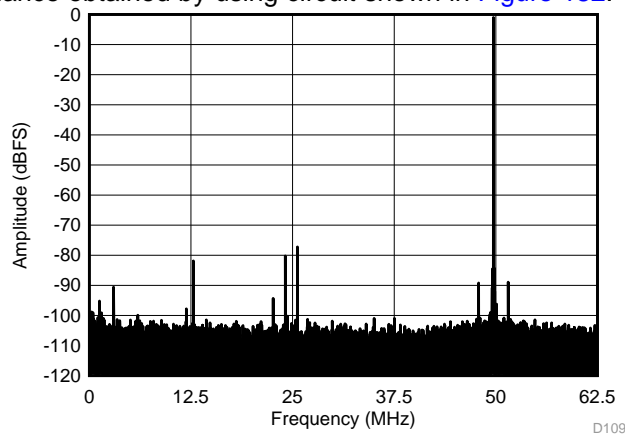
See the [Design Requirements](#) section for further details.

10.2.3.2 Detailed Design Procedure

For high input frequencies (> 230 MHz), using the R-C-R or R-LC-R circuit does not show significant improvement in performance. However, a series resistance of $10\ \Omega$ can be used as shown in [Figure 182](#).

10.2.3.3 Application Curve

[Figure 183](#) shows the performance obtained by using circuit shown in [Figure 182](#).



SFDR = 76.2 dBc, SNR = 68.3 dBFS, SINAD = 67.5 dBFS,

THD = 74.3 dBc, HD2 = -76.2 dBc, HD3 = -79.2 dBc

Figure 183. Performance FFT at 450 MHz (High Input Frequency)
11 Power-Supply Recommendations

The device requires a 1.8-V nominal supply for AVDD and DVDD. There are no specific sequence power-supply requirements during device power-up. AVDD and DVDD can power up in any order.

12 Layout

12.1 Layout Guidelines

The ADC324x EVM layout can be used as a reference layout to obtain the best performance. A layout diagram of the EVM top layer is provided in [Figure 184](#). Some important points to remember during laying out the board are:

1. Analog inputs are located on opposite sides of the device pin out to ensure minimum crosstalk on the package level. To minimize crosstalk onboard, the analog inputs must exit the pin out in opposite directions, as shown in the reference layout of [Figure 184](#) as much as possible.
2. In the device pin out, the sampling clock is located on a side perpendicular to the analog inputs in order to minimize coupling between them. This configuration is also maintained on the reference layout of [Figure 184](#) as much as possible.
3. Keep digital outputs away from the analog inputs. When these digital outputs exit the pin out, do not keep the digital output traces parallel to the analog input traces because this configuration can result in coupling from digital outputs to analog inputs and degrade performance. All digital output traces to the receiver [such as a field-programmable gate array (FPGA) or an application-specific integrated circuit (ASIC)] must be matched in length to avoid skew among outputs.
4. At each power-supply pin (AVDD and DVDD), keep a 0.1- μ F decoupling capacitor close to the device. A separate decoupling capacitor group consisting of a parallel combination of 10- μ F, 1- μ F, and 0.1- μ F capacitors can be kept close to the supply source.

12.2 Layout Example

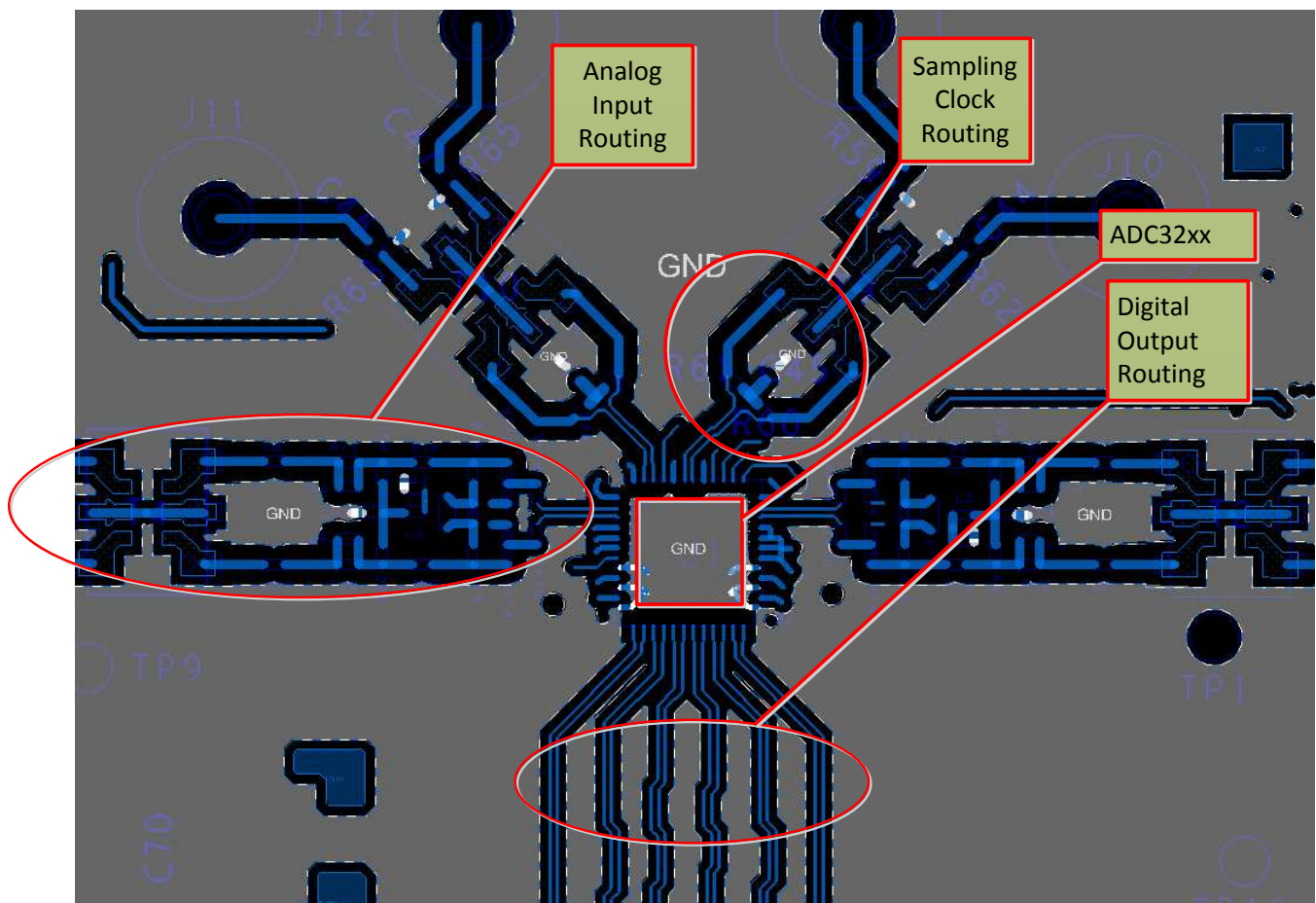


Figure 184. Typical Layout of the ADC324x Board

13 器件和文档支持

13.1 相关链接

下面的表格列出了快速访问链接。范围包括技术文档、支持和社区资源、工具和软件，以及样片或购买的快速访问。

表 37. 相关链接

器件	产品文件夹	样片与购买	技术文档	工具与软件	支持与社区
ADC3241	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处
ADC3242	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处
ADC3243	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处
ADC3244	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处

13.2 社区资源

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

13.3 商标

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ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

13.5 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

14 机械、封装和可订购信息

以下页中包括机械、封装和可订购信息。这些信息是针对指定器件可提供的最新数据。这些数据会在无通知且不对本文档进行修订的情况下发生改变。欲获得该数据表的浏览器版本，请查阅左侧的导航栏。

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
ADC3241IRGZR	ACTIVE	VQFN	RGZ	48	2500	RoHS & Green	NIPDAUAG	Level-3-260C-168 HR	-40 to 85	AZ3241	Samples
ADC3241IRGZT	ACTIVE	VQFN	RGZ	48	250	RoHS & Green	NIPDAUAG	Level-3-260C-168 HR	-40 to 85	AZ3241	Samples
ADC3242IRGZR	ACTIVE	VQFN	RGZ	48	2500	RoHS & Green	NIPDAUAG	Level-3-260C-168 HR	-40 to 85	AZ3242	Samples
ADC3242IRGZT	ACTIVE	VQFN	RGZ	48	250	RoHS & Green	NIPDAUAG	Level-3-260C-168 HR	-40 to 85	AZ3242	Samples
ADC3243IRGZR	ACTIVE	VQFN	RGZ	48	2500	RoHS & Green	NIPDAUAG	Level-3-260C-168 HR	-40 to 85	AZ3243	Samples
ADC3243IRGZT	ACTIVE	VQFN	RGZ	48	250	RoHS & Green	NIPDAUAG	Level-3-260C-168 HR	-40 to 85	AZ3243	Samples
ADC3244IRGZR	ACTIVE	VQFN	RGZ	48	2500	RoHS & Green	NIPDAUAG	Level-3-260C-168 HR	-40 to 85	AZ3244	Samples
ADC3244IRGZT	ACTIVE	VQFN	RGZ	48	250	RoHS & Green	NIPDAUAG	Level-3-260C-168 HR	-40 to 85	AZ3244	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ADC3241IRGZR	VQFN	RGZ	48	2500	330.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2
ADC3242IRGZR	VQFN	RGZ	48	2500	330.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2
ADC3243IRGZR	VQFN	RGZ	48	2500	330.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2
ADC3244IRGZR	VQFN	RGZ	48	2500	330.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ADC3241IRGZR	VQFN	RGZ	48	2500	350.0	350.0	43.0
ADC3242IRGZR	VQFN	RGZ	48	2500	350.0	350.0	43.0
ADC3243IRGZR	VQFN	RGZ	48	2500	350.0	350.0	43.0
ADC3244IRGZR	VQFN	RGZ	48	2500	350.0	350.0	43.0

GENERIC PACKAGE VIEW

RGZ 48

VQFN - 1 mm max height

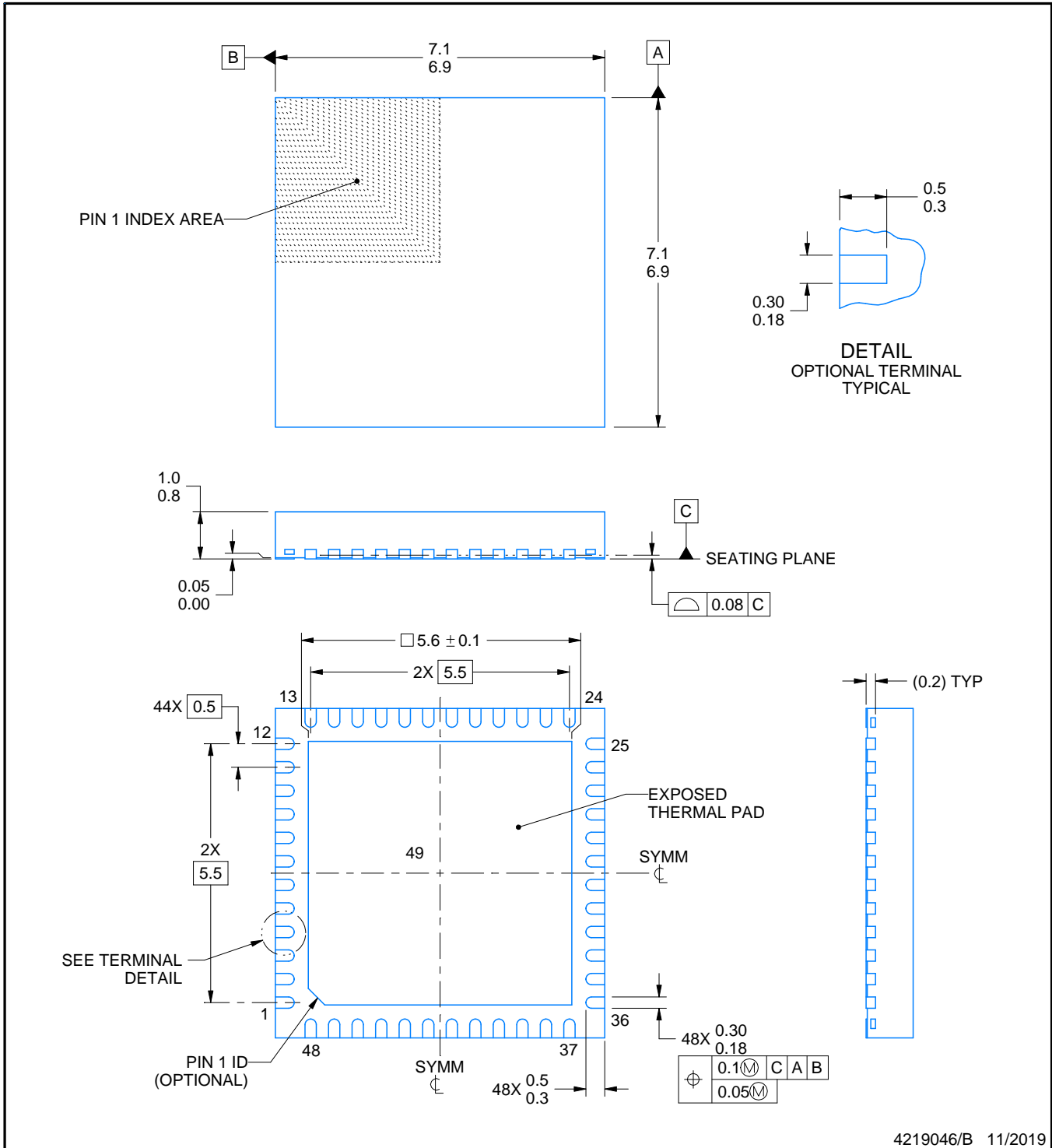
7 x 7, 0.5 mm pitch

PLASTIC QUADFLAT PACK- NO LEAD



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4224671/A



4219046/B 11/2019

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

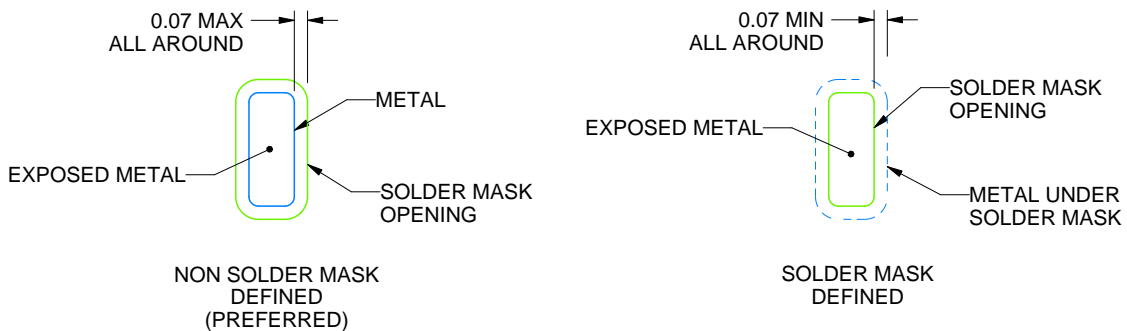
RGZ0048D

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:12X



SOLDER MASK DETAILS

4219046/B 11/2019

NOTES: (continued)

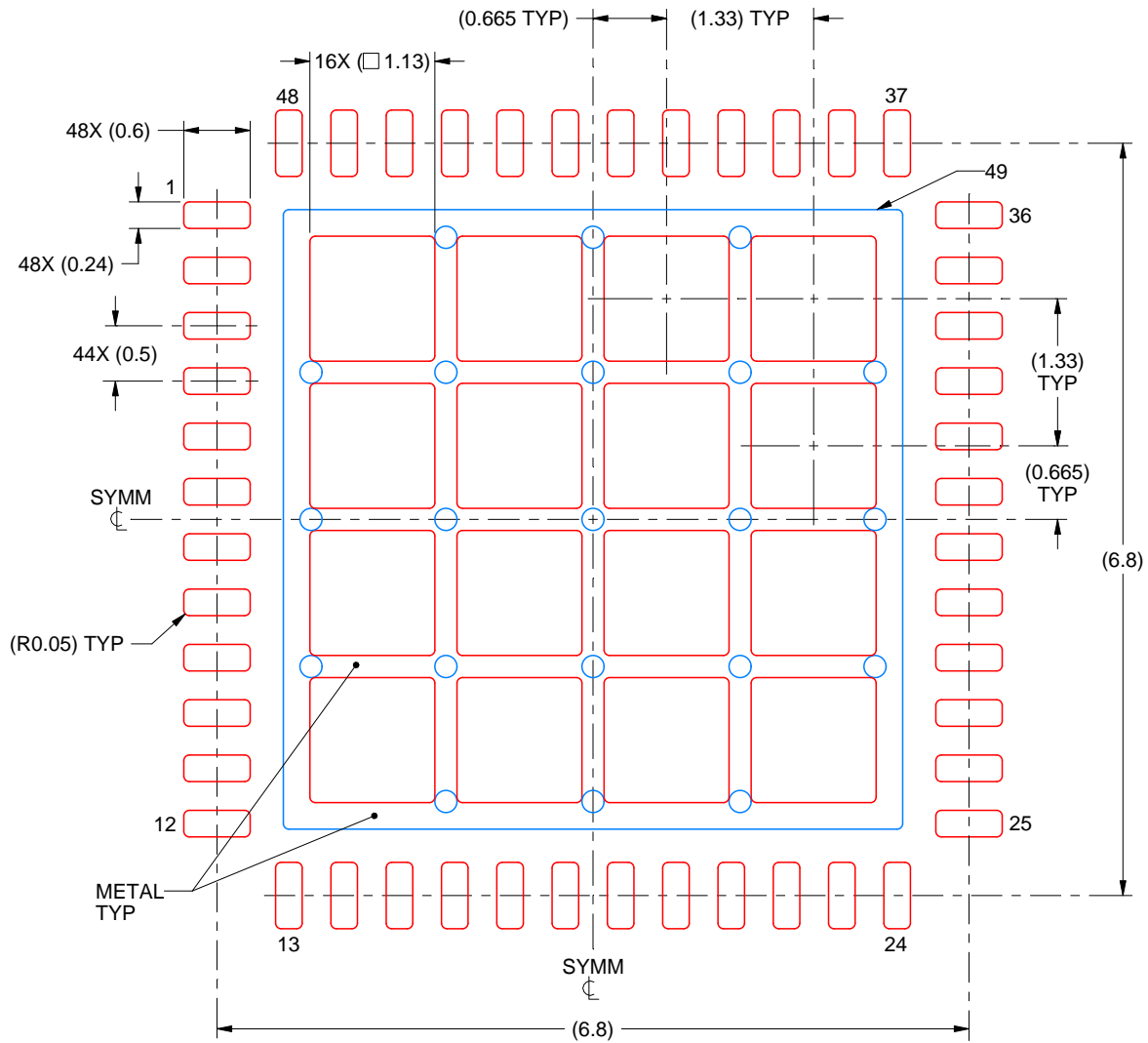
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

RGZ0048D

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE
 BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 49
 66% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
 SCALE:15X

4219046/B 11/2019

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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[HI5766KCAZ](#) [HI5766KCBZ](#) [ISOSD61TR](#) [ES7201](#) [AD7266BSUZ-REEL](#) [AD7708BRZ-REEL7](#) [CLM2543IDW](#) [CLM2543CDW](#)
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[GP9101-F10K-N-SW](#) [GP9301BXI-F4K-D1V10-SH](#) [GP9301BXI-F1K-L5H2-SH](#) [LTC2484IDD#TRPBF](#) [AD9245BCPZRL7-20](#) [SSP1120](#)
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[LTC2447IUHF#PBF](#) [AD9235BRUZRL7-20](#) [AD7888ARUZ-REEL](#) [AD7606BBSTZ-RL](#) [AD7998BRUZ-1REEL](#) [AD7276ARMZ-REEL](#)
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[AD7923BRUZ-REEL](#) [AD7495ARZ-REEL7](#) [AD9629BCPZRL7-40](#)